SAR Test Report

For

Applicant Name:	**Elo Touch Solutions, Inc.**
Address:	670 N. McCarthy Blvd., Suite 100, Milpitas, CA 95035, USA.
EUT Name:	mobile POS
Brand Name:	Elo
Model Number:	EMC0650S
Series Model Number:	Refer to section 2

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF230608R00301
Test Standards:	47 CFR Part 2.1093 IEEE1528-2013 IEEE C95.1-2019 KDB447498 D01 KDB865664 D01 KDB865664 D02 KDB941225 D05 KDB248227 D01 KDB941225 D06 KDB648474 D04 KDB690783 D01
FCC ID:	RBWEMC0650C
Test Conclusion:	Pass
Test Date:	2023-06-08 to 2023-06-12
Date of Issue:	2023-06-13

Prepared By:	Monica Zhou / Project Engineer
Date:	2023-06-13
Approved By:	Ryan.CJ / EMC Manager
Date:	2023-06-13

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Revision History		
Version	Issue Date	Revisions Content
R_V0	2023-06-13	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

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BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Product Information

2.1 Application Information

Company Name:	Elo Touch Solutions, Inc.
Address:	670 N. McCarthy Blvd., Suite 100, Milpitas, CA 95035, USA.

2.2 Manufacturer Information

Company Name:	Elo Touch Solutions, Inc.
Address:	670 N. McCarthy Blvd., Suite 100, Milpitas, CA 95035, USA.

2.3 Factory Information

Company Name:	Jiangxi Neostra Electronic Co., Ltd.
Address:	279 Shenzhen Road, Jinggangshan Economic and Technological Development Zone, Ji'an, Jiangxi

2.4 General Description of Equipment under Test (EUT)

EUT Name	mobile POS
Under Test Model Name	EMC0650S
Series Model Name	EMC0650
Description of Model name differentiation	PCB board, structure and internal of these model(s) are the same, Only the difference in the scanning head, model (EMC0650S) with a scanning head and model (EMC0650) without a scanning head, was evaluated for the EMC part and did not affect RF performance.
Sample No.	BTFSN230605E009-1/2

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	5200mAh
	Rated Voltage	3.8V

2.6 Technical Information

Network and Wireless connectivity	4G Network FDD LTE Band 2/4/5/7/12/13/14/17/25/26/66/71 TDD LTE Band 41 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/HT40) 5G WIFI 802.11a, 802.11n(HT20/HT40), 802.11ac(VHT20/VHT40/VHT80) BT (EDR+BLE)

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The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	LTE, WLAN, Bluetooth		
Frequency Range	LTE Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	LTE Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	LTE Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 7	TX: 2500 ~ 2570 MHz	RX: 2620 ~ 2690 MHz
	LTE Band 12	TX: 698 ~ 716 MHz	RX: 728 ~ 746 MHz
	LTE Band 13	TX: 777 ~ 787 MHz	RX: 746 ~ 756 MHz
	LTE Band 14	TX: 788 ~ 798 MHz	RX: 758 ~768 MHz
	LTE Band 17	TX: 704 ~ 716 MHz	RX: 734 ~ 746 MHz
	LTE Band 25	TX: 1850 ~ 1915 MHz	RX: 1930 ~ 1995 MHz
	LTE Band 26	TX: 814 ~ 849 MHz	RX: 859 ~ 894 MHz
	LTE Band 66	TX: 1710 ~ 1780 MHz	RX: 2110 ~ 2200 MHz
	LTE Band 71	TX: 663 ~ 698 MHz	RX: 617 ~ 652 MHz
	LTE Band 41	2496 ~ 2690 MHz	
	802.11b/g/n(HT20)	2412 ~ 2462 MHz	
	802.11n(HT40)	2422 ~ 2452 MHz	
	802.11a /802.11n(HT20/HT40) /802.11ac(VHT20/VHT40/VHT80)	5150 ~ 5250 MHz	
		5250 ~ 5350 MHz	
		5470 ~ 5725 MHz	
		5725 ~ 5850 MHz	
	Bluetooth	2402 ~ 2480 MHz	
Antenna Type	WWAN: FPC Antenna WLAN: FPC Antenna BT: FPC Antenna		
Hotspot Function	Support		
Power Reduction	Not Support		
Exposure Category	General Population/Uncontrolled exposure		
EUT Stage	Portable Device		
Product	Type		
	☐ Production unit	☒ Identical prototype	
Note: this device doesn't support voice call function, so we don't need to test head.			

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices
2	IEEE1528-2013	Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate in the Human Head from Wireless Communications Devices: Measurement Techniques
3	IEEE C95.1-2019	IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz
4	KDB447498 D01	General RF Exposure Guidance v06
5	KDB865664 D01	SAR measurement 100MHz to 6GHz v01r04
6	KDB865664 D02	RF Exposure Reporting v01r02
7	KDB941225 D05	SAR for LTE Devices v02r05
8	KDB248227 D01	802.11 Wi-Fi SAR v02r02
9	KDB941225 D06	Hotspot Mode v02r01
10	KDB648474 D04	Handset SAR v01r03
11	KDB690783 D01	SAR Listings on Grant v01r03

3.2 Device Category and SAR Limit

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

Body Position	SAR Value (W/Kg)	
	General Population/ Uncontrolled Exposure	Occupational/ Controlled Exposure
Whole-Body SAR (averaged over the entire body)	0.08	0.4
Partial-Body SAR (averaged over any 1 gram of tissue)	1.60	8.0
SAR for hands, wrists, feet and ankles (averaged over any 10 grams of tissue)	4.0	20.0

NOTE:
General Population/Uncontrolled Exposure: Locations where there is the exposure of individuals who have no knowledge or control of their exposure. General population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment- related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Occupational/Controlled Exposure: Locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

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3.3 Test Result Summary

The maximum results of Specific Absorption Rate (SAR) found during test as bellows:

<Highest Reported standalone SAR Summary>

Exposure Position	Frequency Band	Reported SAR (W/kg)	Equipment Class	Highest Reported SAR (W/kg)
Hotspot(Body) 1-g SAR (0 mm Gap)	LTE Band 2	0.729	PCB	**1.247**
	LTE Band 4	1.145		
	LTE Band 5	0.650		
	LTE Band 7	0.951		
	LTE Band 12	0.385		
	LTE Band 13	0.168		
	LTE Band 14	0.132		
	LTE Band 17	0.425		
	LTE Band 25	0.803		
	LTE Band 26	0.385		
	LTE Band 41	0.432		
	LTE Band 66	**1.247**		
	LTE Band 71	0.173		
	WLAN 2.4 GHz	0.209	DTS	
	WLAN 5.2 GHz	0.505	NII	
	WLAN 5.4 GHz	0.314		
	WLAN 5.6 GHz	0.367		
	WLAN 5.8 GHz	0.303		

*This device is in compliance with Specific Absorption Rate(SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC47 CFR part 2(2.1093) and ANSI/IEEE C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013.

<Highest Reported Simultaneous SAR>

Exposure Position	Simultaneous Configuration	Highest Reported Simultaneous Transmission SAR (W/kg)	Limit (W/kg)	Verdict
Hotspot(Body) 1-g SAR (0 mm Gap)	LTE Band 66 + 5G WIFI	1.293	1.6	Pass

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3.4 Test Uncertainty

3.4.1 Measurement uncertainly evaluation for SAR test

Measurement uncertainly evaluation for SAR test (300MHz to 6GHz)

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	√0.5	√0.5	1.43	1.43	∞
Hemispherical Isotropy	5.9	R	√3	√0.5	√0.5	2.41	2.41	∞
Boundary effect	1.0	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1.0	R	√3	1	1	0.58	0.58	∞
Modulation response	3.0	R	√3	1	1	1.73	1.73	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	1	1	0.00	0.00	∞
Integration Time	1.4	R	√3	1	1	0.81	0.81	∞
RF ambient Conditions - Noise	3.0	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3.0	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Test sample Related								
Test sample positioning	2.6	N	1	1	1	2.60	2.60	11
Device Holder Uncertainty	3.0	N	1	1	1	3.00	3.00	7
Output power Variation - SAR drift measurement	5.0	R	√3	1	1	2.89	2.89	∞
SAR scaling	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4.0	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.47	10.34	
Expanded Uncertainty (95% Confidence interval)		k				20.95	20.69	

* This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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3.4.2 Measurement uncertainly evaluation for system check

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10 g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	1	1	2.02	2.02	∞
Hemispherical Isotropy	5.9	R	√3	0	0	0.00	0.00	∞
Boundary effect	1	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1	R	√3	1	1	0.58	0.58	∞
Modulation response	0	N	√3	0	0	0.00	0.00	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	0	0	0.00	0.00	∞
Integration Time	1.4	R	√3	0	0	0.00	0.00	∞
RF ambient Conditions - Noise	3	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Dipole								
Deviation of experimental source from numerical source	5	N	1	1	1	5.00	5.00	∞
Input Power and SAR driftmeasurement	0.5	R	√3	1	1	0.29	0.29	∞
Dipole Axis to Liquid Dist.	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.16	10.03	
Expanded Uncertainty (95% Confidence interval)		k				20.32	20.06	

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4. Measurement System

4.1 Specific Absorption Rate (SAR) Definition

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$SAR = \frac{d}{dt}\left(\frac{dW}{dm}\right) = \frac{d}{dt}\left(\frac{dW}{\rho dv}\right)$$

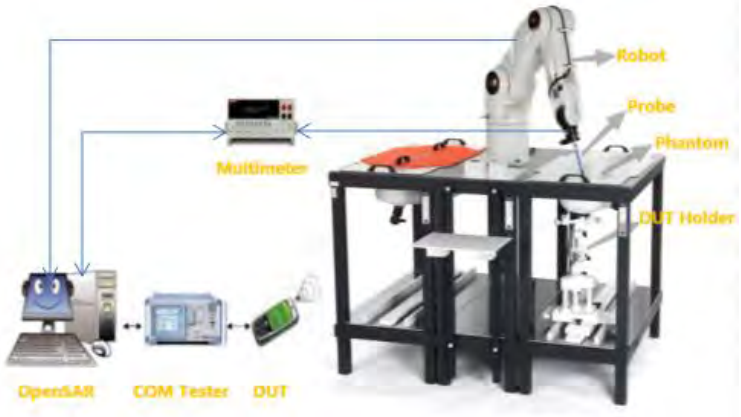
SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be related to the electrical field in the tissue by

$$SAR = \frac{\sigma E^2}{\rho}$$

Where: σ is the conductivity of the tissue,
ρ is the mass density of the tissue and E is the RMS electrical field strength.

4.2 MVG SAR System

4.2.1 SAR system diagram



4.2.2 Robot

A standard high precision 6-axis robot (Denso) with teaches pendant with Scanning System
· It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
· Must be able to set the probe orthogonal of the surface of the phantom (±30°).
· Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.

4.2.3 E-Field Probe

For the measurements, the Specific Dosimetric SSE2 E-Field Probe with following specifications is used:

- Dynamic range: 0.01-100 W/kg
- Tip diameter: 2mm for SSE2
- Distance between probe tip and sensor centre: 1mm for SSE2
- Distance between sensor centre and the inner phantom surface: 2mm for f>=4GHz.
- Probe linearity: <0.25dB.
- Axial Isotropy: <0.25dB.
- Spherical Isotropy: <0.50dB.
- Calibration range: 150 to 6000 MHz for head & body simulating liquid
- Angle between probe axis (evaluation axis) and surface normal line: less than 20°.

4.2.4 Phantoms

SAM Phantom

For the measurements the Specific Anthropomorphic Mannequin (SAM) defined by the IEEE SCC-34/SC2 group is used. The probe scanning of the E-Field is done in the 2 halves of the normalized head. The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size. It enables the dosimetric evaluation of left and right-hand phone usage and includes an additional flat phantom part for the simplified body performance check.The phantom set-up includes a cover, which prevents the evaporation of the liquid.

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The thickness of the phantom amounts to 2 mm±0.2 mm. The materials for the phantom do not affect the radiation of the device under test (DUT) : εr' <5
The head is filled with tissue simulating liquid. The hand do not have to be modeled.

SAM Phantom

TWIN SAM phantom			
	Mechanical	Electrical	
Overall thickness	2±0.2 mm(except ear area)	Relative permittivity	3.4
Dimensions	1000 mm(L) x 500 mm(W) x 200 mm(H)	Loss tangent	0.02
Maximum volume	27 L		
Material	Fiberglass based		

ELLIPTICAL Phantom

The phantom is for Body performance check filled with tissue-equivalent liquid to a depth of at least 150 mm, whose shell material is resistant to damage or reaction with tissue-equivalent liquid chemicals.

The shape of the phantom is an ellipse with length 600mm±5mm and width 400mm±5mm.
The phantom shell is made of low-loss and low-permittivity material, having loss tangent tanδ ≤ 0.05 and relative permittivity:
εr' ≤ 5 for f ≤ 3 GHz
3 ≤εr' ≤ 5 for f > 3 GHz
The thickness of the bottom-wall of the flat phantom is 2.0 mm with a tolerance of ± 0.2 mm.

ELLI Phantom

Technical & mechanical characteristics	
Shell thickness	2 mm ± 0.2 mm
Filling volume	25 L
Dimensions	600 mm x 400 mm x 200mm
Permittivity	4.4
Loss tangent	0.017

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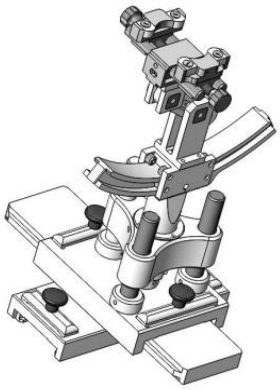
4.2.5 Device Holder



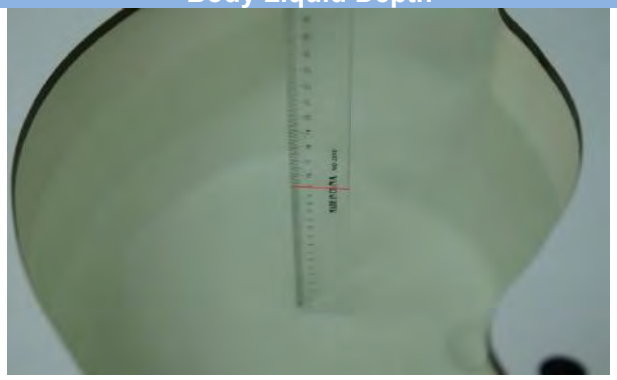
System Material	Permittivity	Loss tangent
Delrin	3.7	0.005

(The positioning system allows obtaining cheek and tilting position with a very good accuracy. In compliance with CENELEC, the tilt angle uncertainty is lower than 1°.)

System Material	Permittivity	Loss tangent
PMMA	2.9	0.028

4.2.6 Simulating Liquid

For SAR measurement of the field distribution inside the phantom, the phantom must be filled with homogeneous tissue simulating liquid to a depth of at least 15 cm. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm. The nominal dielectric values of the tissue simulating liquids in the phantom and the tolerance of 5%.

Head Liquid Depth	Body Liquid Depth
	

The following table gives the recipes for tissue simulating liquid and the theoretical Conductivity/Permittivity.

Head (Reference IEEE1528)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.4	40.0
2450	55.0	0	0	0.1	0	44.9	1.80	39.2
2600	54.9	0	0	0.1	0	45.0	1.96	39.0
Frequency (MHz)	Water (%)	Hexyl Carbitol (%)			Triton X-100 (%)		Conductivity σ (S/m)	Permittivity ε
5200	62.52	17.24			17.24		4.66	36.0
5800	62.52	17.24			17.24		5.27	35.3
Body (From instrument manufacturer)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	51.7	47.2	0	0.9	0.1	0	0.96	55.5
835	50.8	48.2	0	0.9	0.1	0	0.97	55.2
900	50.8	48.2	0	0.9	0.1	0	1.05	55.0
1800, 1900, 2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0.1	0	31.3	1.95	52.7
2600	68.2	0	0	0.1	0	31.7	2.16	52.5
Frequency(MHz)	Water	DGBE (%)			Salt (%)		Conductivity σ (S/m)	Permittivity ε
5200	78.60	21.40			/		5.30	49.00
5800	78.50	21.40			0.1		6.00	48.20

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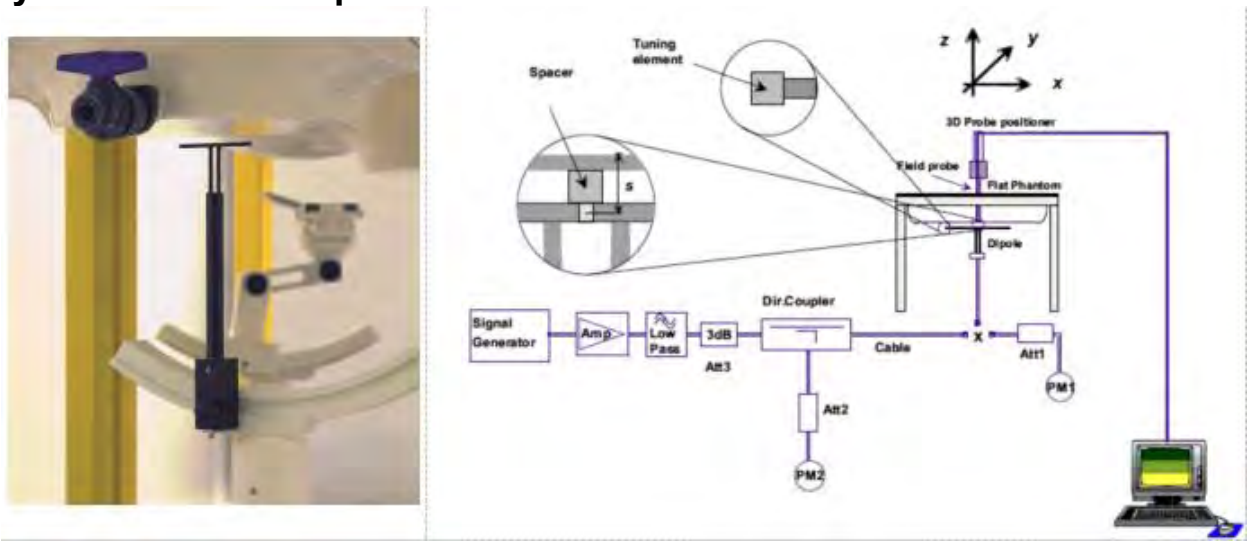
5. System Verification

5.1 Purpose of System Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. The setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

5.2 System Check Setup



6. TEST POSITION CONFIGURATIONS

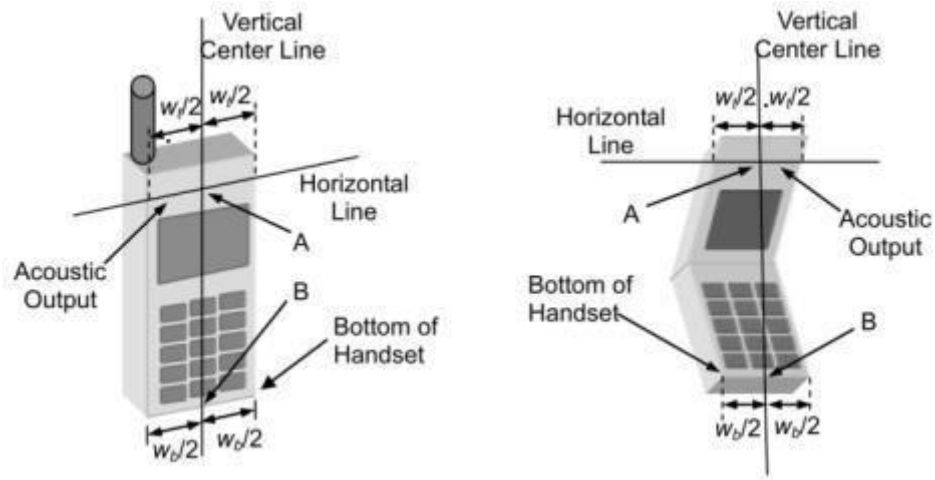
According to KDB 648474 D04 Handset, handsets are tested for SAR compliance in head, body-worn accessory and other use configurations described in the following subsections.

6.1 Head Exposure Conditions

Head exposure is limited to next to the ear voice mode operations. Head SAR compliance is tested according to the test positions defined in IEEE Std 1528-2013 using the SAM phantom illustrated as below.

6.1.1 Two Imaginary Lines on the Handset

(a) The vertical center line passes through two points on the front side of the handset - the midpoint of the width w t of the handset at the level of the acoustic output, and the midpoint of the width w b of the bottom of the handset.
(b) The horizontal line is perpendicular to the vertical center line and passes through the center of the acoustic output. The horizontal line is also tangential to the face of the handset at point A.
(c) The two lines intersect at point A. Note that for many handsets, point A coincides with the center of the acoustic output; however, the acoustic output may be located elsewhere on the horizontal line. Also note that the vertical center line is not necessarily parallel to the front face of the handset, especially for clamshell handsets, handsets with flip covers, and other irregularly shaped handsets.



6.1.2 Two Imaginary Lines on the Handset

(a) To position the device with the vertical center line of the body of the device and the horizontal line crossing the center piece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, align the vertical center line with the reference plane containing the three ear and mouth reference point (M: Mouth, RE: Right Ear, and LE: Left Ear) and align the center of the ear piece with the line RE-LE.

(b) To move the device towards the phantom with the ear piece aligned with the line LE-RE until the phone touched the ear. While maintaining the device in the reference plane and maintaining the phone contact with the ear, move the bottom of the phone until any point on the front side is in contact with the cheek of the phantom or until contact with the ear is lost.

6.1.3 Titled Position

(a) To position the device in the “cheek” position described above.

(b) While maintaining the device the reference plane described above and pivoting against the ear, moves it outward away from the mouth by an angle of 15 degrees or until contact with the ear is lost.

6.2 Body-worn Position Conditions

Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in KDB 447498 are used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode. When the reported SAR for a body-worn accessory.

Body-worn accessories that do not contain metallic or conductive components may be tested according to worst-case exposure configurations, typically according to the smallest test separation distance required for the group of body-worn accessories with similar operating and exposure characteristics. All body-worn accessories containing metallic components are tested in conjunction with the host device.

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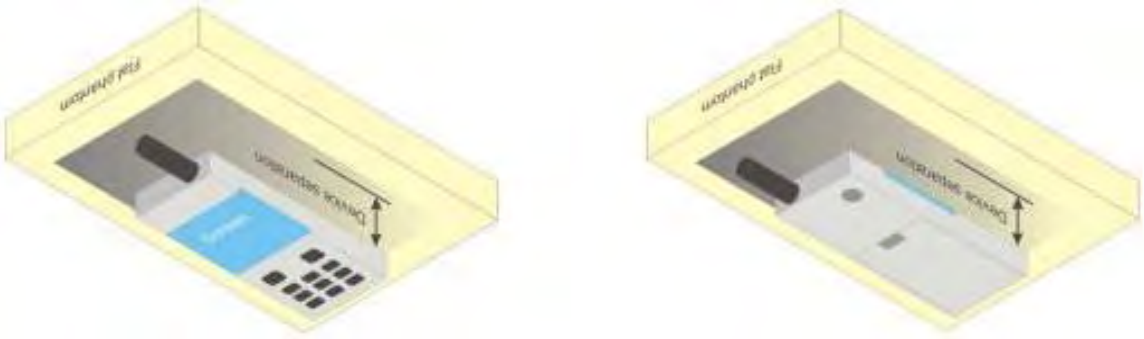
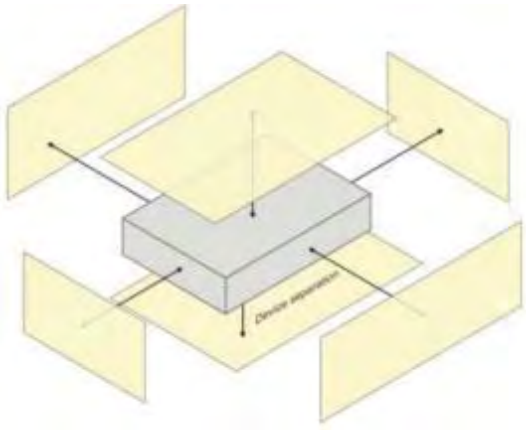
Body-worn accessory SAR compliance is based on a single minimum test separation distance for all wireless and operating modes applicable to each body-worn accessory used by the host, and according to the relevant voice and/or data mode transmissions and operations. If a body-worn accessory supports voice only operations in its normal and expected use conditions, testing of data mode for body-worn compliance is not required. A conservative minimum test separation distance for supporting off-the-shelf body-worn accessories that may be acquired by users of consumer handsets is used to test for body-worn accessory SAR compliance. This distance is determined by the handset manufacturer, according to the requirements of Supplement C 01-01. Devices that are designed to operate on the body of users using lanyards and straps, or without requiring additional body-worn accessories, will be tested using a conservative minimum test separation distance <= 5 mm to support compliance.



6.3 Hotspot Mode Exposure Position Conditions

For handsets that support hotspot mode operations, with wireless router capabilities and various web browsing functions, the relevant hand and body exposure conditions are tested according to the hotspot SAR procedures in KDB 941225. A test separation distance of 0 mm is required between the phantom and all surfaces and edges with a transmitting antenna located within 25 mm from that surface or edge. When the form factor of a handset is smaller than 9 cm x 5 cm, a test separation distance of 5 mm (instead of 10 mm) is required for testing hotspot mode. When the separation distance required for body-worn accessory testing is larger than or equal to that tested for hotspot mode, in the same wireless mode and for the same surface of the phone, the hotspot mode SAR data may be used to support body-worn accessory SAR compliance for that particular configuration (surface).



6.4 Product Specific 10g Exposure Consideration

According with FCC KDB 648474 D04, for smart phones with a display diagonal dimension > 15.0 cm or an overall diagonal dimension > 16.0 cm that provide similar mobile web access and multimedia support found in mini-tablets or UMPC mini-tablets that support voice calls next to the ear, unless it is confirmed otherwise through KDB inquiries, the following phablet procedures should be applied to evaluate SAR compliance for each applicable wireless modes and frequency band. Devices marketed as phablets, regardless of form factors and operating characteristics must be tested as a phablet to determine SAR compliance;

The UMPC mini-tablet procedures must also be applied to test the SAR of all surfaces and edges with an antenna located at ≤ 25 mm from that surface or edge, in direct contact with a flat phantom, for 10-g extremity SAR according to the body-equivalent tissue dielectric parameters in KDB 865664 to address interactive hand use exposure conditions. The UMPC mini-tablet 1-g SAR at 5 mm is not required. When hotspot mode applies, 10-g extremity SAR is required only for the surfaces and edges with hotspot mode 1-g reported SAR > 1.2 W/kg.

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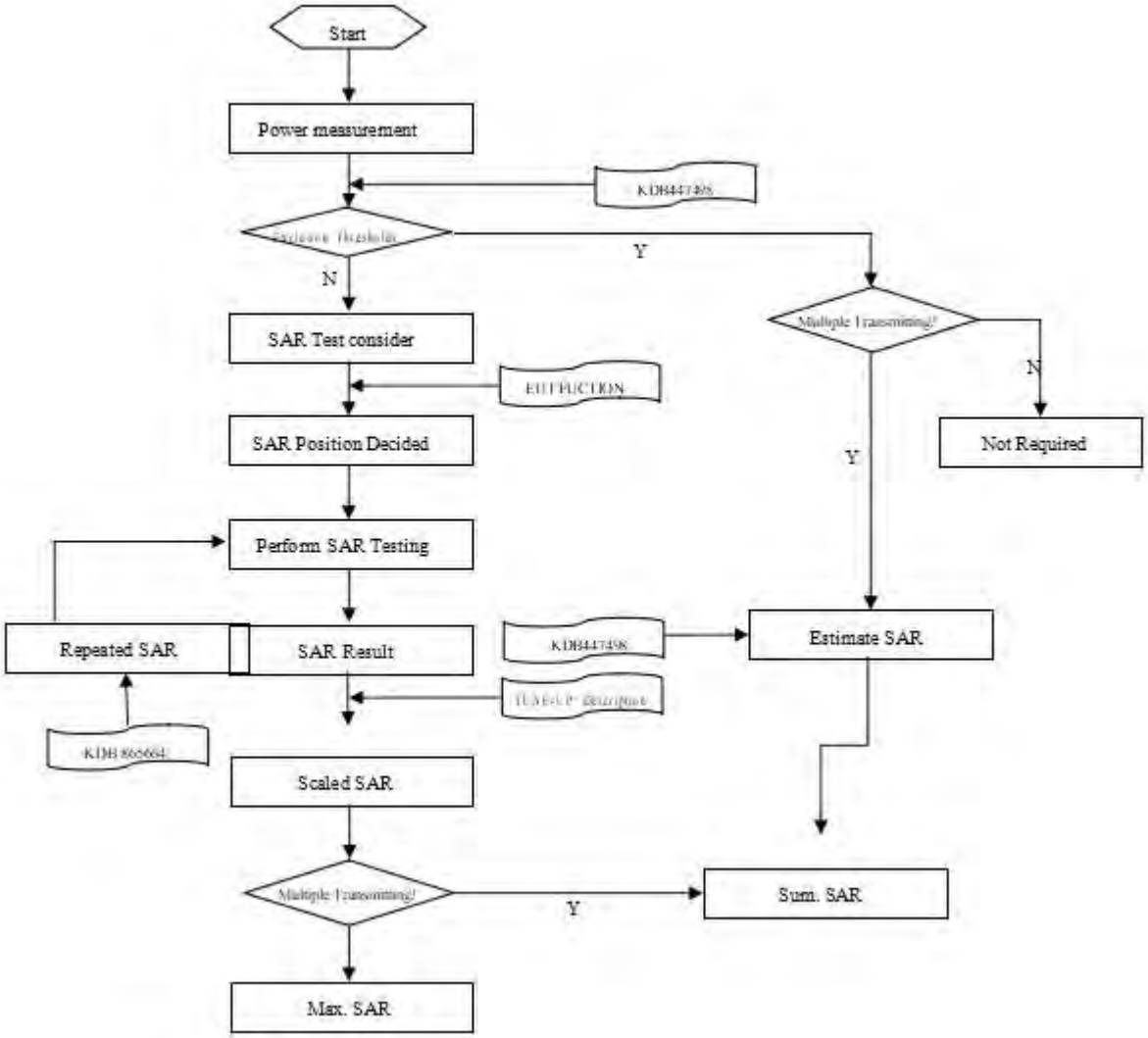
7. Measurement Procedure

7.1 Measurement Process Diagram

Body SAR



7.2 SAR Scan General Requirement

Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1 g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEEE Std 1528-2013.

<table>
<tr><th colspan="3"></th><th>≤3GHz</th><th>>3GHz</th></tr>
<tr><td colspan="3">Maximum distance from closest measurement point
(geometric center of probe sensors) to phantom surface</td><td>5±1 mm</td><td>½·δ·ln(2)±0.5 mm</td></tr>
<tr><td colspan="3">Maximum probe angle from probe axis to phantom surface
normal at the measurement location</td><td>30°±1°</td><td>20°±1°</td></tr>
<tr><td colspan="3" rowspan="2">Maximum area scan spatial resolution: Δx Area , Δy Area</td><td>≤ 2 GHz: ≤ 15 mm
2 – 3 GHz: ≤ 12 mm</td><td>3–4 GHz: ≤ 12 mm
4 – 6 GHz: ≤ 10 mm</td></tr>
<tr><td colspan="2">When the x or y dimension of the test device, in the measurement plane orientation, is smaller than the above, the measurement resolution must be ≤ the corresponding x or y dimension of the test device with at least one measurement point on the test device.</td></tr>
<tr><td colspan="3">Maximum zoom scan spatial resolution: Δx Zoom , Δy Zoom</td><td>≤ 2 GHz: ≤ 8 mm
2 –3 GHz: ≤ 5 mm*</td><td>3–4 GHz: ≤ 5 mm*
4 – 6 GHz: ≤ 4 mm*</td></tr>
<tr><td rowspan="6">Maximum zoom scan spatial resolution, normal to phantom surface</td><td colspan="2" rowspan="2">uniform grid: Δz Zoom (n)</td><td rowspan="2">≤ 5 mm</td><td>3–4 GHz: ≤ 4 mm</td></tr>
<tr><td>4–5 GHz: ≤ 3 mm</td></tr>
<tr><td rowspan="4">graded grid</td><td rowspan="3">Δz Zoom (1): between 1st two points closest to phantom surface</td><td rowspan="3">≤ 4 mm</td><td>5–6 GHz: ≤ 2 mm</td></tr>
<tr><td>3–4 GHz: ≤ 3 mm</td></tr>
<tr><td>4–5 GHz: ≤ 2.5 mm</td></tr>
<tr><td>Δz Zoom (n>1): between subsequent points</td><td colspan="2">≤ 1.5·Δz Zoom (n-1)</td><td>5–6 GHz: ≤ 2 mm</td></tr>
<tr><td rowspan="3">Minimum zoom scan volume</td><td colspan="2" rowspan="3">x, y, z</td><td rowspan="3">≥30 mm</td><td>3–4 GHz: ≥ 28 mm</td></tr>
<tr><td>4–5 GHz: ≥ 25 mm</td></tr>
<tr><td>5–6 GHz: ≥ 22 mm</td></tr>
<tr><td colspan="5">Note:
1. δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528- 2011 for details.
2. * When zoom scan is required and the reported SAR from the area scan based 1 g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.</td></tr>
</table>

7.3 Measurement Procedure

The following steps are used for each test position

a. Establish a call with the maximum output power with a base station simulator. The connection between the mobile and the base station simulator is established via air interface

b. Measurement of the local E-field value at a fixed location. This value serves as a reference value for calculating a possible power drift.

c. Measurement of the SAR distribution with a grid of 8 to 16mm * 8 to16 mm and a constant distance to the inner surface of the phantom. Since the sensors cannot directly measure at the inner phantom surface, the values between the sensors and the inner phantom surface are extrapolated. With these values the area of the maximum SAR is calculated by an interpolation scheme.

d. Around this point, a cube of 30 * 30 * 30 mm or 32 * 32 *32 mm is assessed by measuring 5 or 8 * 5 or 8*4 or 5 mm. With these data, the peak spatial-average SAR value can be calculated.

7.4 Area & Zoom Scan Procedure

First Area Scan is used to locate the approximate location(s) of the local peak SAR value(s). The measurement grid within an Area Scan is defined by the grid extent, grid step size and grid offset. Next, in order to determine the EM field distribution in a three-dimensional spatial extension, Zoom Scan is required. The Zoom Scan is performed around the highest E-field value to determine the averaged SAR-distribution over 10 g. Area scan and zoom scan resolution setting follows KDB 865664 D01v01r04 quoted below.

When the 1 g SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are required for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR.

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8. Conducted RF Output Power

8.1 LTE

Band 2

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18607	18900	19193
					1850.7MHz	1880.0MHz	1909.3MHz
1.4MHz	QPSK	1	0	23.00	22.60	22.53	22.91
			2	23.00	22.46	22.47	22.82
			5	23.00	22.36	22.36	22.90
		3	0	23.00	22.53	22.44	22.83
			2	23.00	22.49	22.47	22.82
			3	23.00	22.41	22.39	22.84
		6	0	22.00	21.45	21.37	21.88
	16QAM	1	0	22.50	21.71	21.70	22.01
			2	22.50	21.73	21.71	22.06
			5	22.00	21.60	21.52	21.94
		3	0	22.00	21.23	21.35	21.80
			2	22.00	21.30	21.37	21.74
			3	22.00	21.19	21.26	21.74
		6	0	21.00	20.40	20.45	20.78
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18615	18900	19185
					1851.5MHz	1880.0MHz	1908.5MHz
3MHz	QPSK	1	0	23.00	22.42	22.54	22.95
			7	23.50	22.46	22.45	23.07
			14	23.50	22.34	22.48	23.03
		8	0	22.00	21.43	21.38	21.98
			4	22.00	21.41	21.37	21.97
			7	22.50	21.34	21.36	22.00
		15	0	22.00	21.38	21.39	21.96
	16QAM	1	0	22.00	21.66	21.58	21.87
			7	22.00	21.72	21.68	21.93
			14	22.00	21.47	21.65	21.85
		8	0	21.00	20.44	20.43	20.96
			4	21.00	20.44	20.42	20.94
			7	21.00	20.34	20.37	20.99
		15	0	21.00	20.34	20.36	20.90
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18625	18900	19175
					1852.5MHz	1880.0MHz	1907.5MHz
5MHz	QPSK	1	0	23.50	22.74	22.72	23.17
			13	23.50	22.49	22.68	23.09
			24	23.50	22.38	22.52	23.06
		12	0	22.50	21.42	21.60	22.09
			6	22.50	21.42	21.60	22.11
			13	22.50	21.27	21.42	22.00
		25	0	22.50	21.39	21.55	22.05
	16QAM	1	0	22.50	21.65	21.96	22.06
			13	22.50	21.54	21.87	22.20
			24	22.50	21.37	21.85	22.03
		12	0	21.50	20.42	20.64	21.10
			6	21.50	20.43	20.64	21.10
			13	21.00	20.32	20.53	20.98
		25	0	21.50	20.37	20.52	21.12

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LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18650	18900	19150
					1855.0MHz	1880.0MHz	1905.0MHz
10MHz	QPSK	1	0	23.00	22.57	22.58	22.93
			25	23.00	22.23	22.56	22.95
			49	23.50	22.43	22.52	23.18
		25	0	22.00	21.35	21.50	21.86
			13	22.00	21.37	21.51	21.89
			25	22.00	21.35	21.47	21.96
		50	0	22.00	21.33	21.54	21.95
	16QAM	1	0	22.00	21.88	21.67	21.78
			25	22.00	21.52	21.65	21.83
			49	22.50	21.65	21.59	22.05
		25	0	21.00	20.35	20.56	20.91
			13	21.00	20.39	20.57	20.91
			25	21.00	20.31	20.47	20.98
		50	0	21.00	20.31	20.56	20.95
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18675	18900	19125
					1857.5MHz	1880.0MHz	1902.5MHz
15MHz	QPSK	1	0	23.00	22.59	22.79	22.81
			38	23.00	22.22	22.43	22.74
			74	23.50	22.45	22.49	23.19
		36	0	22.00	21.27	21.49	21.77
			18	22.00	21.28	21.51	21.76
			39	22.00	21.30	21.54	21.78
		75	0	22.00	21.28	21.49	21.78
	16QAM	1	0	22.50	21.72	22.01	21.63
			38	22.00	21.34	21.78	21.60
			74	22.00	21.64	21.72	21.97
		36	0	22.00	21.30	21.54	21.74
			18	22.00	21.30	21.51	21.77
			39	22.00	21.30	21.49	21.78
		75	0	21.00	20.23	20.50	20.77
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	23.00	22.55	22.58	22.53
			50	**23.00**	22.38	22.56	**22.70**
			99	23.00	22.34	22.13	22.70
		50	0	22.00	21.20	21.47	21.55
			25	22.00	21.21	21.48	21.55
			50	22.00	21.23	21.32	**21.71**
		100	0	22.00	21.23	21.44	21.68
	16QAM	1	0	22.00	21.50	21.71	21.55
			50	22.00	21.37	21.69	21.72
			99	22.00	21.31	21.34	21.74
		50	0	21.00	20.20	20.52	20.53
			25	21.00	20.24	20.52	20.58
			50	21.00	20.27	20.27	20.82
		100	0	21.00	20.30	20.41	20.70

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Band 4

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		19957	20175	20393
					1710.7MHz	1732.5MHz	1754.3MHz
1.4MHz	QPSK	1	0	24.00	23.72	23.01	22.52
			2	24.00	23.60	23.03	22.55
			5	24.00	23.50	22.98	22.50
		3	0	23.50	23.46	22.95	22.49
			2	24.00	23.56	23.03	22.56
			3	24.00	23.78	23.01	22.46
		6	0	23.00	22.61	22.00	21.61
	16QAM	1	0	23.00	22.58	22.08	21.57
			2	23.00	22.67	22.21	21.71
			5	23.00	22.62	22.12	21.58
		3	0	23.00	22.70	21.90	21.41
			2	23.00	22.68	21.91	21.38
			3	22.50	22.47	21.92	21.42
		6	0	22.00	21.61	20.83	20.70
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19965	20175	20385
					1711.5MHz	1732.5MHz	1753.5MHz
3MHz	QPSK	1	0	23.50	23.46	23.12	22.41
			7	23.50	23.38	23.01	22.43
			14	23.50	23.41	23.03	22.43
		8	0	23.00	22.71	22.07	21.60
			4	23.00	22.74	22.07	21.57
			7	23.00	22.58	22.01	21.54
		15	0	23.00	22.61	22.05	21.56
	16QAM	1	0	23.00	22.79	22.18	21.67
			7	23.00	22.69	22.24	21.67
			14	23.00	22.63	22.09	21.62
		8	0	22.00	21.74	21.15	20.68
			4	22.00	21.75	21.14	20.68
			7	22.00	21.67	21.09	20.59
		15	0	22.00	21.61	20.97	20.67
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19976	20175	20375
					1712.5MHz	1732.5MHz	1752.5MHz
5MHz	QPSK	1	0	24.00	23.64	23.26	22.66
			13	24.00	23.78	23.15	22.44
			24	23.50	23.47	23.08	22.51
		12	0	23.00	22.76	22.10	21.61
			6	23.00	22.79	22.09	21.67
			13	23.00	22.59	22.03	21.51
		25	0	23.00	22.63	22.02	21.46
	16QAM	1	0	23.00	22.64	22.43	21.57
			13	23.00	22.62	22.33	21.46
			24	23.00	22.50	22.24	21.56
		12	0	22.00	21.75	21.19	20.59
			6	22.00	21.78	21.17	20.59
			13	22.00	21.58	21.06	20.51
		25	0	22.00	21.62	21.05	20.51

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LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20000	20175	20350
					1715.0MHz	1732.5MHz	1750.0MHz
10MHz	QPSK	1	0	24.00	23.59	23.38	22.66
			25	23.50	23.23	22.97	22.32
			49	24.00	23.68	23.27	22.79
		25	0	22.50	22.49	22.02	21.43
			13	22.50	22.44	22.04	21.44
			25	22.50	22.35	22.13	21.52
		50	0	22.50	22.46	22.08	21.58
	16QAM	1	0	23.00	22.84	22.46	21.80
			25	22.50	22.45	22.18	21.46
			49	23.00	22.89	22.70	22.00
		25	0	21.50	21.46	21.06	20.50
			13	21.50	21.45	21.06	20.48
			25	21.50	21.33	21.18	20.55
		50	0	21.50	21.43	21.09	20.57
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20025	20175	20325
					1717.5MHz	1732.5MHz	1747.5MHz
15MHz	QPSK	1	0	23.50	23.18	22.89	22.36
			38	23.50	23.13	22.88	22.04
			74	23.50	23.08	22.47	22.04
		36	0	22.50	22.20	21.77	21.25
			18	22.50	22.20	21.81	21.26
			39	22.50	22.19	21.81	21.26
		75	0	22.50	22.19	21.77	21.26
	16QAM	1	0	22.50	22.38	22.18	21.55
			38	22.50	22.43	22.16	21.26
			74	22.50	22.28	21.76	21.22
		36	0	22.50	22.20	21.77	21.25
			18	22.50	22.20	21.75	21.26
			39	22.50	22.19	21.78	21.26
		75	0	21.50	21.11	20.85	20.24
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20050	20175	20300
					1720.0MHz	1732.5MHz	1745.0MHz
20MHz	QPSK	1	0	23.50	23.13	22.74	22.62
			50	**23.50**	**23.17**	22.94	22.52
			99	23.00	22.96	22.50	22.29
		50	0	22.50	22.18	21.86	21.53
			25	22.50	**22.22**	21.85	21.51
			50	22.50	22.03	21.63	21.25
		100	0	22.50	22.03	21.81	21.45
	16QAM	1	0	22.50	22.22	21.85	21.70
			50	22.50	22.25	22.05	21.54
			99	22.00	21.97	21.67	21.31
		50	0	21.50	21.15	20.91	20.52
			25	21.50	21.14	20.85	20.52
			50	21.00	20.98	20.71	20.26
		100	0	21.50	21.01	20.82	20.48

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Band 5

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20407	20525	20643
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	23.00	22.97	22.35	22.74
			2	23.00	22.93	22.39	22.78
			5	23.00	22.94	22.31	22.68
		3	0	23.50	23.03	22.50	22.76
			2	23.00	22.95	22.47	22.84
			3	23.00	22.92	22.38	22.71
		6	0	22.00	21.96	21.44	21.75
	16QAM	1	0	22.50	22.18	21.40	21.77
			2	22.50	22.16	21.56	21.86
			5	22.50	22.09	21.45	21.72
		3	0	22.00	21.91	21.42	21.70
			2	22.00	21.91	21.39	21.70
			3	22.00	21.81	21.34	21.67
		6	0	21.00	20.99	20.35	20.77
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20415	20525	20635
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	23.00	22.82	22.29	22.75
			7	23.00	22.71	22.28	22.75
			14	23.00	22.58	22.25	22.65
		8	0	22.00	21.75	21.30	21.87
			4	22.00	21.72	21.34	21.86
			7	22.00	21.69	21.29	21.93
		15	0	22.00	21.74	21.27	21.80
	16QAM	1	0	22.00	21.94	21.50	21.96
			7	22.00	21.87	21.41	21.96
			14	22.00	21.62	21.38	21.79
		8	0	21.00	20.78	20.35	20.93
			4	21.00	20.77	20.35	20.88
			7	21.00	20.67	20.31	20.88
		15	0	21.00	20.63	20.36	20.94

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20425	20525	20625
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	23.50	23.15	22.58	22.88
			13	23.00	22.89	22.49	22.84
			24	23.00	22.73	22.41	22.85
		12	0	22.00	21.94	21.41	21.86
			6	22.00	21.95	21.39	21.83
			13	22.00	21.85	21.44	21.81
		25	0	22.00	21.87	21.43	21.82
	16QAM	1	0	22.50	22.11	21.72	21.92
			13	22.00	21.89	21.66	21.92
			24	22.00	21.81	21.58	21.87
		12	0	21.50	21.04	20.49	20.86
			6	21.50	21.03	20.45	20.87
			13	21.00	20.81	20.50	20.80
		25	0	21.00	20.86	20.36	20.83

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	**23.50**	**23.22**	22.63	22.65
			25	23.00	22.64	22.38	22.62
			49	23.00	22.75	22.77	22.96
		25	0	22.00	21.86	21.55	21.58
			13	22.00	**21.90**	21.56	21.57
			25	22.00	21.64	21.53	21.77
		50	0	22.00	21.78	21.50	21.81
	16QAM	1	0	22.50	22.38	21.81	21.84
			25	22.00	21.94	21.57	21.88
			49	22.50	21.98	21.86	22.14
		25	0	21.00	20.88	20.55	20.63
			13	21.00	20.87	20.55	20.63
			25	21.00	20.61	20.58	20.86
		50	0	21.00	20.73	20.50	20.67

Band 7

LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20775	21100	21425
					2502.5MHz	2535MHz	2567.5MHz
5MHz	QPSK	1	0	22.00	21.40	21.80	20.56
			12	22.00	21.11	21.72	20.47
			24	22.00	20.97	21.69	20.34
		12	0	21.00	20.18	20.59	19.47
			6	21.00	20.16	20.62	19.43
			13	21.00	19.99	20.63	19.29
		25	0	21.00	20.08	20.67	19.41
	16QAM	1	0	21.00	20.29	20.95	19.56
			12	21.00	20.18	20.92	19.45
			24	21.00	19.96	20.85	19.34
		12	0	20.00	19.15	19.72	18.47
			6	20.00	19.13	19.71	18.47
			13	20.00	18.98	19.75	18.35
		25	0	20.00	19.06	19.65	18.45
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20800	21100	21400
					2505MHz	2535MHz	2565MHz
10MHz	QPSK	1	0	22.00	21.24	21.83	20.91
			24	22.00	20.77	21.65	20.48
			49	22.00	20.91	21.71	20.42
		25	0	21.00	20.05	20.56	19.81
			12	21.00	20.05	20.57	19.79
			25	20.50	19.82	20.47	19.42
		50	0	21.00	19.83	20.62	19.63
	16QAM	1	0	21.50	20.51	21.02	19.89
			24	21.00	19.92	20.81	19.41
			49	21.00	20.08	20.79	19.30
		25	0	20.00	19.05	19.60	18.82
			12	20.00	19.03	19.62	18.83
			25	20.00	18.79	19.56	18.41
		50	0	20.00	18.90	19.63	18.65

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LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20825	21100	21375
					2507.5MHz	2535MHz	2562.5MHz
15MHz	QPSK	1	0	22.00	21.18	21.58	21.02
			38	22.00	20.90	21.65	20.65
			74	22.00	20.90	21.61	20.31
		38	0	21.00	19.94	20.67	19.73
			18	21.00	19.94	20.69	19.69
			37	21.00	19.96	20.69	19.71
		75	0	21.00	19.95	20.69	19.71
	16QAM	1	0	21.00	20.42	20.87	19.96
			38	21.00	20.09	20.92	19.60
			74	21.00	20.07	20.91	19.20
		38	0	21.00	19.92	20.69	19.72
			18	21.00	19.94	20.69	19.73
			37	21.00	19.96	20.69	19.71
		75	0	20.00	18.91	19.69	18.77
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20850	21100	21350
					2510MHz	2535MHz	2560MHz
20MHz	QPSK	1	0	22.00	21.27	21.68	21.43
			49	**22.00**	21.01	**21.79**	20.90
			99	22.00	21.27	21.66	20.30
		50	0	21.00	19.98	**20.70**	20.06
			25	21.00	19.99	20.65	20.10
			50	21.00	19.96	20.54	19.61
		100	0	21.00	20.01	20.69	19.91
	16QAM	1	0	21.00	20.33	20.77	20.41
			49	21.00	20.00	20.92	19.89
			99	21.00	20.31	20.86	19.35
		50	0	20.00	18.96	19.74	19.14
			25	20.00	18.96	19.75	19.15
			50	20.00	18.94	19.66	18.66
		100	0	20.00	19.05	19.72	18.97

Band 12

LTE-FDD Band 12				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23017	23095	23173
					699.7MHz	707.5MHz	715.3MHz
1.4MHz	QPSK	1	0	24.00	22.82	23.56	23.49
			2	24.00	22.95	23.72	23.53
			5	24.00	22.94	23.62	23.46
		3	0	24.00	22.91	23.55	23.53
			2	24.00	22.92	23.63	23.46
			3	24.00	22.80	23.69	23.52
		6	0	23.00	21.85	22.62	22.53
	16QAM	1	0	23.00	21.93	22.43	22.59
			2	23.00	22.06	22.57	22.70
			5	23.00	22.02	22.50	22.67
		3	0	22.50	21.83	22.33	22.45
			2	22.50	21.84	22.40	22.44
			3	22.50	21.72	22.40	22.39
		6	0	22.00	20.77	21.63	21.53

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23025	23095	23165
					700.5MHz	707.5MHz	714.5MHz
3MHz	QPSK	1	0	24.00	22.75	23.55	23.58
			7	24.00	22.93	23.61	23.61
			14	24.00	22.96	23.67	23.59
		8	0	23.00	21.84	22.64	22.53
			4	23.00	21.80	22.58	22.58
			7	23.00	21.93	22.58	22.63
		15	0	23.00	22.04	22.67	22.49
	16QAM	1	0	23.00	21.94	22.62	22.49
			7	23.00	22.09	22.83	22.46
			14	23.00	22.10	22.78	22.43
		8	0	22.00	20.92	21.63	21.60
			4	22.00	20.89	21.63	21.57
			7	22.00	21.04	21.64	21.62
		15	0	22.00	20.95	21.55	21.52
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23035	23095	23155
					701.5MHz	707.5MHz	713.5MHz
5MHz	QPSK	1	0	24.00	22.92	23.53	23.74
			13	24.00	23.19	23.75	23.67
			24	24.00	23.23	23.92	23.68
		12	0	23.00	21.90	22.47	22.60
			6	23.00	21.96	22.49	22.59
			13	23.00	22.10	22.78	22.58
		25	0	23.00	22.09	22.66	22.69
	16QAM	1	0	23.00	21.94	22.79	22.66
			13	23.00	22.18	22.89	22.73
			24	23.50	22.24	23.03	22.74
		12	0	22.00	20.89	21.50	21.65
			6	22.00	20.96	21.52	21.63
			13	22.00	21.16	21.83	21.62
		25	0	22.00	21.09	21.63	21.70
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23060	23095	23130
					704.0MHz	707.5MHz	711.0MHz
10MHz	QPSK	1	0	24.00	23.10	23.50	23.70
			25	24.00	23.22	23.59	23.58
			49	**24.00**	23.78	**23.92**	23.69
		25	0	23.00	22.11	22.60	22.65
			13	23.00	22.14	22.63	22.63
			25	23.00	22.51	**22.75**	22.75
		50	0	23.00	22.38	22.66	22.75
	16QAM	1	0	23.00	22.30	22.74	22.66
			25	23.00	22.36	22.79	22.56
			49	23.50	22.93	23.14	22.63
		25	0	22.00	21.17	21.58	21.68
			13	22.00	21.17	21.59	21.66
			25	22.00	21.50	21.77	21.75
		50	0	22.00	21.37	21.69	21.72

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Band 13

LTE-FDD Band 13				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23205	23230	23255
					779.5MHz	782.0MHz	784.5MHz
5MHz	QPSK	1	0	23.50	23.32	23.34	23.36
			13	23.50	23.31	23.35	23.24
			24	23.50	23.21	23.09	23.06
		12	0	22.50	22.44	22.18	22.20
			6	23.00	22.51	22.19	22.21
			13	22.50	22.18	22.11	22.04
		25	0	22.50	22.37	22.18	22.08
	16QAM	1	0	23.00	22.29	22.53	22.31
			13	22.50	22.32	22.46	22.29
			24	22.50	22.22	22.24	22.05
		12	0	21.50	21.36	21.21	21.23
			6	21.50	21.31	21.22	21.23
			13	21.50	21.17	21.14	21.13
		25	0	21.50	21.38	21.32	21.14

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23230
					782.0MHz
10MHz	QPSK	1	0	**24.00**	**23.57**
			25	23.50	23.18
			49	23.50	23.15
		25	0	22.50	22.39
			13	22.50	**22.40**
			25	22.50	22.17
		50	0	22.50	22.31
	16QAM	1	0	23.00	22.90
			25	22.50	22.40
			49	22.50	22.24
		25	0	21.50	21.47
			13	22.00	21.51
			25	21.50	21.16
		50	0	21.50	21.29

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Band 14

LTE-FDD Band 14				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23305	23330	23355
					790.5MHz	793.0MHz	795.5MHz
5MHz	QPSK	1	0	23.00	22.95	22.78	22.76
			13	23.00	22.81	22.70	22.72
			24	23.00	22.62	22.62	22.63
		12	0	22.00	21.83	21.58	21.50
			6	22.00	21.80	21.62	21.50
			13	22.00	21.66	21.49	21.55
		25	0	22.00	21.72	21.60	21.60
	16QAM	1	0	22.00	21.94	21.90	21.67
			13	22.00	21.80	21.84	21.66
			24	22.00	21.70	21.85	21.68
		12	0	21.00	20.86	20.66	20.53
			6	21.00	20.88	20.65	20.52
			13	21.00	20.65	20.62	20.62
		25	0	21.00	20.79	20.62	20.68

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23330
					793.0MHz
10MHz	QPSK	1	0	**23.50**	**23.09**
			25	23.00	22.65
			49	23.00	22.78
		25	0	22.00	21.77
			13	22.00	**21.78**
			25	22.00	21.65
		50	0	22.00	21.76
	16QAM	1	0	22.50	22.31
			25	22.00	21.86
			49	22.00	21.87
		25	0	21.00	20.86
			13	21.00	20.85
			25	21.00	20.69
		50	0	21.00	20.72

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Band 17

LTE-FDD Band 17				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23755	23790	23825
					706.5MHz	710.0MHz	713.5MHz
5MHz	QPSK	1	0	24.00	23.47	23.38	23.82
			12	24.00	23.57	23.70	23.70
			24	24.00	23.61	23.70	23.58
		12	0	23.00	22.50	22.53	22.71
			6	23.00	22.50	22.51	22.72
			13	23.00	22.64	22.67	22.74
		25	0	23.00	22.56	22.49	22.76
	16QAM	1	0	23.00	22.42	22.67	22.87
			12	23.00	22.60	22.86	22.67
			24	23.00	22.67	22.83	22.81
		12	0	22.00	21.53	21.61	21.73
			6	22.00	21.47	21.66	21.74
			13	22.00	21.64	21.67	21.73
		25	0	22.00	21.56	21.55	21.82
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23780	23790	23800
					709.0MHz	710.0MHz	711.0MHz
10MHz	QPSK	1	0	24.00	23.53	23.22	23.24
			24	24.00	23.39	23.52	23.50
			49	**24.00**	23.68	**23.71**	23.65
		25	0	23.00	22.46	22.59	22.65
			12	23.00	22.50	22.58	22.60
			25	23.00	22.72	**22.71**	22.72
		50	0	23.00	22.64	22.71	22.78
	16QAM	1	0	23.00	22.70	22.77	22.66
			24	23.00	22.64	22.69	22.53
			49	23.00	22.86	22.99	22.63
		25	0	22.00	21.49	21.61	21.69
			12	22.00	21.41	21.59	21.67
			25	22.00	21.64	21.82	21.73
		50	0	22.00	21.65	21.71	21.81

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Band 25

LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26047	26365	26683
					1850.7MHz	1882.5MHz	1914.3MHz
1.4MHz	QPSK	1	0	23.50	22.66	22.52	23.12
			2	23.50	22.64	22.53	23.15
			5	23.50	22.59	22.48	23.06
		3	0	23.50	22.67	22.50	23.15
			2	23.50	22.70	22.47	23.08
			3	23.50	22.56	22.50	23.08
		6	0	22.50	21.67	21.45	22.17
	16QAM	1	0	22.50	21.83	21.76	22.09
			2	22.50	21.83	21.76	22.07
			5	22.00	21.82	21.53	21.98
		3	0	22.00	21.60	21.37	21.94
			2	22.00	21.54	21.37	21.96
			3	22.00	21.46	21.31	21.93
		6	0	21.50	20.78	20.40	21.19
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26055	26365	26675
					1851.5MHz	1882.5MHz	1913.5MHz
3MHz	QPSK	1	0	23.50	22.75	22.57	23.26
			7	23.50	22.74	22.53	23.24
			14	23.50	22.62	22.54	23.10
		8	0	22.50	21.59	21.55	22.15
			4	22.50	21.60	21.56	22.21
			7	22.50	21.53	21.46	22.20
		15	0	22.50	21.63	21.51	22.26
	16QAM	1	0	22.50	21.99	21.81	22.10
			7	22.50	21.89	21.71	22.14
			14	22.50	21.83	21.67	22.07
		8	0	21.50	20.65	20.55	21.22
			4	21.50	20.72	20.53	21.22
			7	21.50	20.60	20.46	21.19
		15	0	21.50	20.59	20.40	21.16
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26065	26365	26665
					1852.5MHz	1882.5MHz	1912.5MHz
5MHz	QPSK	1	0	23.50	22.83	22.78	23.36
			13	23.50	22.56	22.62	23.33
			24	23.50	22.55	22.58	23.22
		12	0	22.50	21.59	21.53	22.14
			6	22.50	21.59	21.54	22.13
			13	22.50	21.43	21.47	22.15
		25	0	22.50	21.52	21.55	22.17
	16QAM	1	0	22.50	21.86	22.00	22.22
			13	22.50	21.62	21.82	22.34
			24	22.50	21.58	21.81	22.30
		12	0	21.50	20.61	20.55	21.23
			6	21.50	20.62	20.58	21.21
			13	21.50	20.41	20.57	21.21
		25	0	21.50	20.50	20.48	21.19

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LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26090	26365	26640
					1855.0MHz	1882.5MHz	1910.0MHz
10MHz	QPSK	1	0	23.50	22.73	22.73	23.11
			25	23.50	22.43	22.51	23.10
			49	23.50	22.56	22.77	23.30
		25	0	22.00	21.52	21.52	21.98
			13	22.00	21.52	21.53	21.99
			25	22.50	21.37	21.55	22.19
		50	0	22.50	21.49	21.50	22.15
	16QAM	1	0	22.50	22.08	21.85	21.92
			25	22.00	21.75	21.60	21.95
			49	22.50	21.79	21.86	22.28
		25	0	21.50	20.49	20.61	21.04
			13	21.50	20.47	20.60	21.00
			25	21.50	20.34	20.55	21.27
		50	0	21.50	20.43	20.54	21.14
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26115	26365	26615
					1857.5MHz	1882.5MHz	1907.5MHz
15MHz	QPSK	1	0	23.50	22.60	22.68	23.07
			38	23.50	22.34	22.58	23.21
			74	23.50	22.39	22.61	23.36
		36	0	22.50	21.50	21.79	22.27
			18	22.50	21.49	21.74	22.29
			39	22.50	21.50	21.74	22.27
		75	0	22.50	21.50	21.76	22.25
	16QAM	1	0	22.00	21.79	21.97	21.90
			38	22.50	21.49	21.94	22.04
			74	22.50	21.55	21.95	22.30
		36	0	22.50	21.53	21.72	22.27
			18	22.50	21.53	21.77	22.27
			39	22.50	21.52	21.71	22.29
		75	0	21.50	20.40	20.74	21.32
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26140	26365	26590
					1860.0MHz	1882.5MHz	1905.0MHz
20MHz	QPSK	1	0	23.00	22.64	22.52	22.72
			50	**23.50**	22.37	22.68	**23.01**
			99	23.00	22.16	22.23	22.91
		50	0	22.00	21.32	21.57	21.79
			25	22.00	21.36	21.57	21.81
			50	22.50	21.30	21.46	**22.13**
		100	0	22.00	21.35	21.51	21.97
	16QAM	1	0	22.00	21.55	21.72	21.76
			50	22.50	21.35	21.82	22.08
			99	22.50	21.16	21.47	22.05
		50	0	21.00	20.29	20.56	20.89
			25	21.00	20.34	20.56	20.91
			50	21.50	20.26	20.50	21.21
		100	0	21.50	20.33	20.50	21.01

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Band 26

LTE-FDD Band 26a				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26697	26740	26783
					814.7MHz	819.0MHz	823.3MHz
1.4MHz	QPSK	1	0	24.00	23.61	23.60	23.41
			2	24.00	23.58	23.62	23.37
			5	24.00	23.50	23.53	23.25
		3	0	24.00	23.50	23.53	23.30
			2	24.00	23.50	23.51	23.35
			3	24.00	23.52	23.49	23.29
		6	0	23.00	22.55	22.59	22.26
	16QAM	1	0	23.00	22.73	22.65	22.32
			2	23.00	22.76	22.81	22.24
			5	23.00	22.57	22.65	22.16
		3	0	22.50	22.39	22.42	22.15
			2	22.50	22.39	22.43	22.22
			3	22.50	22.49	22.48	22.10
		6	0	22.00	21.59	21.47	21.26
LTE-FDD Band 26b				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26797	26915	27033
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	23.50	23.13	22.56	23.07
			2	23.50	23.08	22.52	23.18
			5	23.50	22.99	22.47	23.01
		3	0	23.50	23.07	22.46	23.19
			2	23.50	23.08	22.46	23.17
			3	23.50	22.99	22.57	23.07
		6	0	22.50	22.02	21.46	22.05
	16QAM	1	0	22.50	22.24	21.74	22.20
			2	22.50	22.30	21.59	22.20
			5	22.50	22.10	21.68	22.07
		3	0	22.50	22.01	21.51	21.93
			2	22.00	21.97	21.49	21.99
			3	22.50	21.95	21.47	22.08
		6	0	21.50	21.03	20.33	21.06

LTE-FDD Band 26a				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26705	26740	26775
					815.5MHz	819.0MHz	822.5MHz
3MHz	QPSK	1	0	24.00	23.49	23.51	23.29
			7	24.00	23.59	23.46	23.25
			14	24.00	23.51	23.34	23.21
		8	0	23.00	22.62	22.48	22.31
			4	23.00	22.62	22.48	22.26
			7	23.00	22.51	22.43	22.31
		15	0	23.00	22.59	22.33	22.28
	16QAM	1	0	23.00	22.76	22.61	22.18
			7	23.00	22.78	22.71	22.20
			14	23.00	22.65	22.43	22.08
		8	0	22.00	21.65	21.50	21.29
			4	22.00	21.65	21.50	21.29
			7	22.00	21.63	21.42	21.30
		15	0	22.00	21.60	21.36	21.21

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LTE-FDD Band 26b				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26805	26915	27025
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	23.50	23.10	22.65	23.03
			7	23.50	23.00	22.55	23.13
			14	23.50	22.78	22.47	23.16
		8	0	22.50	22.09	21.54	22.18
			4	22.50	22.04	21.53	22.15
			7	22.50	21.93	21.53	22.36
		15	0	22.50	21.98	21.48	22.13
	16QAM	1	0	22.50	22.22	21.72	22.22
			7	22.50	22.14	21.74	22.26
			14	22.50	21.98	21.53	22.32
		8	0	21.50	21.08	20.53	21.20
			4	21.50	21.06	20.53	21.17
			7	21.50	21.04	20.51	21.41
		15	0	21.50	20.98	20.50	21.25

LTE-FDD Band 26a				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26715	26740	26765
					816.5MHz	819.0MHz	821.5MHz
5MHz	QPSK	1	0	24.00	23.60	23.49	23.54
			13	24.00	23.60	23.58	23.44
			24	24.00	23.56	23.32	23.24
		12	0	23.00	22.58	22.52	22.36
			6	23.00	22.57	22.48	22.36
			13	23.00	22.68	22.41	22.29
		25	0	23.00	22.62	22.36	22.39
	16QAM	1	0	23.00	22.61	22.64	22.54
			13	23.00	22.57	22.73	22.41
			24	23.00	22.67	22.49	22.31
		12	0	22.00	21.53	21.59	21.38
			6	22.00	21.54	21.59	21.41
			13	22.00	21.69	21.55	21.28
		25	0	22.00	21.64	21.32	21.39
LTE-FDD Band 26b				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26815	26915	27015
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	23.50	23.19	22.77	23.09
			13	23.50	22.94	22.75	23.24
			24	23.50	22.76	22.55	23.25
		12	0	22.50	22.03	21.59	22.16
			6	22.50	22.00	21.55	22.15
			13	22.50	21.82	21.58	22.24
		25	0	22.50	21.94	21.59	22.19
	16QAM	1	0	22.50	22.17	21.97	22.09
			13	22.50	21.90	21.84	22.23
			24	22.50	21.79	21.81	22.27
		12	0	21.50	20.98	20.67	21.14
			6	21.50	20.98	20.60	21.14
			13	21.50	20.83	20.59	21.22
		25	0	21.50	20.91	20.53	21.25

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LTE-FDD Band 26a				Maximum Tune-up(dBm)	Conducted Power(dBm)
Bandwidth	Modulation	RB allocation	RB offset		26740
					819.0MHz
10MHz	QPSK	1	0	24.00	23.55
			25	23.50	23.39
			49	23.50	23.47
		25	0	23.00	22.53
			13	22.50	22.49
			25	22.50	22.33
		50	0	22.50	22.41
	16QAM	1	0	23.00	22.83
			25	23.00	22.64
			49	23.00	22.64
		25	0	22.00	21.57
			13	22.00	21.57
			25	21.50	21.32
		50	0	21.50	21.37

LTE-FDD Band 26b				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26840	26915	26990
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	23.50	23.26	22.97	23.01
			25	23.00	22.56	22.47	22.99
			49	23.50	22.72	22.87	23.38
		25	0	22.00	21.93	21.68	21.96
			13	22.00	21.93	21.69	21.97
			25	22.50	21.56	21.70	22.14
		50	0	22.50	21.71	21.71	22.12
	16QAM	1	0	23.00	22.51	22.20	22.14
			25	22.50	21.83	21.71	22.14
			49	23.00	21.92	22.06	22.53
		25	0	21.50	20.91	20.78	21.01
			13	21.00	20.89	20.77	20.98
			25	21.50	20.55	20.69	21.19
		50	0	21.50	20.75	20.69	21.12

LTE-FDD Band 26c				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26765	26865	26965
					821.5MHz	831.5MHz	841.5MHz
15MHz	QPSK	1	0	23.50	23.49	23.19	23.06
			38	23.00	22.61	22.65	22.85
			74	**24.00**	22.83	23.16	**23.53**
		36	0	22.50	21.75	21.90	**22.08**
			18	22.50	21.75	21.87	22.06
			39	22.50	21.88	21.83	22.08
		75	0	22.50	21.89	21.86	22.08
	16QAM	1	0	23.00	22.65	22.49	22.23
			38	22.50	21.85	21.94	22.00
			74	23.00	22.03	22.57	22.76
		36	0	22.50	21.77	21.87	22.06
			18	22.50	21.84	21.83	22.08
			39	22.50	21.91	21.85	22.08
		75	0	21.50	20.92	20.79	21.08

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Band 41

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		39675	40620	41565
					2498.5MHz	2593.0MHz	2687.5MHz
5MHz	QPSK	1	0	22.00	21.94	21.61	20.80
			13	22.00	21.60	21.72	20.84
			24	22.00	21.49	21.72	20.99
		12	0	21.00	20.82	20.66	19.79
			6	21.00	20.81	20.66	19.75
			13	21.00	20.66	20.64	19.92
		25	0	21.00	20.72	20.64	19.86
	16QAM	1	0	21.50	21.37	20.78	20.21
			13	21.50	21.11	20.86	20.25
			24	21.00	20.89	20.85	20.30
		12	0	20.00	19.93	19.67	18.74
			6	20.00	19.90	19.66	18.74
			13	20.00	19.68	19.68	18.91
		25	0	20.00	19.71	19.64	18.90
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	39700	40620	41540
					2501.0MHz	2593.0MHz	2685.0MHz
10MHz	QPSK	1	0	22.50	22.11	21.63	20.79
			25	22.00	21.52	21.66	20.70
			49	22.00	21.44	21.90	21.03
		25	0	21.00	20.70	20.53	19.61
			13	21.00	20.70	20.50	19.63
			25	21.00	20.35	20.75	19.90
		50	0	21.00	20.56	20.68	19.71
	16QAM	1	0	21.50	21.46	20.49	20.19
			25	21.00	20.87	20.46	20.01
			49	21.00	20.76	20.73	20.53
		25	0	20.00	19.76	19.56	18.71
			13	20.00	19.78	19.58	18.72
			25	20.00	19.39	19.70	18.98
		50	0	20.00	19.52	19.69	18.66

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		39725	40620	41515
					2503.5MHz	2593.0MHz	2682.5MHz
15MHz	QPSK	1	0	22.00	21.84	21.43	20.83
			38	22.00	20.87	21.62	20.59
			74	22.00	20.87	21.70	21.03
		36	0	21.00	20.13	20.57	19.76
			18	21.00	20.13	20.57	19.78
			39	21.00	20.13	20.56	19.79
		75	0	21.00	20.12	20.56	19.79
	16QAM	1	0	21.50	21.19	20.49	20.04
			38	21.00	20.49	20.66	20.06
			74	21.00	20.40	20.67	20.56
		36	0	21.00	20.12	20.57	19.78
			18	21.00	20.13	20.56	19.79
			39	21.00	20.13	20.56	19.79
		75	0	20.00	19.22	19.53	18.76

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	39750	40620	41490
					2506.0MHz	2593.0MHz	2680.0MHz
20MHz	QPSK	1	0	21.50	21.47	21.02	20.83
			50	**22.00**	20.81	**21.71**	20.72
			99	21.50	21.03	21.45	20.95
		50	0	20.50	20.35	20.39	19.70
			25	20.50	20.32	20.39	19.73
			50	21.00	19.90	**20.59**	19.85
		100	0	21.00	20.02	20.51	19.73
	16QAM	1	0	21.00	20.65	19.48	19.91
			50	20.50	20.04	20.11	19.90
			99	20.50	20.20	20.02	20.28
		50	0	19.50	19.33	19.43	18.79
			25	19.50	19.33	19.41	18.77
			50	20.00	18.92	19.65	18.79
		100	0	20.00	19.06	19.51	18.74

Band 66

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		131979	132322	132665
					1710.7MHz	1745.0MHz	1779.3MHz
1.4MHz	QPSK	1	0	24.50	24.20	23.00	23.06
			2	24.50	24.05	22.95	23.07
			5	24.50	24.05	22.83	23.10
		3	0	24.00	23.97	23.04	23.12
			2	24.00	23.96	22.92	23.11
			3	24.00	23.97	22.93	23.08
		6	0	23.00	22.95	21.99	22.06
	16QAM	1	0	23.00	22.96	22.06	22.22
			2	23.50	23.17	22.07	22.30
			5	23.50	23.18	21.93	22.14
		3	0	23.50	23.20	22.11	22.00
			2	23.50	23.30	21.95	22.17
			3	23.50	23.04	21.86	22.08
		6	0	22.00	21.89	20.96	21.12
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131987	132322	132657
					1711.5MHz	1745.0MHz	1778.5MHz
3MHz	QPSK	1	0	24.00	23.86	22.93	23.11
			7	24.00	23.75	22.84	23.12
			14	24.00	23.75	22.69	23.05
		8	0	23.50	23.01	22.07	22.20
			4	23.50	23.08	22.11	22.21
			7	23.00	22.97	21.97	22.11
		15	0	23.50	23.11	22.09	22.20
	16QAM	1	0	23.50	23.11	22.16	22.41
			7	23.50	23.05	22.03	22.29
			14	23.00	22.97	21.89	22.19
		8	0	22.50	22.22	21.09	21.22
			4	22.50	22.06	21.17	21.22
			7	22.00	21.97	21.02	21.13
		15	0	22.50	22.23	21.13	21.23

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131997	132322	132647
					1712.5MHz	1745.0MHz	1777.5MHz
5MHz	QPSK	1	0	24.50	24.17	23.22	23.48
			13	24.00	23.81	23.09	23.23
			24	24.00	23.98	22.81	23.14
		12	0	23.50	23.16	22.18	22.25
			6	23.50	23.15	22.23	22.33
			13	23.00	22.86	21.96	22.16
		25	0	23.50	23.04	22.12	22.22
	16QAM	1	0	23.50	23.18	22.18	22.47
			13	23.00	22.92	21.95	22.27
			24	23.00	22.92	21.86	22.19
		12	0	22.00	21.99	21.17	21.27
			6	22.50	22.22	21.20	21.27
			13	22.00	21.85	20.93	21.14
		25	0	22.50	22.02	21.07	21.21
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132022	132322	132622
					1715.0MHz	1745.0MHz	1775.0MHz
10MHz	QPSK	1	0	23.50	23.23	22.58	22.50
			25	24.00	23.58	22.89	23.04
			49	24.00	23.95	23.19	23.47
		25	0	23.00	22.77	22.07	22.17
			13	23.00	22.78	22.08	22.12
			25	23.00	22.68	21.97	22.32
		50	0	23.00	22.85	22.11	22.18
	16QAM	1	0	22.50	22.46	21.73	21.73
			25	23.00	22.77	22.04	22.24
			49	23.50	23.34	22.30	22.73
		25	0	22.00	21.77	21.05	21.11
			13	22.00	21.74	21.04	21.12
			25	22.00	21.68	20.97	21.31
		50	0	22.00	21.81	21.11	21.14

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		132047	132322	132597
					1717.5MHz	1745.0MHz	1772.5MHz
15MHz	QPSK	1	0	24.00	23.82	23.30	23.08
			38	23.50	23.39	22.67	22.96
			74	24.00	23.53	22.54	23.04
		36	0	22.50	22.49	21.87	21.93
			18	22.50	22.48	21.90	21.91
			39	22.50	22.48	21.89	21.91
		75	0	22.50	22.48	21.92	21.91
	16QAM	1	0	23.50	23.22	22.51	22.27
			38	23.00	22.60	21.79	22.14
			74	23.00	22.83	21.71	22.25
		36	0	22.50	22.48	21.89	21.91
			18	22.50	22.48	21.87	21.91
			39	22.50	22.48	21.88	21.91
		75	0	21.50	21.39	20.86	20.82

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132072	132322	132572
					1720.0MHz	1745.0MHz	1770.0MHz
20MHz	QPSK	1	0	24.00	23.61	23.07	22.43
			50	24.00	23.52	22.89	23.04
			99	**24.00**	**23.79**	22.88	23.46
		50	0	22.50	22.48	22.01	21.68
			25	22.50	**22.49**	22.01	21.69
			50	22.50	22.32	21.66	21.92
		100	0	23.00	22.51	21.87	21.90
	16QAM	1	0	23.00	22.78	22.11	21.53
			50	23.00	22.55	22.10	22.05
			99	23.00	22.87	21.95	22.43
		50	0	21.50	21.44	20.98	20.63
			25	21.50	21.43	20.98	20.64
			50	21.50	21.34	20.67	20.97
		100	0	21.50	21.47	20.92	20.85

Band 71

LTE-FDD Band 71				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		133147	133297	133447
					665.5MHz	680.5MHz	695.5MHz
5MHz	QPSK	1	0	24.00	23.85	23.56	22.78
			13	24.50	24.26	23.33	22.82
			24	24.00	23.80	23.17	22.91
		12	0	23.00	22.97	22.35	21.67
			6	23.00	22.84	22.32	21.66
			13	23.00	22.86	22.08	21.80
		25	0	23.00	22.92	22.12	21.68
	16QAM	1	0	23.00	22.78	22.79	21.75
			13	23.50	23.04	22.46	21.79
			24	23.00	22.87	22.41	21.87
		12	0	22.00	21.95	21.44	20.71
			6	22.00	21.97	21.39	20.71
			13	22.00	21.95	21.15	20.80
		25	0	22.00	21.84	21.18	20.70
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133172	133297	133422
					668.0MHz	680.5MHz	693.0MHz
10MHz	QPSK	1	0	23.50	23.15	22.83	22.07
			25	24.50	24.16	23.15	22.11
			49	23.50	22.94	23.30	23.34
		25	0	23.50	23.13	22.32	21.60
			13	23.50	23.07	22.31	21.70
			25	23.50	23.18	22.24	21.89
		50	0	23.50	23.03	22.16	21.78
	16QAM	1	0	22.50	22.17	21.93	20.84
			25	23.50	23.18	22.19	21.71
			49	24.00	23.55	22.50	22.16
		25	0	22.00	21.97	21.31	20.55
			13	22.00	21.98	21.35	20.59
			25	22.50	22.11	21.24	20.95
		50	0	22.50	22.08	21.17	20.81

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133197	133297	133397
					670.5MHz	680.5MHz	690.5MHz
15MHz	QPSK	1	0	23.50	23.41	23.29	22.73
			38	24.00	23.66	22.95	21.69
			74	23.00	22.81	22.48	22.57
		36	0	23.50	23.10	22.56	22.02
			18	23.00	22.87	22.23	20.60
			39	22.00	21.82	21.80	21.43
		75	0	23.00	22.73	21.80	21.48
	16QAM	1	0	23.00	22.66	22.60	21.34
			38	23.00	22.92	22.22	21.46
			74	22.50	22.48	21.81	21.39
		36	0	23.00	22.46	22.57	21.33
			18	23.00	22.80	22.24	21.47
			39	22.50	22.43	21.78	21.45
		75	0	22.00	21.69	20.84	20.52
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133222	133322	133372
					673.0MHz	683.0MHz	688.0MHz
20MHz	QPSK	1	0	23.00	22.77	22.57	22.04
			50	**23.50**	**23.23**	22.88	22.52
			99	23.00	23.00	21.48	22.32
		50	0	22.50	**22.43**	21.84	21.40
			25	22.50	22.40	21.86	21.36
			50	22.50	22.17	21.68	21.41
		100	0	23.00	22.53	21.61	21.36
	16QAM	1	0	22.00	21.73	21.73	21.02
			50	23.00	22.93	22.01	21.61
			99	22.00	21.93	21.66	21.56
		50	0	21.50	21.34	20.86	20.39
			25	21.50	21.33	20.82	20.41
			50	21.50	21.21	20.64	20.49
		100	0	22.00	21.54	20.58	20.39

8.2 Wi-Fi

2.4G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4 (2.4~2.4835)	802.11b	1	2412	18.42	18.50	No
		6	2437	18.89	19.00	No
		11	2462	**19.06**	**19.50**	Yes
	802.11g	1	2412	17.08	17.50	No
		6	2437	17.69	18.00	No
		11	2462	18.00	18.50	No
	802.11n(HT20)	1	2412	16.96	17.00	No
		6	2437	16.55	17.00	No
		11	2462	16.78	17.00	No
	802.11n(HT40)	3	2422	15.07	16.00	No
		6	2437	15.53	16.00	No
		9	2452	15.40	16.00	No
Note: Per KDB 248227 Section 5.2.2 2.4 GHz 802.11g/n OFDM SAR Test Exclusion Requirements, SAR is not required for the following 2.4 GHz OFDM conditions as the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2W/kg.						

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5G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-1 (5.150~5.250)	802.11a	36	5180	13.98	14.00	No
		44	5220	14.08	14.50	No
		48	5240	13.84	14.00	No
	802.11n(HT20)	36	5180	13.80	14.00	No
		44	5220	13.94	14.00	No
		48	5240	13.66	14.00	No
	802.11ac(VHT20)	36	5180	13.84	14.00	No
		44	5220	14.03	14.50	No
		48	5240	13.80	14.00	No
	802.11n(HT40)	38	5190	**14.60**	**15.00**	Yes
		46	5230	14.33	14.50	No
	802.11ac(VHT40)	38	5190	14.51	15.00	No
		46	5230	14.34	14.50	No
	802.11ac(VHT80)	42	5210	14.38	14.50	No
Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-2a (5.250~5.350)	802.11a	52	5260	13.44	13.50	No
		56	5280	13.02	13.50	No
		64	5320	12.84	13.00	No
	802.11n(HT20)	52	5260	13.24	13.50	No
		56	5280	12.86	13.00	No
		64	5320	12.75	13.00	No
	802.11ac(VHT20)	52	5260	13.25	13.50	No
		56	5280	12.83	13.00	No
		64	5320	12.76	13.00	No
	802.11n(HT40)	54	5270	**13.64**	**14.00**	Yes
		62	5310	13.36	13.50	No
	802.11ac(VHT40)	54	5270	13.62	14.00	No
		62	5310	13.35	13.50	No
	802.11ac(VHT80)	58	5290	13.50	14.00	No
Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-2c (5.470~5.725)	802.11a	100	5500	14.36	14.50	No
		120	5600	14.78	15.00	No
		140	5700	13.91	14.00	No
	802.11n(HT20)	100	5500	14.13	14.50	No
		120	5600	14.58	15.00	No
		140	5700	13.73	14.00	No
	802.11ac(VHT20)	100	5500	14.28	14.50	No
		120	5600	14.74	15.00	No
		140	5700	13.89	14.00	No
	802.11n(HT40)	102	5510	14.94	15.00	No
		118	5590	14.89	15.00	No
		134	5670	14.89	15.00	No
	802.11ac(VHT40)	102	5510	**15.04**	**15.50**	Yes
		118	5590	14.93	15.00	No
		134	5670	14.97	15.00	No
	802.11ac(VHT80)	106	5530	14.89	15.00	No
		122	5610	14.66	15.00	No
Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-3 (5.725~5.850)	802.11a	149	5745	12.31	12.50	No
		157	5785	12.96	13.00	No
		165	5825	13.20	13.50	No
	802.11n(HT20)	149	5745	12.19	12.50	No
		157	5785	12.84	13.00	No
		165	5825	13.01	13.50	No
	802.11ac(VHT20)	149	5745	12.21	12.50	No
		157	5785	12.80	13.00	No
		165	5825	12.99	13.00	No
	802.11n(HT40)	151	5755	12.78	13.00	No
		159	5795	13.32	13.50	No
	802.11ac(VHT40)	151	5755	12.71	13.00	No
		159	5795	**13.41**	**13.50**	Yes
	802.11ac(VHT80)	155	5775	12.34	12.50	No

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8.3 Bluetooth

EDR	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
			0	39	78
			2402MHz	2441MHz	2480MHz
	GFSK	9.50	9.04	8.65	8.09
	π/4QPSK	9.00	8.82	8.47	8.80
	8DPSK	**9.50**	**9.20**	8.86	9.12
BLE	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
			0	20	39
			2402MHz	2440MHz	2480MHz
	1Mbps	1.00	-0.54	-0.29	0.63

Channel	Frequency (GHz)	Max. Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Exclusion thresholds for 1-g SAR(mW)	RF exposure evaluation required
0	2.402	9.50	8.91	5	19	No

Note

1. Per KDB 447498 D01 General RF Exposure Guidance v06, the 1-g SAR test exclusion thresholds for 300 MHz to 6 GHz at *test separation distances* ≤ 40 cm are determined by:

MHz	5	10	15	20	25	mm
150	39	77	116	155	194	*SAR Test Exclusion Threshold* (mW)
300	27	55	82	110	137	
450	22	45	67	89	112	
835	16	33	49	66	82	
900	16	32	47	63	79	
1500	12	24	37	49	61	
1900	11	22	33	44	54	
2450	10	19	29	38	48	
3600	8	16	24	32	40	
5200	7	13	20	26	33	
5400	6	13	19	26	32	
5800	6	12	19	25	31	

*When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine estimated SAR.

2. Per KDB 248227 D01 v02r02, choose the highest output power channel to test SAR and determine further SAR exclusion.
3. The output power of all data rate were prescan, just the worst case (the lowest data rate) of all mode were shown in report.

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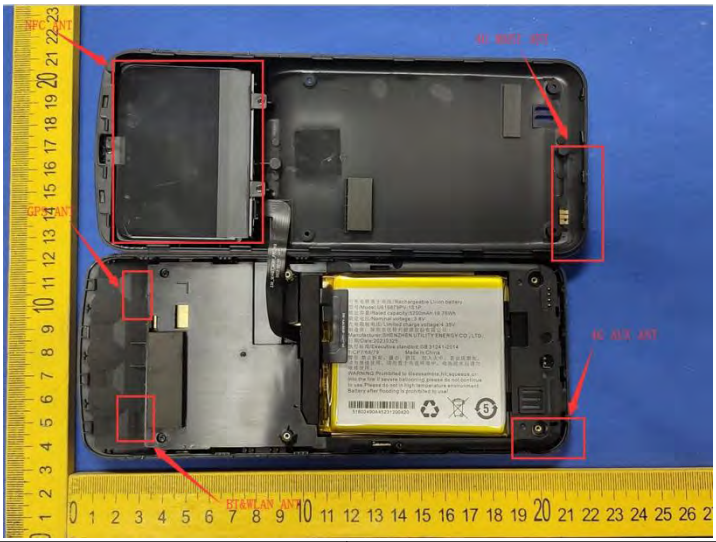
9. Test Exclusion Consideration

Antenna information:



WWAN Main Antenna	LTE TX/RX
WLAN/BT Antenna	WLAN/BT TX/RX

Note:
1. KDB 447498 D01v06, particular DUT edges were not required to be evaluated for SAR if the antenna-to-edge distance is greater than 2.5cm.
2. Per KDB648474 D04,10-g extremity SAR is not required when Body-Worn mode 1-g reported SAR<1.2W/Kg.

Distance of The Antenna to the EUT surface and edge (mm)						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	<25	<25	<25	69	188	<25
BT/Wifi	<25	<25	68	<25	<25	175
Positions for SAR tests: Hotspot mode						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	Yes	Yes	Yes	No	No	Yes
BT/Wifi	Yes	Yes	No	Yes	Yes	No

9.1 SAR Test Exclusion Consideration Table

Per KDB 447498 requires when the standalone SAR test exclusion of section 4.3.1 is applied to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to the following format to determine simultaneous transmission SAR test exclusion:

(max.power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz) / x] W/kg for test separation distances ≤ 50 mm;
where x = 7.5 for 1-g SAR, and x= 18.75 for 10-g SAR.
0.4 W/Kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distances is > 50 mm

Mode	Channel	Frequency (GHz)	Max tune-up power (dBm)	Max. Power (mW)	Exposure Position	Head	Body-worn
					Test Dist.(mm)	5	10
BT	0	2.402	9.50	8.91	Estimated SAR(W/kg)	/	0.104

10. Test Result

LTE

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Front	19100	1900.0	-0.778	0.425	100.00	1.000	22.70	23.00	1.072	0.456	/
		Back	19100	1900.0	1.523	0.474	100.00	1.000	22.70	23.00	1.072	0.508	/
		Left	19100	1900.0	2.218	0.128	100.00	1.000	22.70	23.00	1.072	0.137	/
		Bottom	19100	1900.0	0.870	0.680	100.00	1.000	22.70	23.00	1.072	**0.729**	1#
	50%RB	Front	19100	1900.0	-2.323	0.350	100.00	1.000	21.71	22.00	1.069	0.374	/
		Back	19100	1900.0	0.354	0.402	100.00	1.000	21.71	22.00	1.069	0.430	/
		Left	19100	1900.0	1.249	0.104	100.00	1.000	21.71	22.00	1.069	0.111	/
		Bottom	19100	1900.0	-2.688	0.501	100.00	1.000	21.71	22.00	1.069	0.536	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Front	20050	1720.0	3.539	0.486	100.00	1.000	23.17	23.50	1.079	0.524	/
		Back	20050	1720.0	-0.840	0.682	100.00	1.000	23.17	23.50	1.079	0.736	/
		Left	20050	1720.0	0.152	0.553	100.00	1.000	23.17	23.50	1.079	0.597	/
		Bottom	20050	1720.0	-0.760	1.061	100.00	1.000	23.17	23.50	1.079	**1.145**	2#
		Bottom-repeated	20050	1720.0	-0.250	1.058	100.00	1.000	23.17	23.50	1.079	1.142	/
		Bottom	20175	1732.5	1.200	0.985	100.00	1.000	22.94	23.00	1.014	0.999	/
		Bottom	20300	1745.0	2.050	0.977	100.00	1.000	22.52	23.00	1.117	1.091	/
	50%RB	Front	20050	1720.0	-1.994	0.300	100.00	1.000	22.22	22.50	1.067	0.320	/
		Back	20050	1720.0	4.671	0.518	100.00	1.000	22.22	22.50	1.067	0.553	/
		Left	20050	1720.0	2.566	0.405	100.00	1.000	22.22	22.50	1.067	0.432	/
		Bottom	20050	1720.0	1.629	0.740	100.00	1.000	22.22	22.50	1.067	0.790	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Front	20450	829.0	2.539	0.431	100.00	1.000	23.22	23.50	1.067	0.460	/
		Back	20450	829.0	-2.840	0.472	100.00	1.000	23.22	23.50	1.067	0.504	/
		Left	20450	829.0	-3.572	0.122	100.00	1.000	23.22	23.50	1.067	0.130	/
		Bottom	20450	829.0	3.250	0.609	100.00	1.000	23.22	23.50	1.067	**0.650**	3#
	50%RB	Front	20450	829.0	3.994	0.130	100.00	1.000	21.90	22.00	1.023	0.133	/
		Back	20450	829.0	-0.671	0.136	100.00	1.000	21.90	22.00	1.023	0.139	/
		Left	20450	829.0	0.262	0.063	100.00	1.000	21.90	22.00	1.023	0.064	/
		Bottom	20450	829.0	3.629	0.128	100.00	1.000	21.90	22.00	1.023	0.131	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Front	21100	2535	2.539	0.630	100.00	1.000	21.79	22.00	1.050	0.662	/
		Back	21100	2535	-2.840	0.670	100.00	1.000	21.79	22.00	1.050	0.704	/
		Left	21100	2535	-3.572	0.300	100.00	1.000	21.79	22.00	1.050	0.315	/
		Bottom	20850	2510	2.005	0.850	100.00	1.000	21.01	21.50	1.119	**0.951**	4#
		Bottom	21100	2535	0.670	0.871	100.00	1.000	21.79	22.00	1.050	0.915	/
		Bottom-repeated	21100	2535	-1.050	0.866	100.00	1.000	21.79	22.00	1.050	0.909	/
		Bottom	21350	2560	1.120	0.848	100.00	1.000	20.90	21.00	1.023	0.868	/
	50%RB	Front	21100	2535	3.994	0.530	100.00	1.000	20.70	21.00	1.072	0.568	/
		Back	21100	2535	-0.671	0.536	100.00	1.000	20.70	21.00	1.072	0.575	/
		Left	21100	2535	0.262	0.463	100.00	1.000	20.70	21.00	1.072	0.496	/
		Bottom	21100	2535	3.629	0.728	100.00	1.000	20.70	21.00	1.072	0.780	/

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Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 12 (BW: 10MHz)	1RB	Front	23095	707.5	0.153	0.230	100.00	1.000	23.92	24.00	1.019	0.234	/
		Back	23095	707.5	2.910	0.234	100.00	1.000	23.92	24.00	1.019	0.238	/
		Left	23095	707.5	-0.147	0.180	100.00	1.000	23.92	24.00	1.019	0.183	/
		Bottom	23095	707.5	-3.060	0.378	100.00	1.000	23.92	24.00	1.019	**0.385**	5#
	50%RB	Front	23095	707.5	0.738	0.110	100.00	1.000	22.75	23.00	1.059	0.116	/
		Back	23095	707.5	-2.629	0.115	100.00	1.000	22.75	23.00	1.059	0.122	/
		Left	23095	707.5	-0.414	0.065	100.00	1.000	22.75	23.00	1.059	0.069	/
		Bottom	23095	707.5	3.470	0.240	100.00	1.000	22.75	23.00	1.059	0.254	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 13 (BW: 10MHz)	1RB	Front	23230	782.0	3.154	0.120	100.00	1.000	23.57	24.00	1.104	0.132	/
		Back	23230	782.0	-2.460	0.127	100.00	1.000	23.57	24.00	1.104	0.140	/
		Left	23230	782.0	0.322	0.095	100.00	1.000	23.57	24.00	1.104	0.105	/
		Bottom	23230	782.0	2.200	0.152	100.00	1.000	23.57	24.00	1.104	**0.168**	6#
	50%RB	Front	23230	782.0	-2.520	0.080	100.00	1.000	22.40	22.50	1.023	0.082	/
		Back	23230	782.0	0.508	0.085	100.00	1.000	22.40	22.50	1.023	0.087	/
		Left	23230	782.0	-0.312	0.089	100.00	1.000	22.40	22.50	1.023	0.091	/
		Bottom	23230	782.0	4.118	0.111	100.00	1.000	22.40	22.50	1.023	0.114	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 14 (BW: 10MHz)	1RB	Front	23330	793.0	3.154	0.100	100.00	1.000	23.09	23.50	1.099	0.110	/
		Back	23330	793.0	-2.460	0.105	100.00	1.000	23.09	23.50	1.099	0.115	/
		Left	23330	793.0	0.322	0.088	100.00	1.000	23.09	23.50	1.099	0.097	/
		Bottom	23330	793.0	-3.440	0.120	100.00	1.000	23.09	23.50	1.099	**0.132**	7#
	50%RB	Front	23330	793.0	-2.520	0.070	100.00	1.000	21.78	22.00	1.052	0.074	/
		Back	23330	793.0	0.508	0.075	100.00	1.000	21.78	22.00	1.052	0.079	/
		Left	23330	793.0	-0.312	0.080	100.00	1.000	21.78	22.00	1.052	0.084	/
		Bottom	23330	793.0	4.118	0.100	100.00	1.000	21.78	22.00	1.052	0.105	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 17 (BW: 10MHz)	1RB	Front	23790	710.0	3.002	0.260	100.00	1.000	23.71	24.00	1.069	0.278	/
		Back	23790	710.0	-3.650	0.266	100.00	1.000	23.71	24.00	1.069	0.284	/
		Left	23790	710.0	0.107	0.192	100.00	1.000	23.71	24.00	1.069	0.205	/
		Bottom	23790	710.0	-3.210	0.398	100.00	1.000	23.71	24.00	1.069	**0.425**	8#
	50%RB	Front	23790	710.0	2.520	0.123	100.00	1.000	22.71	23.00	1.069	0.131	/
		Back	23790	710.0	-1.508	0.126	100.00	1.000	22.71	23.00	1.069	0.135	/
		Left	23790	710.0	-0.312	0.105	100.00	1.000	22.71	23.00	1.069	0.112	/
		Bottom	23790	710.0	0.118	0.208	100.00	1.000	22.71	23.00	1.069	0.222	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 25 (BW: 20MHz)	1RB	Front	26590	1905.0	3.015	0.438	100.00	1.000	23.01	23.50	1.119	0.490	/
		Back	26590	1905.0	2.855	0.409	100.00	1.000	23.01	23.50	1.119	0.458	/
		Left	26590	1905.0	-1.045	0.212	100.00	1.000	23.01	23.50	1.119	0.237	/
		Bottom	26140	1860.0	2.150	0.695	100.00	1.000	22.37	22.50	1.030	0.716	/
		Bottom	26365	1882.5	-0.500	0.700	100.00	1.000	22.68	23.00	1.076	0.753	/
		Bottom	26590	1905.0	1.320	0.718	100.00	1.000	23.01	23.50	1.119	**0.803**	9#

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	50%RB	Front	26590	1905.0	0.018	0.392	100.00	1.000	22.13	22.50	1.089	0.427	/
		Back	26590	1905.0	2.273	0.366	100.00	1.000	22.13	22.50	1.089	0.399	/
		Left	26590	1905.0	-1.527	0.175	100.00	1.000	22.13	22.50	1.089	0.191	/
		Bottom	26590	1905.0	2.810	0.555	100.00	1.000	22.13	22.50	1.089	0.604	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 (BW: 15MHz)	1RB	Front	26965	841.5	1.290	0.196	100.00	1.000	23.53	24.00	1.114	0.218	/
		Back	26965	841.5	-4.550	0.201	100.00	1.000	23.53	24.00	1.114	0.224	/
		Left	26965	841.5	2.350	0.160	100.00	1.000	23.53	24.00	1.114	0.178	/
		Bottom	26965	841.5	-1.640	0.346	100.00	1.000	23.53	24.00	1.114	**0.385**	10#
	50%RB	Front	26965	841.5	0.223	0.111	100.00	1.000	22.08	22.50	1.102	0.122	/
		Back	26965	841.5	2.478	0.118	100.00	1.000	22.08	22.50	1.102	0.130	/
		Left	26965	841.5	-1.322	0.066	100.00	1.000	22.08	22.50	1.102	0.073	/
		Bottom	26965	841.5	3.020	0.239	100.00	1.000	22.08	22.50	1.102	0.263	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Front	40620	2593.0	2.500	0.262	100.00	1.000	21.71	22.00	1.069	0.280	/
		Back	40620	2593.0	1.760	0.266	100.00	1.000	21.71	22.00	1.069	0.284	/
		Left	40620	2593.0	1.500	0.118	100.00	1.000	21.71	22.00	1.069	0.126	/
		Bottom	40620	2593.0	0.680	0.404	100.00	1.000	21.71	22.00	1.069	**0.432**	11#
	50%RB	Front	40620	2593.0	1.200	0.100	100.00	1.000	20.59	21.00	1.099	0.220	/
		Back	40620	2593.0	3.760	0.105	100.00	1.000	20.59	21.00	1.099	0.247	/
		Left	40620	2593.0	-3.500	0.106	100.00	1.000	20.59	21.00	1.099	0.182	/
		Bottom	40620	2593.0	2.660	0.250	100.00	1.000	20.59	21.00	1.099	0.275	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 66 (BW: 20MHz)	1RB	Front	132072	1720.0	1.205	0.750	100.00	1.000	23.79	24.00	1.050	0.788	/
		Back	132072	1720.0	2.770	0.758	100.00	1.000	23.79	24.00	1.050	0.796	/
		Left	132072	1720.0	3.025	0.403	100.00	1.000	23.79	24.00	1.050	0.423	/
		Bottom	132072	1720.0	0.200	1.188	100.00	1.000	23.79	24.00	1.050	**1.247**	12#
		Bottom-repeated	132072	1720.0	-1.050	1.184	100.00	1.000	23.79	24.00	1.050	1.243	/
		Bottom	132322	1745.0	3.400	1.106	100.00	1.000	22.88	23.00	1.028	1.137	/
		Bottom	132572	1770.0	3.055	1.115	100.00	1.000	23.46	23.50	1.009	1.125	/
	50%RB	Front	132072	1720.0	2.005	0.612	100.00	1.000	22.49	22.50	1.002	0.613	/
		Back	132072	1720.0	0.278	0.620	100.00	1.000	22.49	22.50	1.002	0.621	/
		Left	132072	1720.0	-3.018	0.308	100.00	1.000	22.49	22.50	1.002	0.309	/
		Bottom	132072	1720.0	-2.142	0.789	100.00	1.000	22.49	22.50	1.002	0.791	/

Body(hotspot open, 0mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 71 (BW: 20MHz)	1RB	Front	133222	673.0	1.205	0.132	100.00	1.000	23.23	23.50	1.064	0.140	/
		Back	133222	673.0	2.770	0.136	100.00	1.000	23.23	23.50	1.064	0.145	/
		Left	133222	673.0	3.025	0.099	100.00	1.000	23.23	23.50	1.064	0.105	/
		Bottom	133222	673.0	-2.160	0.163	100.00	1.000	23.23	23.50	1.064	**0.173**	13#
	50%RB	Front	133222	673.0	2.005	0.082	100.00	1.000	22.43	22.50	1.016	0.083	/
		Back	133222	673.0	0.278	0.088	100.00	1.000	22.43	22.50	1.016	0.089	/
		Left	133222	673.0	-3.018	0.062	100.00	1.000	22.43	22.50	1.016	0.063	/
		Bottom	133222	673.0	-2.142	0.111	100.00	1.000	22.43	22.50	1.016	0.113	/

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Wifi

Body(hotspot open, 0mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4b (2.4~2.4835)	Front	11	2462	1.700	0.189	100.00	1.000	19.06	19.50	1.107	**0.209**	14#
	Back	11	2462	-0.800	0.071	100.00	1.000	19.06	19.50	1.107	0.079	/
	Right	11	2462	-1.970	0.072	100.00	1.000	19.06	19.50	1.107	0.080	/
	Top	11	2462	3.080	0.050	100.00	1.000	19.06	19.50	1.107	0.055	/

Body(hotspot open, 0mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11n(HT40)	Front	38	5190	-2.240	0.461	100.00	1.000	14.60	15.00	1.096	**0.505**	15#
	Back	38	5190	-1.180	0.225	100.00	1.000	14.60	15.00	1.096	0.247	/
	Right	38	5190	1.340	0.230	100.00	1.000	14.60	15.00	1.096	0.252	/
	Top	38	5190	2.100	0.182	100.00	1.000	14.60	15.00	1.096	0.199	/

Body(hotspot open, 0mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-2a (5.250~5.350) 802.11n(HT40)	Front	54	5270	1.680	0.289	100.00	1.000	13.64	14.00	1.086	**0.314**	16#
	Back	54	5270	-1.300	0.141	100.00	1.000	13.64	14.00	1.086	0.153	/
	Right	54	5270	-0.835	0.145	100.00	1.000	13.64	14.00	1.086	0.157	/
	Top	54	5270	0.045	0.101	100.00	1.000	13.64	14.00	1.086	0.110	/

Body(hotspot open, 0mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-2c (5.470~5.725) 802.11ac(VHT40)	Front	102	5510	-0.350	0.330	100.00	1.000	15.04	15.50	1.112	**0.367**	17#
	Back	102	5510	-1.300	0.162	100.00	1.000	15.04	15.50	1.112	0.180	/
	Right	102	5510	-0.835	0.166	100.00	1.000	15.04	15.50	1.112	0.185	/
	Top	102	5510	0.045	0.135	100.00	1.000	15.04	15.50	1.112	0.150	/

Body(hotspot open, 0mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11ac(VHT40)	Front	159	5795	-1.000	0.297	100.00	1.000	13.41	13.50	1.021	**0.303**	18#
	Back	159	5795	-0.070	0.152	100.00	1.000	13.41	13.50	1.021	0.155	/
	Right	159	5795	3.052	0.158	100.00	1.000	13.41	13.50	1.021	0.161	/
	Top	159	5795	4.110	0.116	100.00	1.000	13.41	13.50	1.021	0.118	/

Note:

1. The maximum SAR Value of each test band is marked bold.
2. SAR plot is provided only for the highest measured SAR in each exposure configuration, wireless mode and frequency band combination.
3. Per KDB 447498 D01 v06, for each exposure position, if the highest output power channel Reported SAR ≤ 0.8W/kg, other channels SAR testing is not necessary.
4. Per KDB 447498 D01 v06, head/body-worn use is evaluated with the device positioned at 0mm/0 mm from a head/flat phantom respectively filled with head tissue-equivalent medium.
5. Per KDB Publication 941225 D06 where SAR test considerations for handsets (L x W ≥ 9 cm x 5 cm) are based on a composite test separation distance of 0 mm from the front, back and edges of the device with antennas 2.5 cm or closer to the edge of the device, determined from general mixed use conditions for this type of devices. Since the hotspot SAR results may overlap with the body-worn accessory SAR requirements, the more conservative configurations can be considered, thus excluding some body-worn accessory SAR tests.
6. Per KDB 447498 D01 v06, the report SAR is measured SAR value adjusted for maximum tune-up tolerance. Scaling Factor=10^[(tune-up limit power(dBm) - Ave.power power (dBm))/10], where tune-up limit is the maximum rated power among all production units.
   Reported SAR(W/kg)=Measured SAR (W/kg)*Scaling Factor.

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11. SAR Measurement Variability

According to KDB 865664 D01, SAR measurement variability was assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. Alternatively, if the highest measured SAR for both head and body tissue-equivalent media are ≤ 1.45 W/kg and the ratio of these highest SAR values, i.e., largest divided by smallest value, is ≤ 1.10, the highest SAR configuration for either head or body tissue-equivalent medium may be used to perform the repeated measurement. These additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR repeated measurement procedure:

1. When the highest measured SAR is < 0.80 W/kg, repeated measurement is not required.
2. When the highest measured SAR is >= 0.80 W/kg, repeat that measurement once.
3. If the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20, or when the original or repeated measurement is >= 1.45 W/kg, perform a second repeated measurement.
4. If the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20, and the original, first or second repeated measurement is >= 1.5 W/kg, perform a third repeated measurement.

Note: For 1g SAR, the highest measured 1g SAR is 1.188 > 0.80 W/kg, and repeated measurements are as below:

Band	Channel	Frequency	1st Meas. SAR (W/kg)	2nd Meas. SAR (W/kg)	the ratio of largest to smallest SAR for the original and first repeated measurements
LTE Band 4	20050	1720.0	1.061	1.058	1.003
LTE Band 7	21100	2535.0	0.871	0.866	1.006
LTE Band 66	132072	1720.0	1.188	1.184	1.003
Note: According to the above ratio, we don't need to repeat a second repeated measurement.					

12. Simultaneous Transmission

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. When the sum of SAR 1g of all simultaneously transmitting antennas in an operating mode and exposure condition combination is within the SAR limit (SAR 1g 1.6 W/kg), the simultaneous transmission SAR is not required. When the sum of SAR 1g is greater than the SAR limit (SAR 1g 1.6 W/kg), SAR test exclusion is determined by the SAR to Peak Location Ratio (SPLSR).

12.1 Simultaneous Transmission Mode Considerations

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. The device has 2 Tx antennas, WWAN main antenna, Wifi/BT antenna supports 2.4G/5G Wi-Fi and BT. The 2 antennas can always transmit simultaneously. The work mode combination is showed as below table.

Application Simultaneous Transmission information:

NO.	Configuration	Body-worn
1	WWAN+WIFI(2.4g)	Yes
2	WWAN+WIFI(5g)	Yes
3	WWAN+BT	Yes

12.2 Sum SAR of Simultaneous Transmission

Hotspot(body-worn)

Band	Test Position	RB allocation	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE Band 2 QPSK (20MHz)	Front	1RB	0.456	**0.209**	**0.505**	0.104	0.665	0.961	0.560	N/A	N/A
	Back		0.508	0.079	0.247	0.104	0.587	0.755	0.612	N/A	N/A
	Left		0.137	/	/	/	0.137	0.137	0.137	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.729**	/	/	/	0.729	0.729	0.729	N/A	N/A
	Front	50%RB	0.374	**0.209**	**0.505**	0.104	0.583	0.879	0.478	N/A	N/A
	Back		0.430	0.079	0.247	0.104	0.509	0.677	0.534	N/A	N/A
	Left		0.111	/	/	/	0.111	0.111	0.111	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.536	/	/	/	0.536	0.536	0.536	N/A	N/A
LTE Band 4 QPSK (20MHz)	Front	1RB	0.524	**0.209**	**0.505**	0.104	0.733	1.029	0.628	N/A	N/A
	Back		0.736	0.079	0.247	0.104	0.815	0.983	0.840	N/A	N/A
	Left		0.597	/	/	/	0.597	0.597	0.597	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**1.145**	/	/	/	1.145	1.145	1.145	N/A	N/A
	Front	50%RB	0.320	**0.209**	**0.505**	0.104	0.529	0.825	0.424	N/A	N/A
	Back		0.553	0.079	0.247	0.104	0.632	0.800	0.657	N/A	N/A
	Left		0.432	/	/	/	0.432	0.432	0.432	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.790	/	/	/	0.790	0.790	0.790	N/A	N/A
LTE Band 5 QPSK (10MHz)	Front	1RB	0.460	**0.209**	**0.505**	0.104	0.669	0.965	0.564	N/A	N/A
	Back		0.504	0.079	0.247	0.104	0.583	0.751	0.608	N/A	N/A
	Left		0.130	/	/	/	0.130	0.130	0.130	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.650**	/	/	/	0.650	0.650	0.650	N/A	N/A
	Front	50%RB	0.133	**0.209**	**0.505**	0.104	0.342	0.638	0.237	N/A	N/A
	Back		0.139	0.079	0.247	0.104	0.218	0.386	0.243	N/A	N/A
	Left		0.064	/	/	/	0.064	0.064	0.064	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.131	/	/	/	0.131	0.131	0.131	N/A	N/A

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Band	Test Position	RB allocation	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE Band 7 QPSK (10MHz)	Front	1RB	0.662	**0.209**	**0.505**	0.104	0.871	1.167	0.766	N/A	N/A
	Back		0.704	0.079	0.247	0.104	0.783	0.951	0.808	N/A	N/A
	Left		0.315	/	/	/	0.315	0.315	0.315	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.951**	/	/	/	0.951	0.951	0.951	N/A	N/A
	Front	50%RB	0.568	**0.209**	**0.505**	0.104	0.777	1.073	0.672	N/A	N/A
	Back		0.575	0.079	0.247	0.104	0.654	0.822	0.679	N/A	N/A
	Left		0.496	/	/	/	0.496	0.496	0.496	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.780	/	/	/	0.780	0.780	0.780	N/A	N/A
LTE Band 12 QPSK (10MHz)	Front	1RB	0.234	**0.209**	**0.505**	0.104	0.443	0.739	0.338	N/A	N/A
	Back		0.238	0.079	0.247	0.104	0.317	0.485	0.342	N/A	N/A
	Left		0.183	/	/	/	0.183	0.183	0.183	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.385**	/	/	/	0.385	0.385	0.385	N/A	N/A
	Front	50%RB	0.116	**0.209**	**0.505**	0.104	0.325	0.621	0.220	N/A	N/A
	Back		0.122	0.079	0.247	0.104	0.201	0.369	0.226	N/A	N/A
	Left		0.069	/	/	/	0.069	0.069	0.069	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.254	/	/	/	0.254	0.254	0.254	N/A	N/A
LTE Band 13 QPSK (10MHz)	Front	1RB	0.132	**0.209**	**0.505**	0.104	0.341	0.637	0.236	N/A	N/A
	Back		0.140	0.079	0.247	0.104	0.219	0.387	0.244	N/A	N/A
	Left		0.105	/	/	/	0.105	0.105	0.105	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.168**	/	/	/	0.168	0.168	0.168	N/A	N/A
	Front	50%RB	0.082	**0.209**	**0.505**	0.104	0.291	0.587	0.186	N/A	N/A
	Back		0.087	0.079	0.247	0.104	0.166	0.334	0.191	N/A	N/A
	Left		0.091	/	/	/	0.091	0.091	0.091	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.114	/	/	/	0.114	0.114	0.114	N/A	N/A
LTE Band 14 QPSK (10MHz)	Front	1RB	0.110	**0.209**	**0.505**	0.104	0.319	0.615	0.214	N/A	N/A
	Back		0.115	0.079	0.247	0.104	0.194	0.362	0.219	N/A	N/A
	Left		0.097	/	/	/	0.097	0.097	0.097	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.132**	/	/	/	0.132	0.132	0.132	N/A	N/A
	Front	50%RB	0.074	**0.209**	**0.505**	0.104	0.283	0.579	0.178	N/A	N/A
	Back		0.079	0.079	0.247	0.104	0.158	0.326	0.183	N/A	N/A
	Left		0.084	/	/	/	0.084	0.084	0.084	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.105	/	/	/	0.105	0.105	0.105	N/A	N/A
LTE Band 17 QPSK (10MHz)	Front	1RB	0.278	**0.209**	**0.505**	0.104	0.487	0.783	0.382	N/A	N/A
	Back		0.284	0.079	0.247	0.104	0.363	0.531	0.388	N/A	N/A
	Left		0.205	/	/	/	0.205	0.205	0.205	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.425**	/	/	/	0.425	0.425	0.425	N/A	N/A
	Front	50%RB	0.131	**0.209**	**0.505**	0.104	0.340	0.636	0.235	N/A	N/A
	Back		0.135	0.079	0.247	0.104	0.214	0.382	0.239	N/A	N/A
	Left		0.112	/	/	/	0.112	0.112	0.112	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.222	/	/	/	0.222	0.222	0.222	N/A	N/A
LTE Band 25 QPSK (20MHz)	Front	1RB	0.490	**0.209**	**0.505**	0.104	0.699	0.995	0.594	N/A	N/A
	Back		0.458	0.079	0.247	0.104	0.537	0.705	0.562	N/A	N/A
	Left		0.237	/	/	/	0.237	0.237	0.237	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.803**	/	/	/	0.803	0.803	0.803	N/A	N/A
	Front	50%RB	0.427	**0.209**	**0.505**	0.104	0.636	0.932	0.531	N/A	N/A
	Back		0.399	0.079	0.247	0.104	0.478	0.646	0.503	N/A	N/A
	Left		0.191	/	/	/	0.191	0.191	0.191	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.604	/	/	/	0.604	0.604	0.604	N/A	N/A
LTE Band 26 QPSK (15MHz)	Front	1RB	0.218	**0.209**	**0.505**	0.104	0.427	0.723	0.322	N/A	N/A
	Back		0.224	0.079	0.247	0.104	0.303	0.471	0.328	N/A	N/A
	Left		0.178	/	/	/	0.178	0.178	0.178	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.385**	/	/	/	0.385	0.385	0.385	N/A	N/A
	Front	50%RB	0.122	**0.209**	**0.505**	0.104	0.331	0.627	0.226	N/A	N/A
	Back		0.130	0.079	0.247	0.104	0.209	0.377	0.234	N/A	N/A
	Left		0.073	/	/	/	0.073	0.073	0.073	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.263	/	/	/	0.263	0.263	0.263	N/A	N/A

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Band	Test Position	RB allocation	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE Band 41 QPSK (20MHz)	Front	1RB	0.280	**0.209**	**0.505**	0.104	0.489	0.785	0.384	N/A	N/A
	Back		0.284	0.079	0.247	0.104	0.363	0.531	0.388	N/A	N/A
	Left		0.126	/	/	/	0.126	0.126	0.126	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.432**	/	/	/	0.432	0.432	0.432	N/A	N/A
	Front	50%RB	0.220	**0.209**	**0.505**	0.104	0.429	0.725	0.324	N/A	N/A
	Back		0.247	0.079	0.247	0.104	0.326	0.494	0.351	N/A	N/A
	Left		0.182	/	/	/	0.182	0.182	0.182	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.275	/	/	/	0.275	0.275	0.275	N/A	N/A
LTE Band 66 QPSK (20MHz)	Front	1RB	0.788	**0.209**	**0.505**	0.104	0.997	**1.293**	0.892	N/A	N/A
	Back		0.796	0.079	0.247	0.104	0.875	1.043	0.900	N/A	N/A
	Left		0.423	/	/	/	0.423	0.423	0.423	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**1.247**	/	/	/	1.247	1.247	1.247	N/A	N/A
	Front	50%RB	0.613	**0.209**	**0.505**	0.104	0.822	1.118	0.717	N/A	N/A
	Back		0.621	0.079	0.247	0.104	0.700	0.868	0.725	N/A	N/A
	Left		0.309	/	/	/	0.309	0.309	0.309	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.791	/	/	/	0.791	0.791	0.791	N/A	N/A
LTE Band 71 QPSK (20MHz)	Front	1RB	0.140	**0.209**	**0.505**	0.104	0.349	0.645	0.244	N/A	N/A
	Back		0.145	0.079	0.247	0.104	0.224	0.392	0.249	N/A	N/A
	Left		0.105	/	/	/	0.105	0.105	0.105	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		**0.173**	/	/	/	0.173	0.173	0.173	N/A	N/A
	Front	50%RB	0.083	**0.209**	**0.505**	0.104	0.292	0.588	0.187	N/A	N/A
	Back		0.089	0.079	0.247	0.104	0.168	0.336	0.193	N/A	N/A
	Left		0.063	/	/	/	0.063	0.063	0.063	N/A	N/A
	Right		/	0.080	0.252	0.104	0.080	0.252	0.104	N/A	N/A
	Top		/	0.055	0.199	0.104	0.055	0.199	0.104	N/A	N/A
	Bottom		0.113	/	/	/	0.113	0.113	0.113	N/A	N/A

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13. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
E-Field Probe	MVG	SSE2	04/22 EPGO365	2023/02/06	2024/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2022/11/24	2023/11/23
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2022/11/24	2023/11/23
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2022/11/24	2023/11/23
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2023/03/24	2024/03/23
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2023/03/24	2024/03/23
10dB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2023/03/24	2024/03/23
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2023/03/24	2024/03/23
750MHz Validation Dipole	MVG	SID750	07/22 DIP 0G835-655	2023/02/06	2024/02/05
835MHz Validation Dipole	MVG	SID835	07/22 DIP 0G835-656	2023/02/06	2024/02/05
1800MHz Validation Dipole	MVG	SID1800	07/22 DIP 1G800-657	2023/02/06	2024/02/05
1900MHz Validation Dipole	MVG	SID1900	07/22 DIP 1G900-658	2023/02/06	2024/02/05
2450MHz Validation Dipole	MVG	SID2450	07/22 DIP 2G450-662	2023/02/06	2024/02/05
2600MHz Validation Dipole	MVG	SID2600	07/22 DIP 2G600-663	2023/02/06	2024/02/05
5200MHz-5800MHz Validation Dipole	MVG	SID5000	07/22 DIP5G000-670	2023/02/06	2024/02/05
LIMESAR Dielectric Probe	MVG	SCLMP	06/22 OCPG88	/	/
ENA Series Network Analyzer	Agilent	E5071B	MY42301221	2022/11/24	2023/11/23
Thermometer	Riters	DT-232	21A11	2023/03/24	2024/03/23
Antenna network emulator	MVG	ANTA 74	07/22 ANTA 74	/	/
SAM Phantom	MVG	SAM	07/22 SAM149	/	/
Mobile Phone Positioning System	MVG	MSH 118	07/22 MSH 118	/	/
Mechanical Calibration Kit	PNA	/	/	/	/
Open SAR test software	MVG	/	V5.3.5	/	/

Note: For dipole antennas, BTF has adopted 3 years as calibration intervals, and on annual basis, every measurement dipole has been evaluated and is in compliance with the following criteria:

1. There is no physical damage on the dipole;
2. System validation with specific dipole is within 10% of calibrated value;
3. Return-loss in within 20% of calibrated measurement.
4. Impedance (real or imaginary parts) in within 5 Ohms of calibrated measurement.

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ANNEX A Simulating Liquid Verification Result

The dielectric parameters of the liquids were verified prior to the SAR evaluation using an SCLMP Dielectric Probe Kit.

Dielectric performance of tissue simulating liquid									
Frequency (MHz)	εr		σ(s/m)		Delta (εr)	Delta (σ)	Limit	Temp (℃)	Date
	Target	Measured	Target	Measured					
750	41.90	41.80	0.89	0.86	0.24%	3.37%	±5%	20.0	8/6/2023
835	41.50	41.41	0.90	0.87	0.22%	3.33%	±5%	20.0	8/6/2023
1800	40.00	39.91	1.40	1.37	0.23%	2.14%	±5%	20.0	9/6/2023
1900	40.00	39.88	1.40	1.41	0.30%	-0.71%	±5%	20.0	9/6/2023
2450	39.20	39.08	1.80	1.81	0.31%	-0.56%	±5%	20.0	12/6/2023
2600	39.00	38.88	1.96	1.97	0.31%	-0.51%	±5%	20.0	12/6/2023
5200	36.00	35.88	4.66	4.70	0.33%	-0.86%	±5%	20.0	12/6/2023
5400	35.80	35.68	4.86	4.90	0.34%	-0.82%	±5%	20.0	12/6/2023
5600	35.50	35.38	5.07	5.11	0.34%	-0.79%	±5%	20.0	12/6/2023
5800	35.30	35.18	5.27	5.31	0.34%	-0.76%	±5%	20.0	12/6/2023
NOTE: The dielectric parameters of the tissue-equivalent liquid should be measured under similar ambient conditions and within 2 ℃ of the conditions expected during the SAR evaluation to satisfy protocol requirements.									

ANNEX B System Check Result

Comparing to the original SAR value provided by MVG, the validation data should be within its specification of 10 %(for 10 g).

Frequency (MHz)	Input Power (mW)	1g SAR (W/Kg)	10g SAR (W/Kg)	1g SAR 1W input power normalized (W/Kg)	10g SAR 1W input power normalized (W/Kg)	1g SAR Standard target (1W) (W/Kg)	10g SAR Standard target (1W) (W/Kg)	1g SAR Deviation	10g SAR Deviation
750	16	0.138	0.092	8.63	5.75	8.25	5.38	4.55%	6.88%
835	16	0.163	0.106	10.19	6.63	9.79	6.17	4.06%	7.37%
1800	16	0.588	0.312	36.75	19.50	39.33	20.61	-6.56%	-5.39%
1900	16	0.630	0.322	39.38	20.13	40.97	20.7	-3.89%	-2.78%
2450	16	0.793	0.352	49.56	22.00	54.4	23.86	-8.89%	-7.80%
2600	16	0.866	0.421	54.13	26.31	57.14	24.48	-5.28%	7.49%
5200	13	0.998	0.294	76.77	22.62	73.88	21.29	3.91%	6.23%
5400	13	1.120	0.327	86.15	25.15	81.47	23.23	5.75%	8.28%
5600	13	1.084	0.314	83.38	24.15	78.71	22.64	5.94%	6.69%
5800	13	1.023	0.280	78.69	21.54	74.21	21.50	6.04%	0.18%

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System Performance Check Data (750 MHz)

System check at 750 MHz

Date of measurement: 8/6/2023

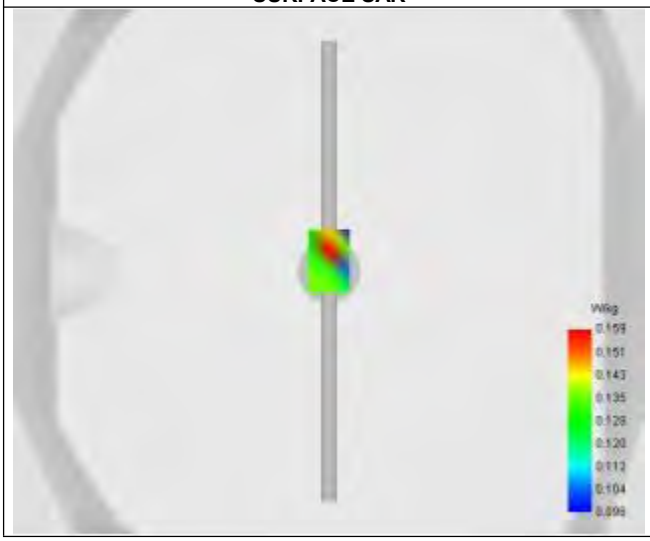
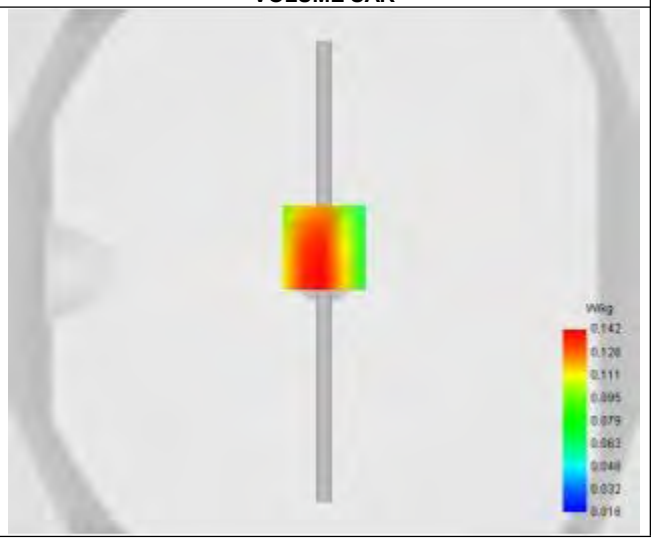
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW750
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	750.000
Relative permitivity (real part)	41.800
Relative permitivity (imaginary part)	21.460
Conductivity (S/m)	0.860

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=9.00 ; SAR Peak: 0.20 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.092
SAR 1g (W/Kg)	0.138
Variation (%)	-2.190
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.287	0.142	0.092	0.073	0.042

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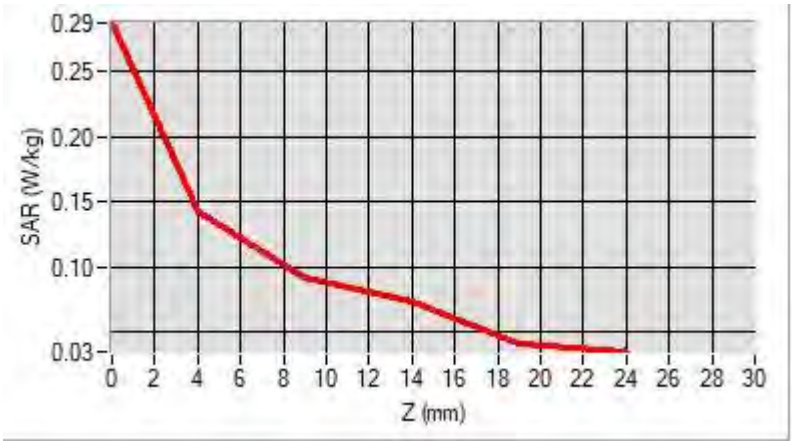
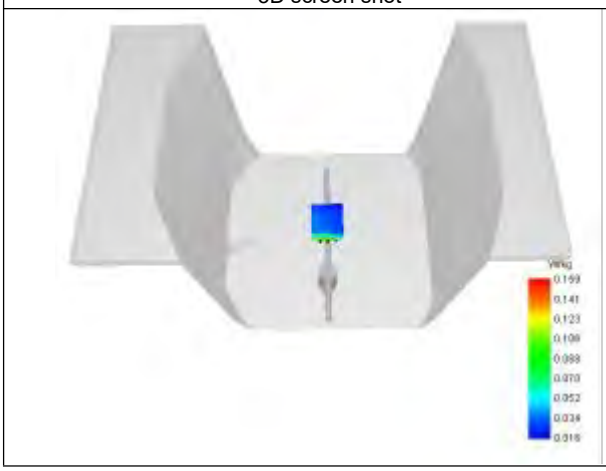
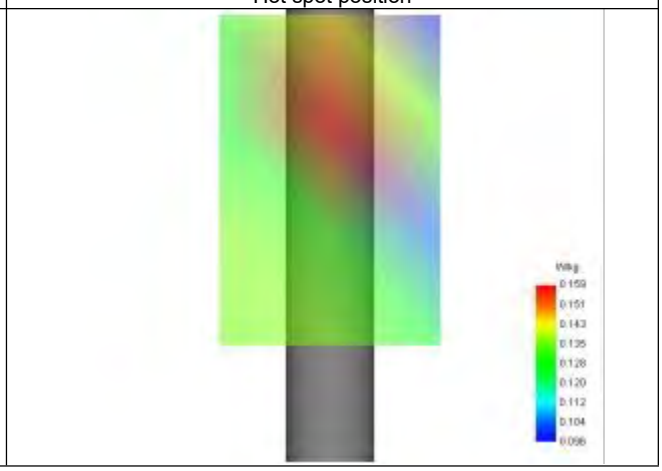


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (835 MHz)

System check at 835 MHz

Date of measurement: 8/6/2023

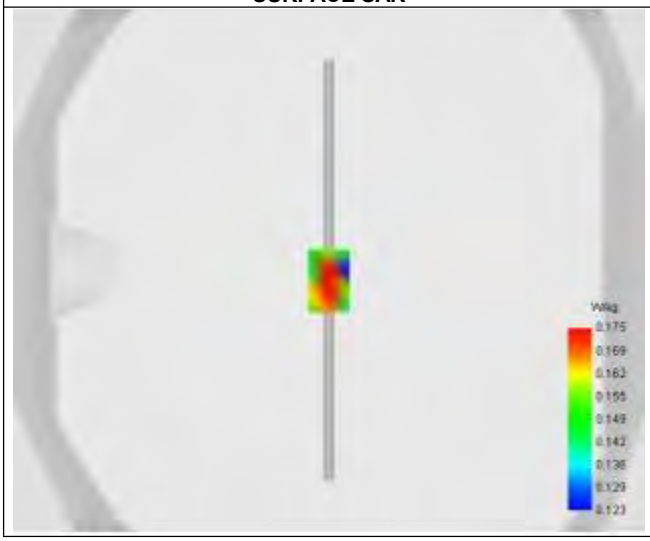
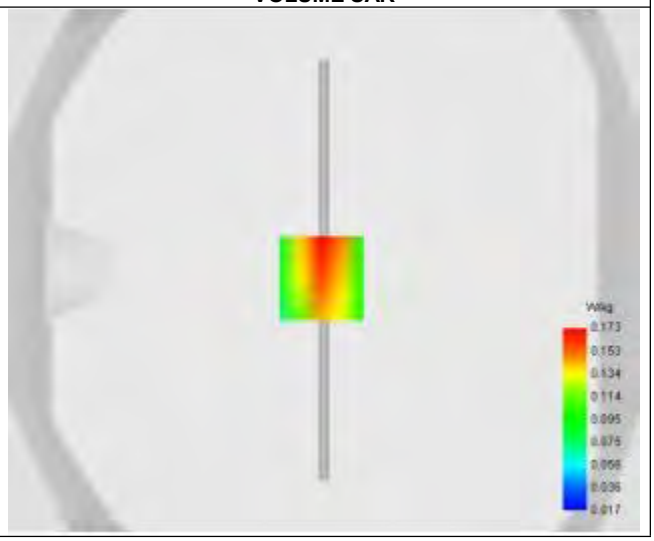
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW835
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	835.000
Relative permitivity (real part)	41.410
Relative permitivity (imaginary part)	19.490
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-3.00 ; SAR Peak: 0.26 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.163
Variation (%)	-3.390
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.059	0.173	0.115	0.061	0.072

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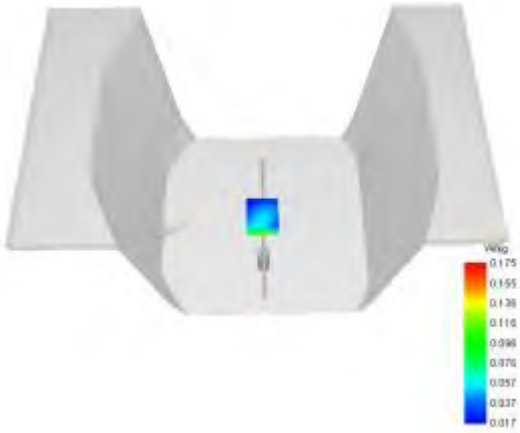
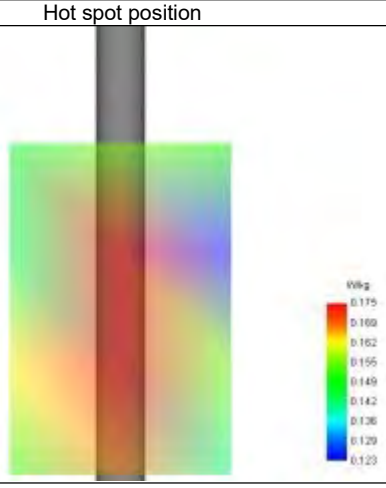
F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1800 MHz)

System check at 1800 MHz

Date of measurement: 9/6/2023

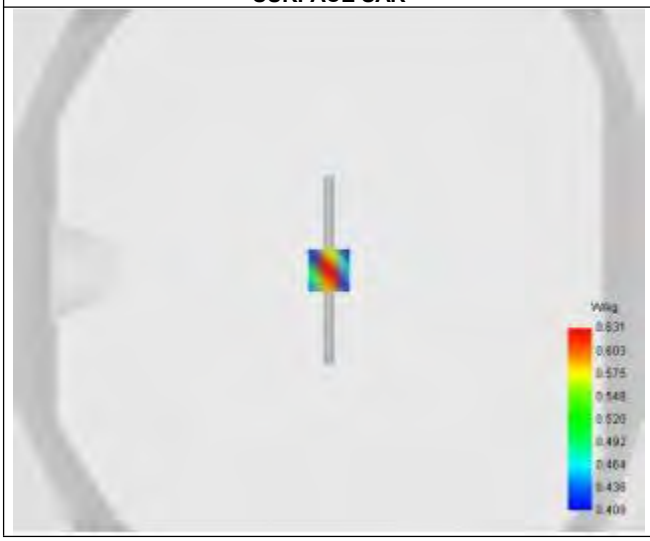
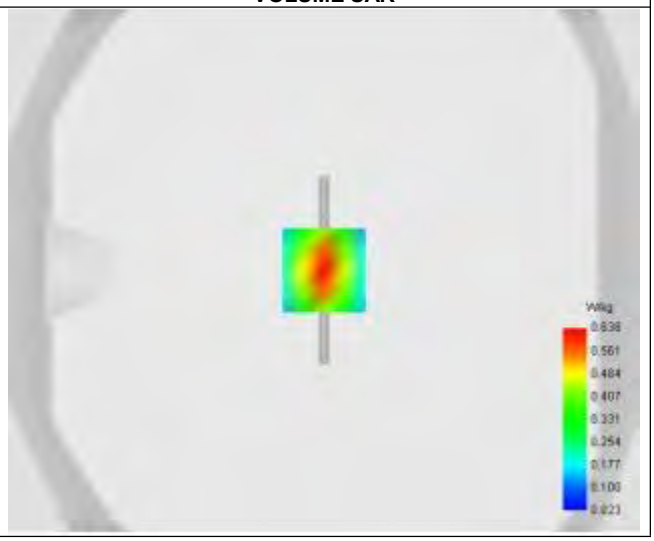
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1800.000
Relative permitivity (real part)	39.910
Relative permitivity (imaginary part)	14.090
Conductivity (S/m)	1.370

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.00 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.312
SAR 1g (W/Kg)	0.588
Variation (%)	-0.250
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.003	0.638	0.356	0.204	0.127

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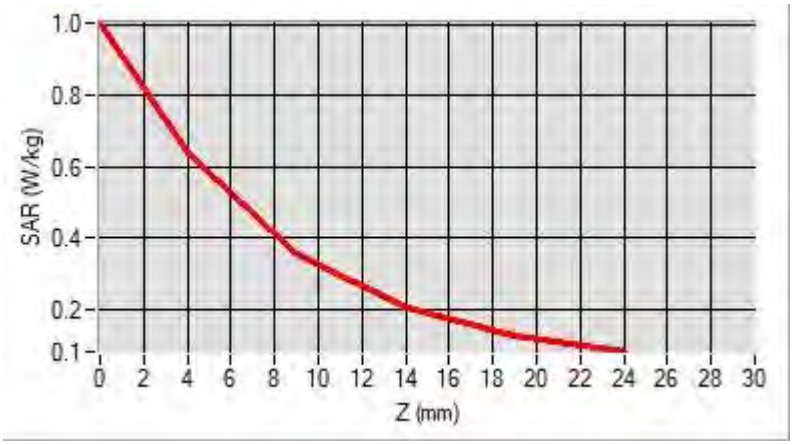
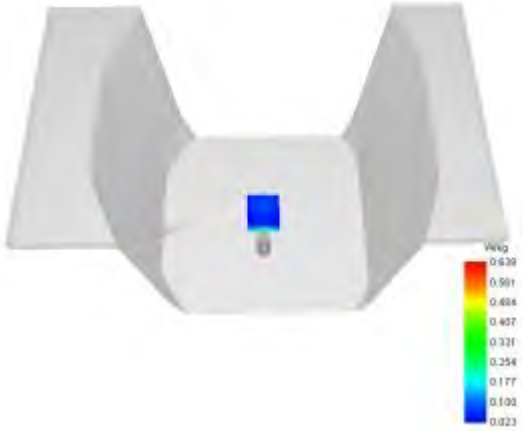
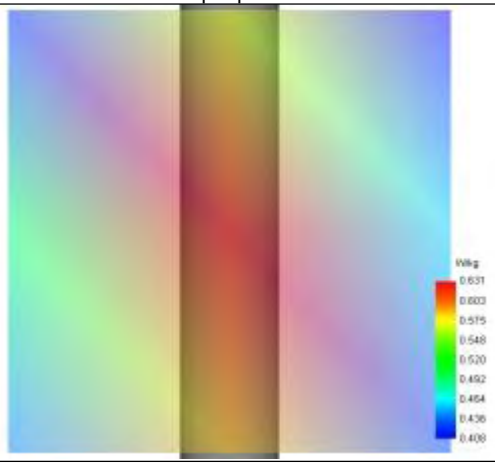


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1900 MHz)

System check at 1900 MHz

Date of measurement: 9/6/2023

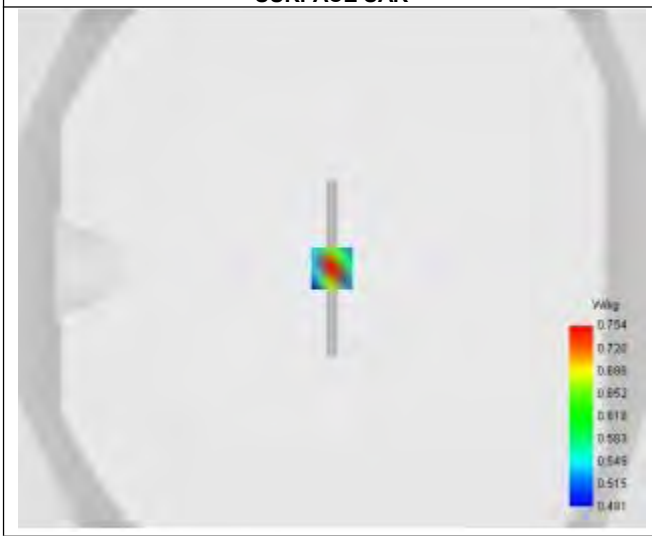
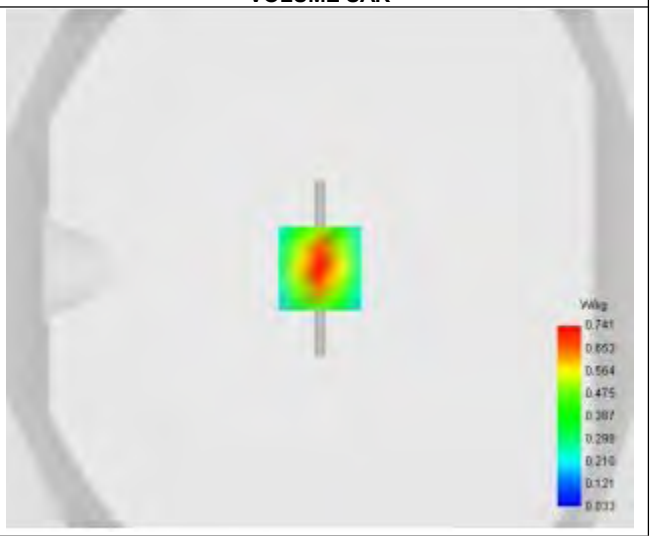
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1900
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1900.000
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.322
SAR 1g (W/Kg)	0.630
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.201	0.759	0.402	0.239	0.156

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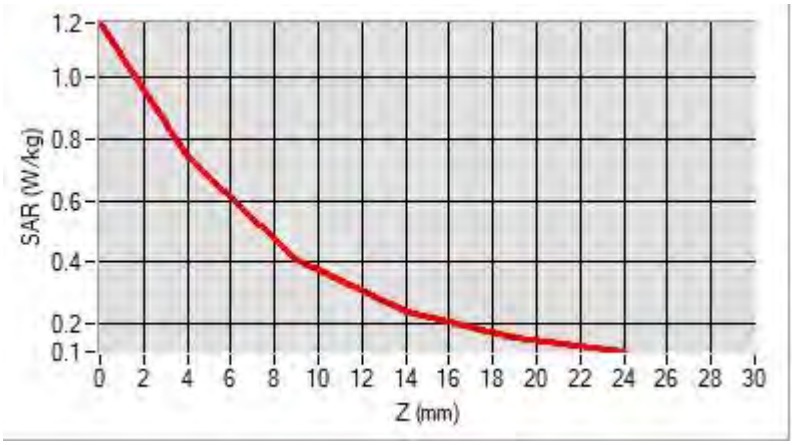
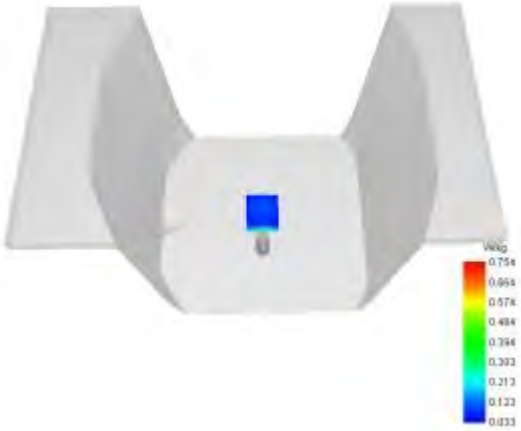
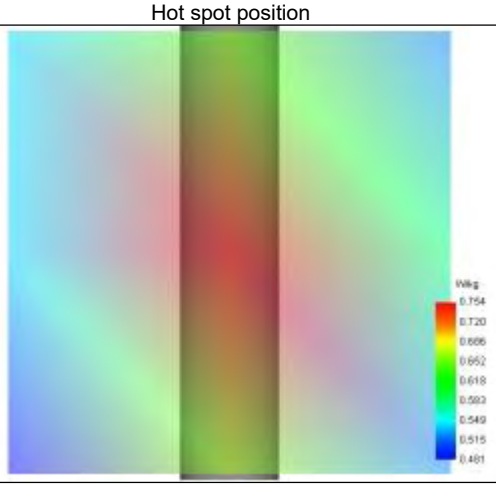


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2450 MHz)

System check at 2450 MHz

Date of measurement: 12/6/2023

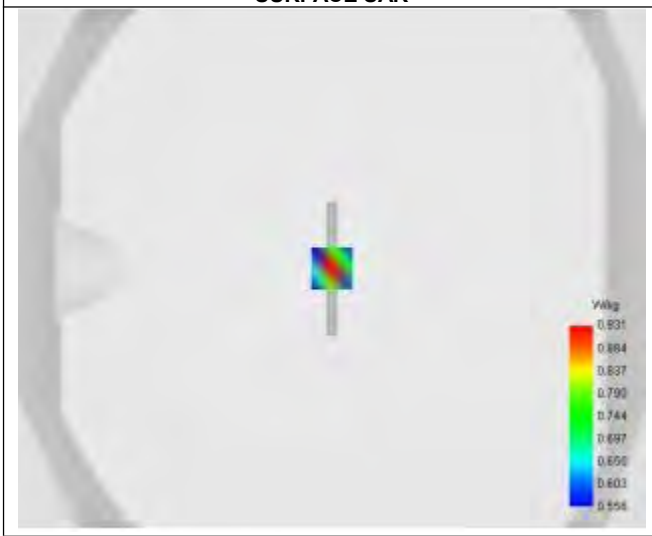
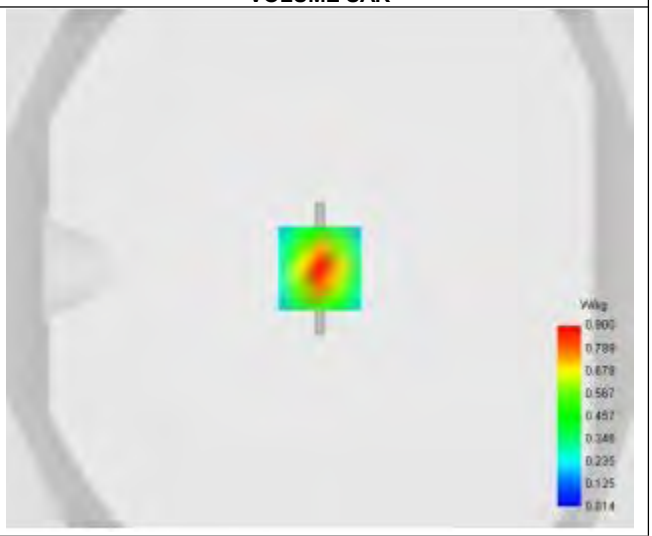
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2450
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2450.000
Relative permitivity (real part)	39.080
Relative permitivity (imaginary part)	13.340
Conductivity (S/m)	1.810

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.47 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.352
SAR 1g (W/Kg)	0.793
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.466	0.900	0.477	0.261	0.158

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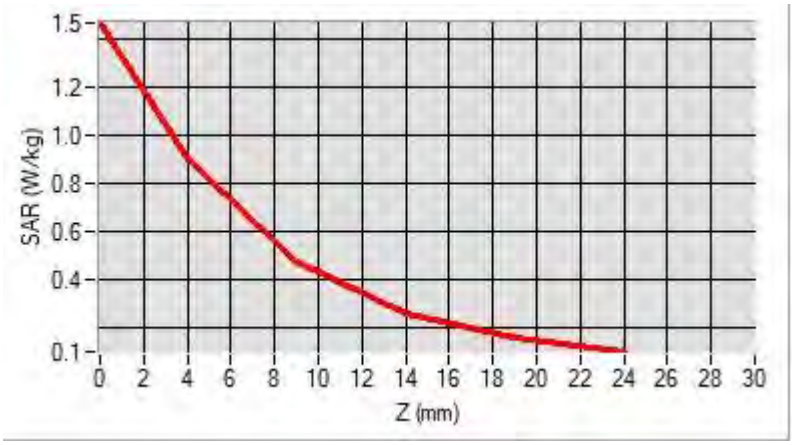
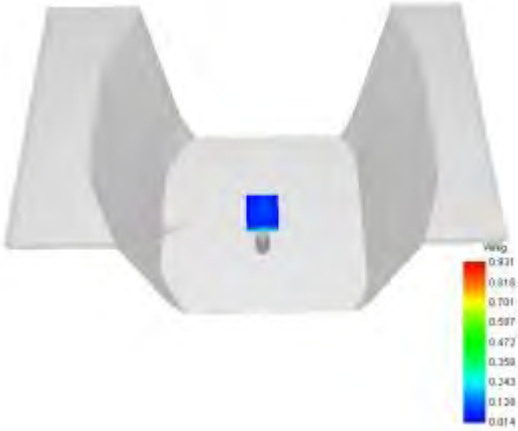
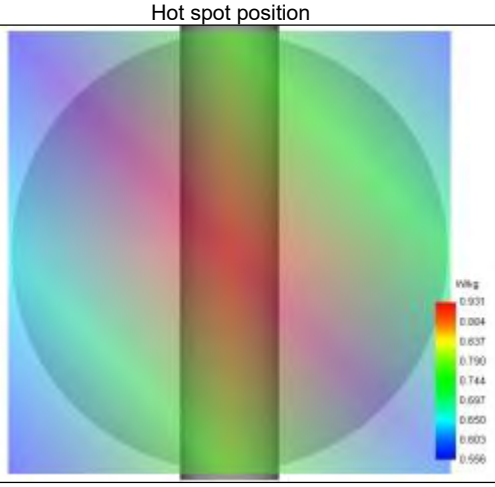


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2600 MHz)

System check at 2600 MHz

Date of measurement: 12/6/2023

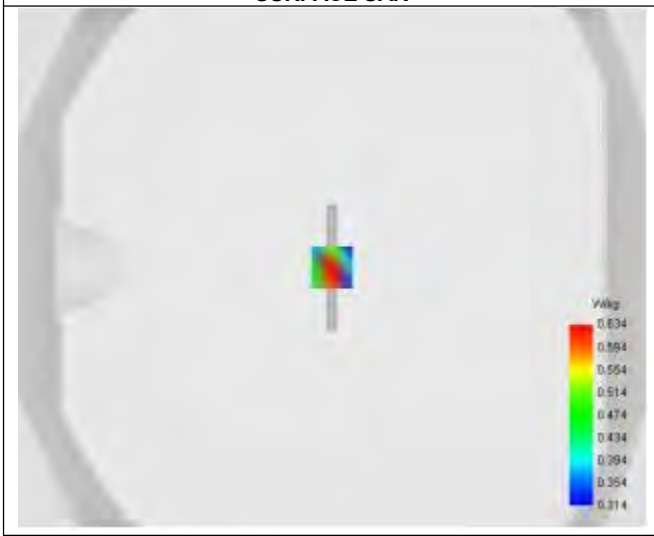
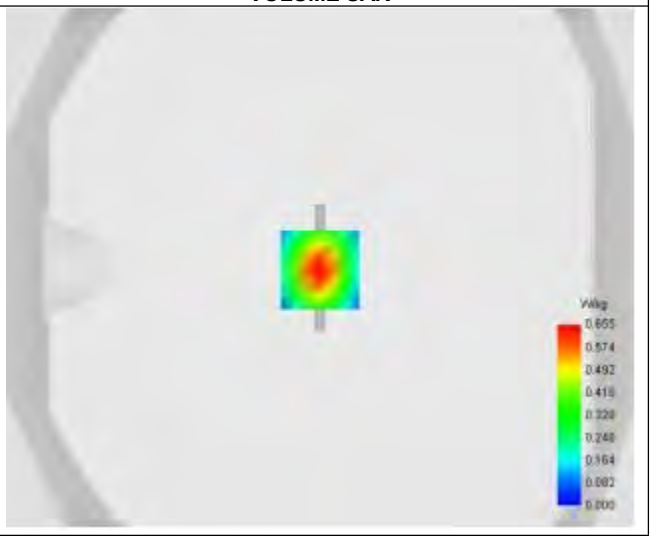
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2600.000
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-1.00 ; SAR Peak: 1.02 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.421
SAR 1g (W/Kg)	0.866
Variation (%)	2.980
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.020	0.655	0.359	0.187	0.091

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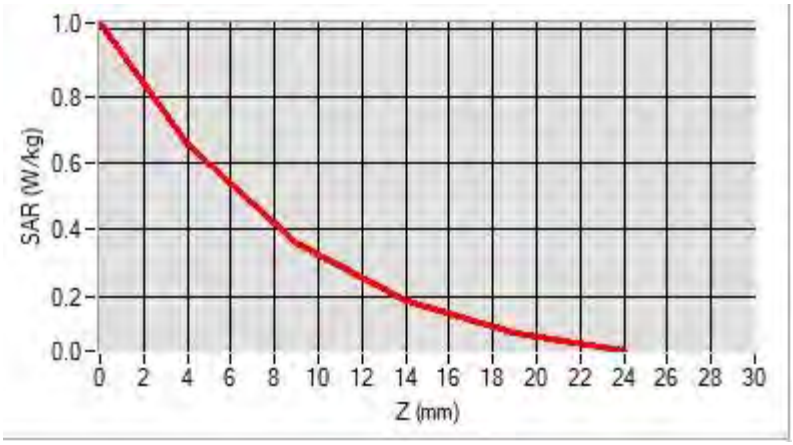
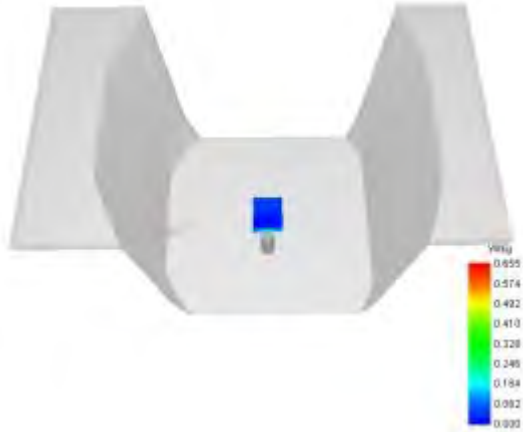
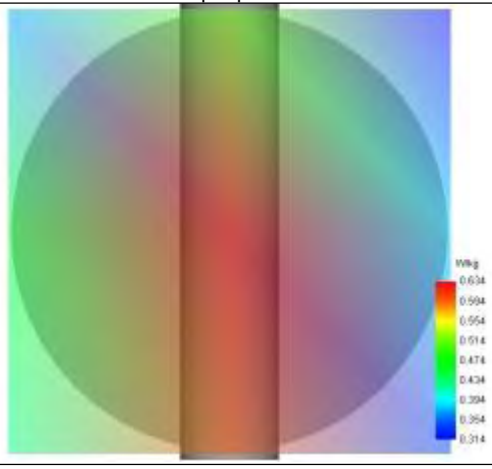


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5200 MHz)

System check at 5200 MHz

Date of measurement: 12/6/2023

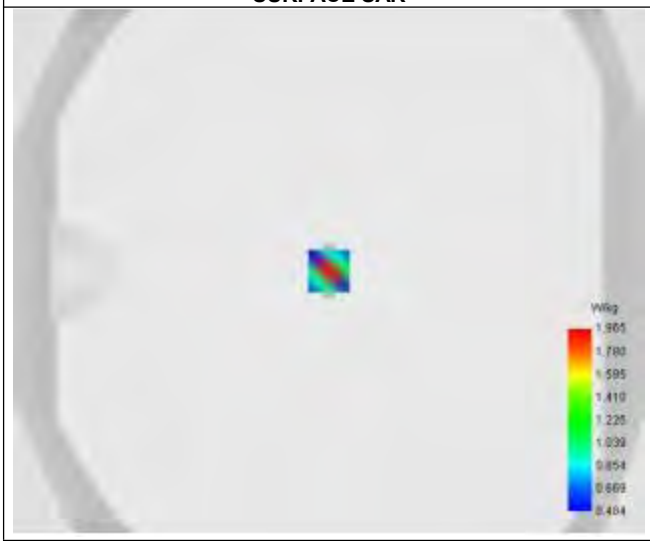
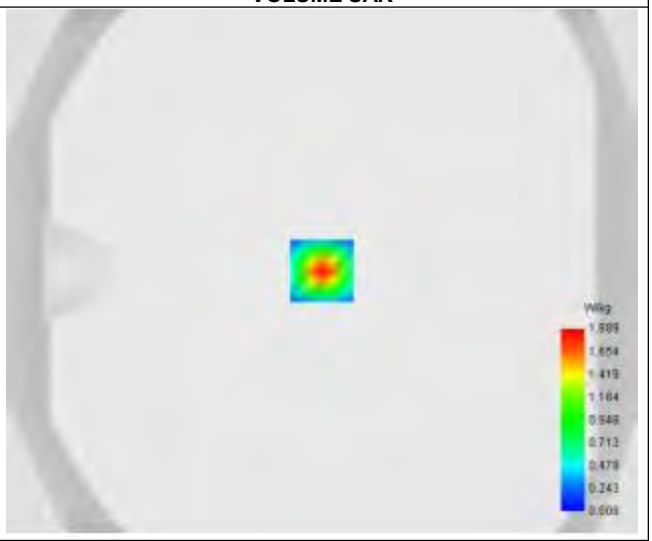
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5200
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5200.000
Relative permitivity (real part)	35.880
Relative permitivity (imaginary part)	16.250
Conductivity (S/m)	4.700

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.38 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.294
SAR 1g (W/Kg)	0.998
Variation (%)	-3.400
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.268	1.889	1.021	0.523	0.266	0.142	0.085	0.060	0.052

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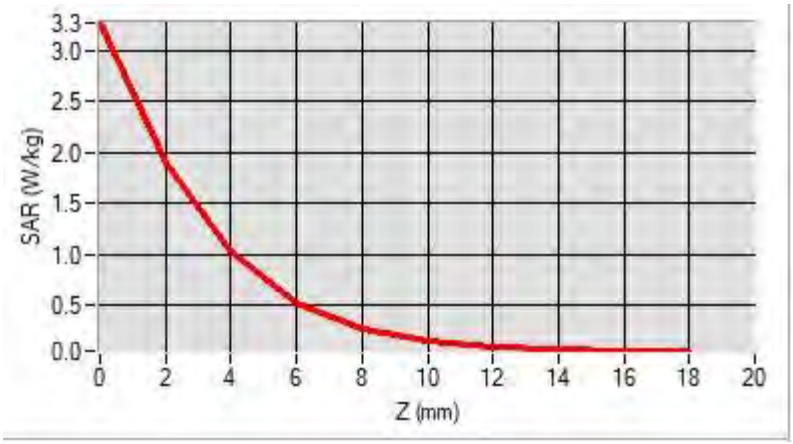
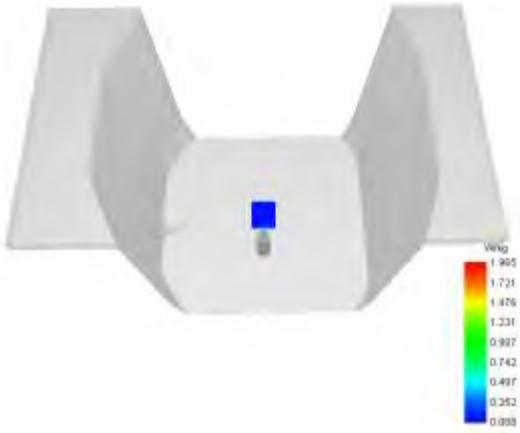
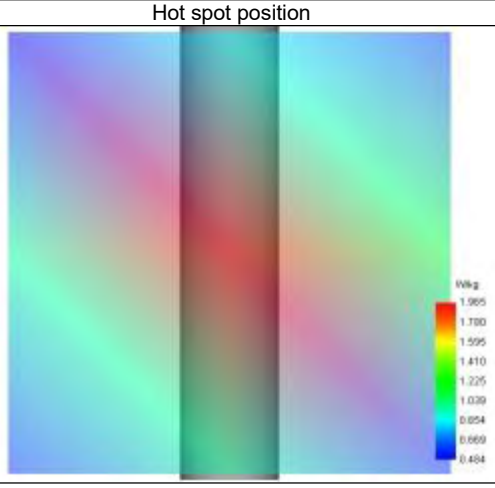


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5400 MHz)

System check at 5400 MHz

Date of measurement: 12/6/2023

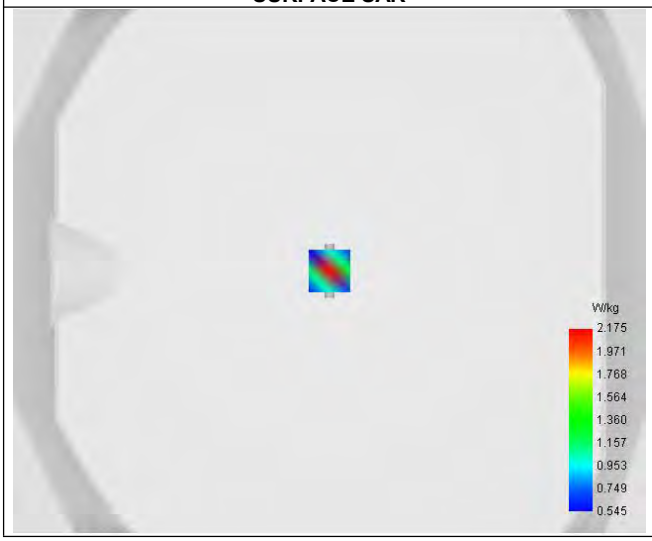
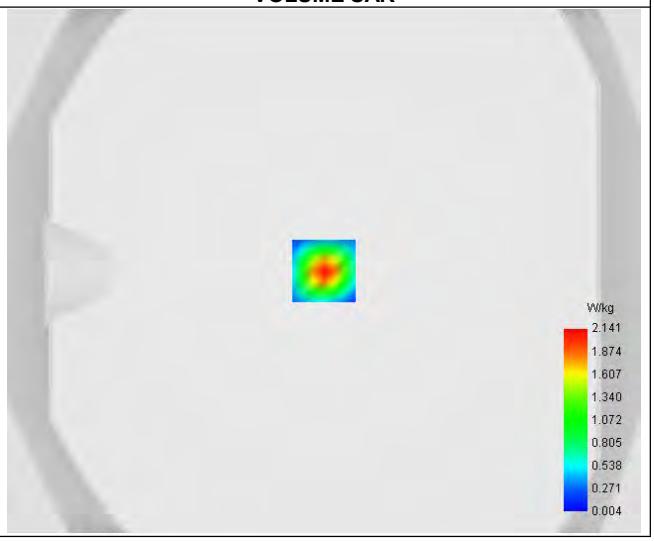
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.12
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5400
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5400.000
Relative permitivity (real part)	35.800
Relative permitivity (imaginary part)	16.200
Conductivity (S/m)	4.860

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.78 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.327
SAR 1g (W/Kg)	1.120
Variation (%)	-4.610
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.660	2.141	1.177	0.614	0.317	0.169	0.098	0.065	0.050

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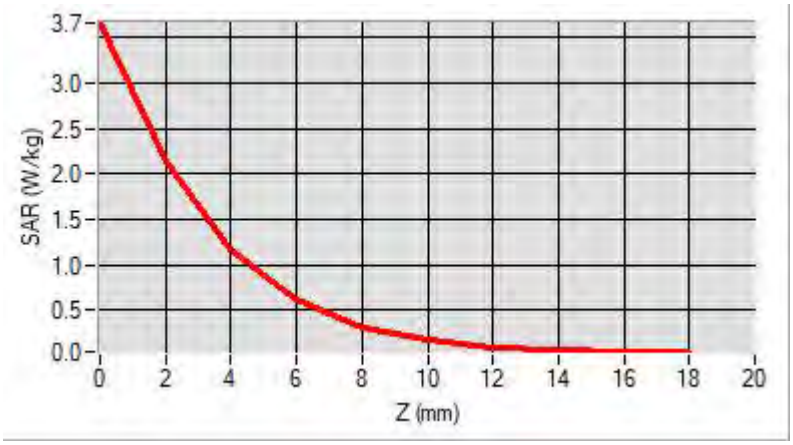
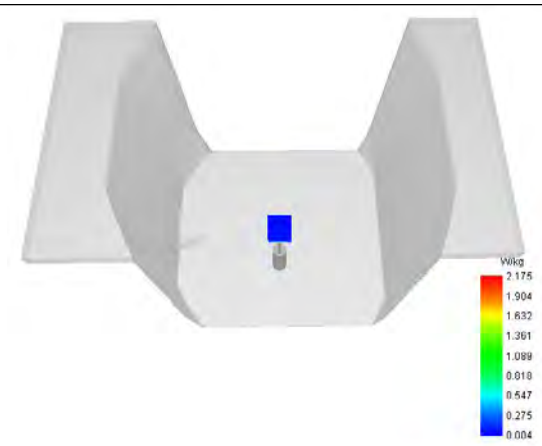
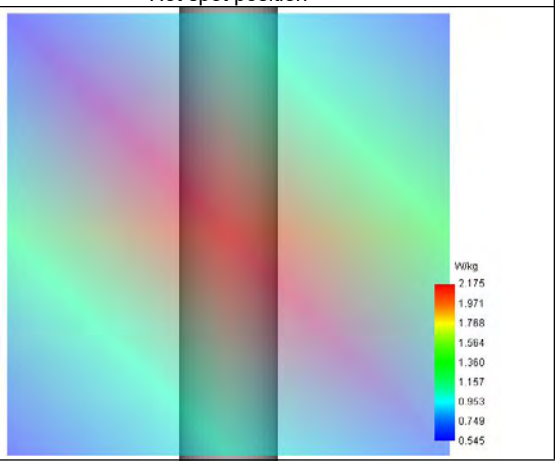


F. 3D Image

3D screen shot	Hot spot position
	

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System Performance Check Data (5600 MHz)

System check at 5600 MHz

Date of measurement: 12/6/2023

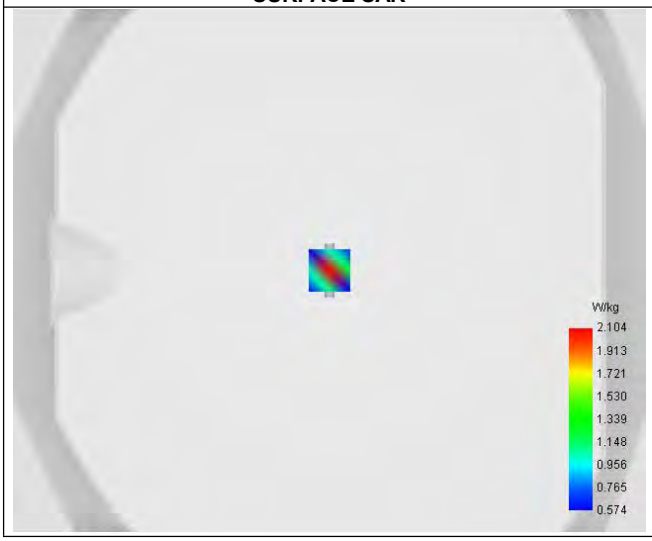
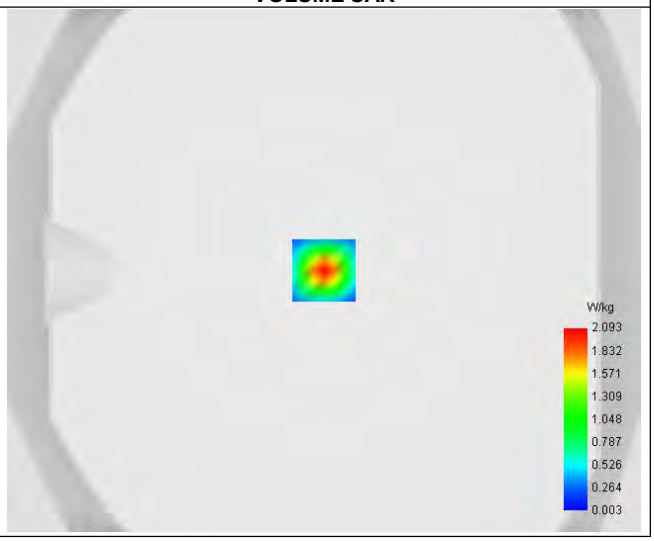
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.18
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5600.000
Relative permitivity (real part)	35.500
Relative permitivity (imaginary part)	16.300
Conductivity (S/m)	5.071

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.90 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.314
SAR 1g (W/Kg)	1.084
Variation (%)	-0.190
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.748	2.093	1.074	0.514	0.243	0.122	0.072	0.056	0.056

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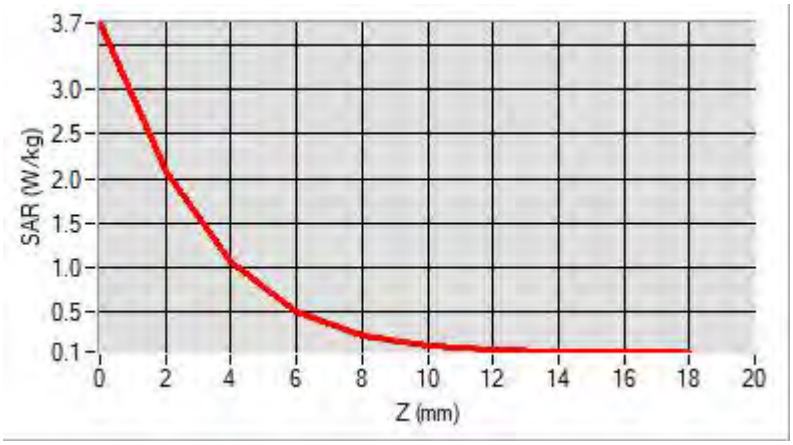
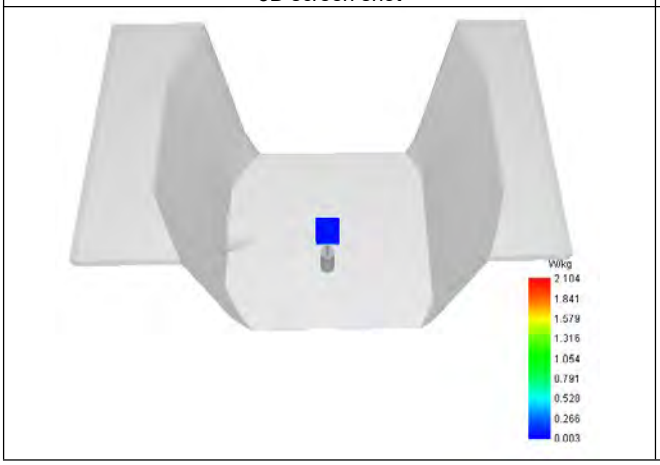
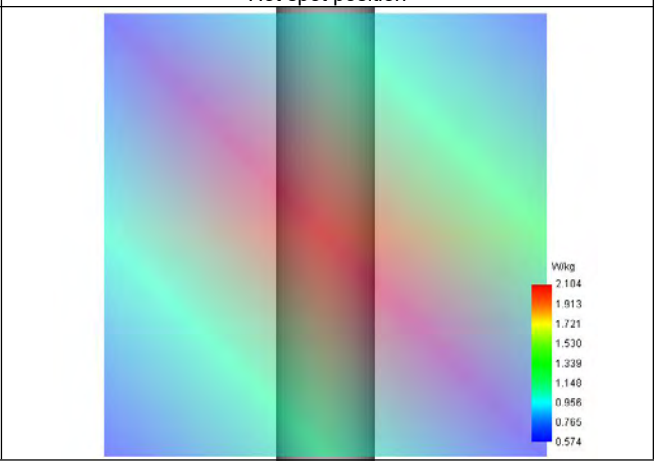


F. 3D Image

3D screen shot	Hot spot position
	

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System Performance Check Data (5800 MHz)

System check at 5800 MHz

Date of measurement: 12/6/2023

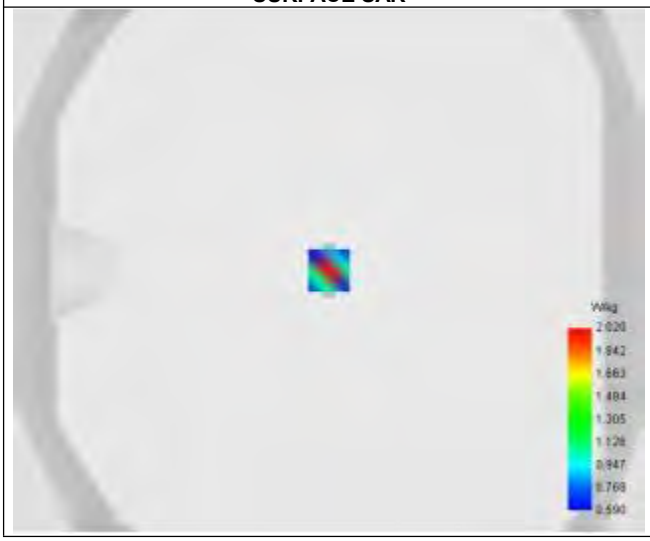
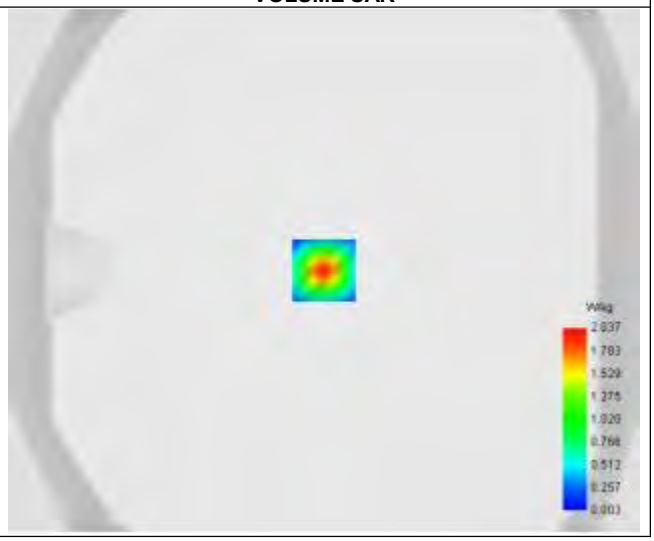
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5800.000
Relative permitivity (real part)	35.180
Relative permitivity (imaginary part)	16.480
Conductivity (S/m)	5.310

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 4.17 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.280
SAR 1g (W/Kg)	1.023
Variation (%)	0.490
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.948	2.037	0.915	0.361	0.135	0.055	0.033	0.037	0.059

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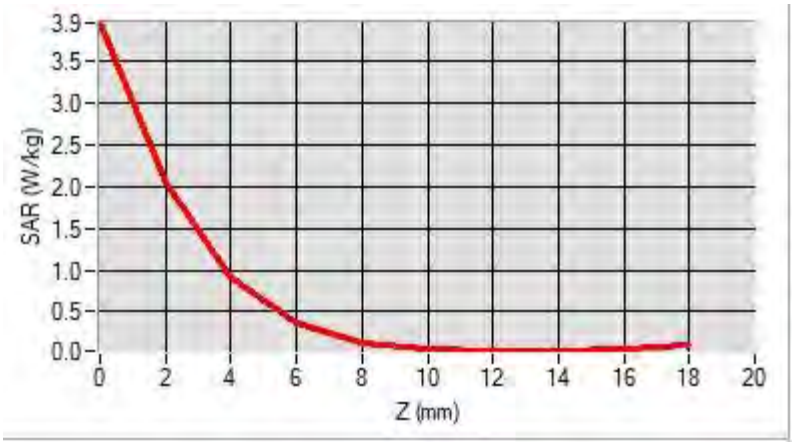
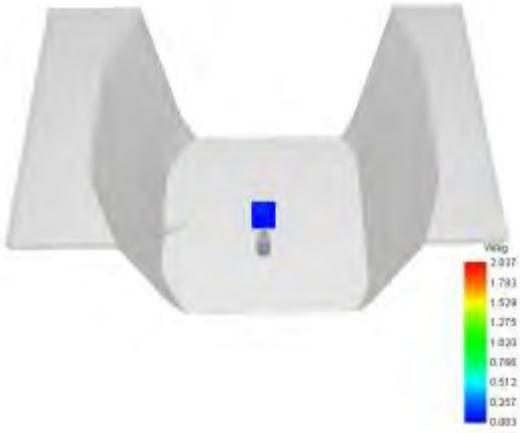
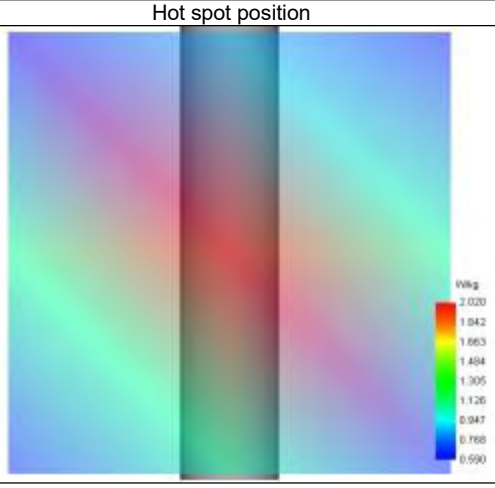


F. 3D Image

3D screen shot	Hot spot position
	

ANNEX C Test Data

1-Body with bottom position in dist. 0mm on Channel 19100 in LTE band 2

SAR Measurement at LTE band 2 (Body, Validation Plane)

Date of measurement: 9/6/2023

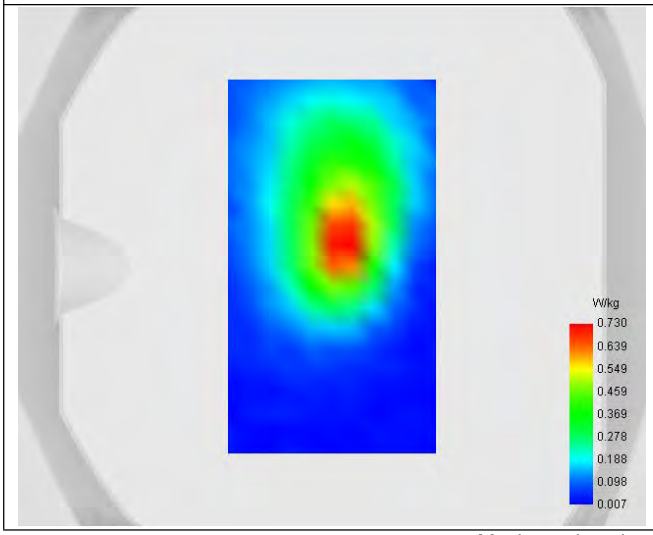
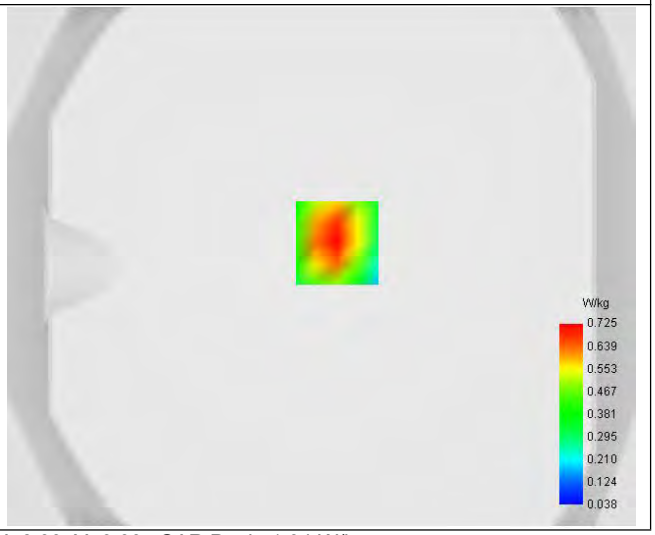
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 2
Channels	Higher (19100)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	50
RB size	1

B. Permitivity

Frequency (MHz)	1900.090
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=6.00, Y=9.00 ; SAR Peak: 1.04 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.393
SAR 1g (W/Kg)	0.680
Variation (%)	0.870
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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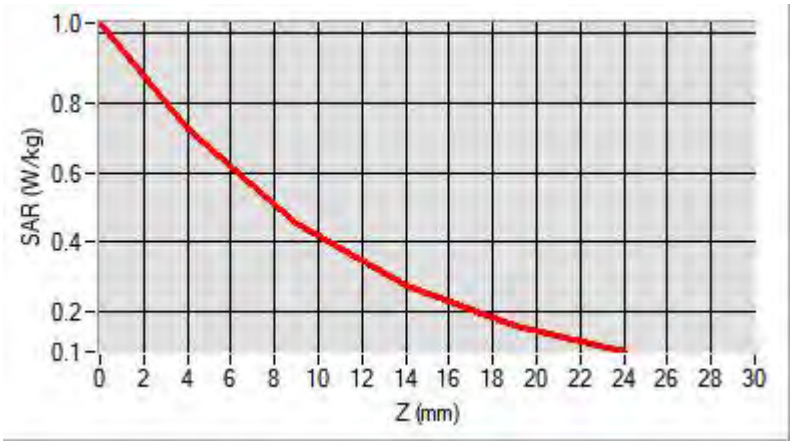
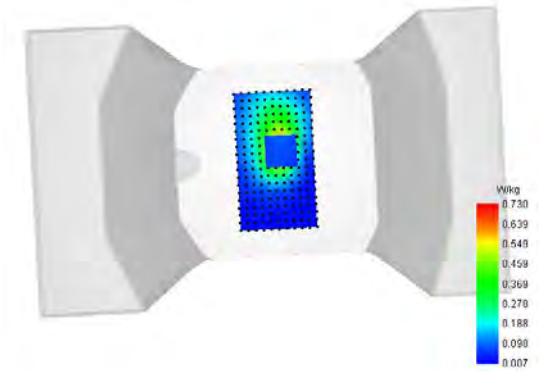
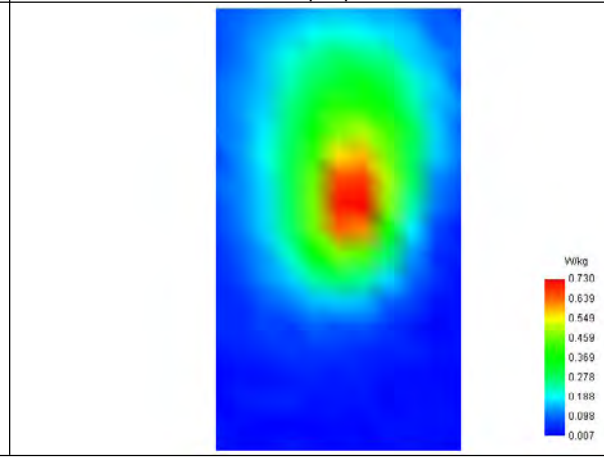
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.031	0.725	0.453	0.275	0.160



F. 3D Image

3D screen shot	Hot spot position
	

2-Body with bottom position in dist. 0mm on Channel 20050 in LTE band 4

SAR Measurement at LTE band 4 (Body, Validation Plane)

Date of measurement: 9/6/2023

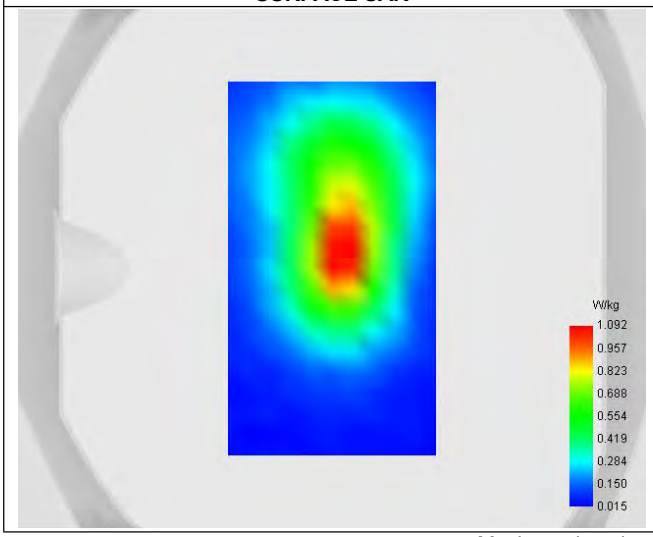
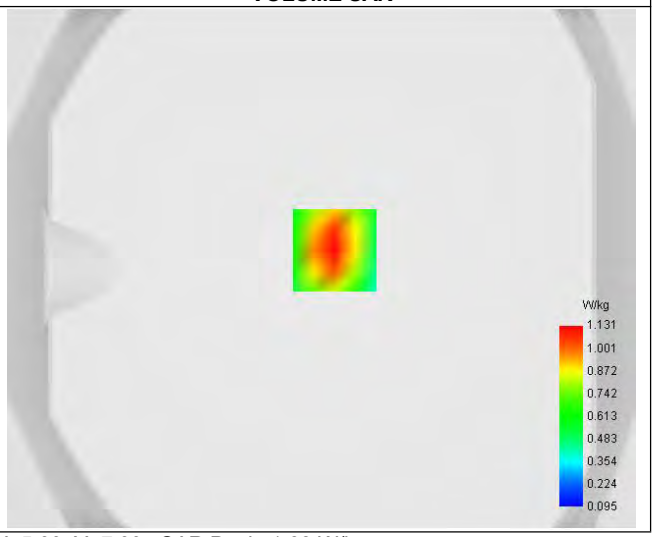
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 4
Channels	Lower (20050)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	50
RB size	1

B. Permitivity

Frequency (MHz)	1720.090
Relative permitivity (real part)	40.034
Relative permitivity (imaginary part)	13.966
Conductivity (S/m)	1.329

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=5.00, Y=7.00 ; SAR Peak: 1.68 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.613
SAR 1g (W/Kg)	1.061
Variation (%)	-0.760
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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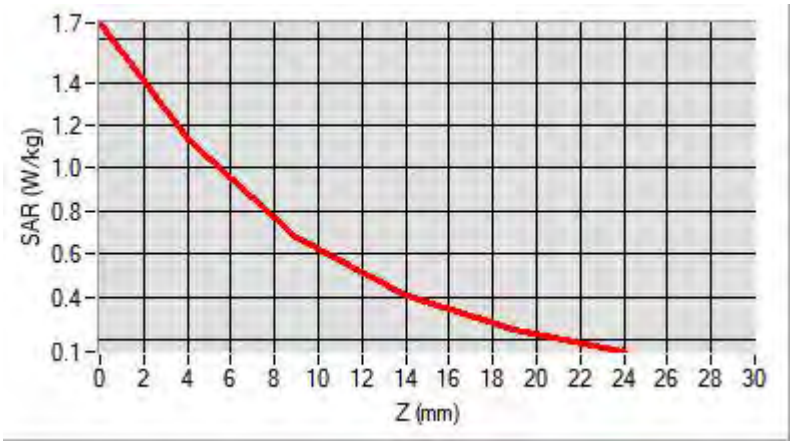
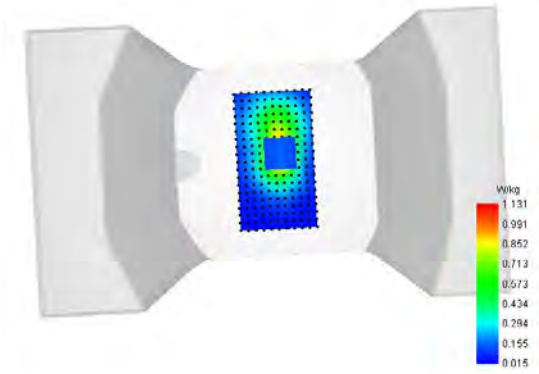
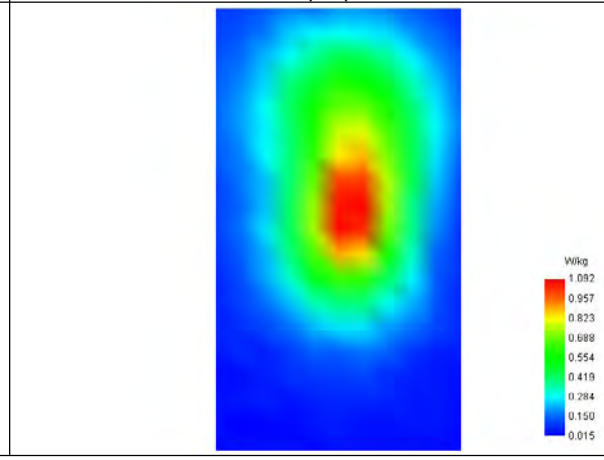
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.675	1.131	0.679	0.408	0.249



F. 3D Image

3D screen shot	Hot spot position
	

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3-Body with bottom position in dist. 0mm on Channel 20450 in LTE band 5

SAR Measurement at LTE band 5 (Body, Validation Plane)

Date of measurement: 8/6/2023

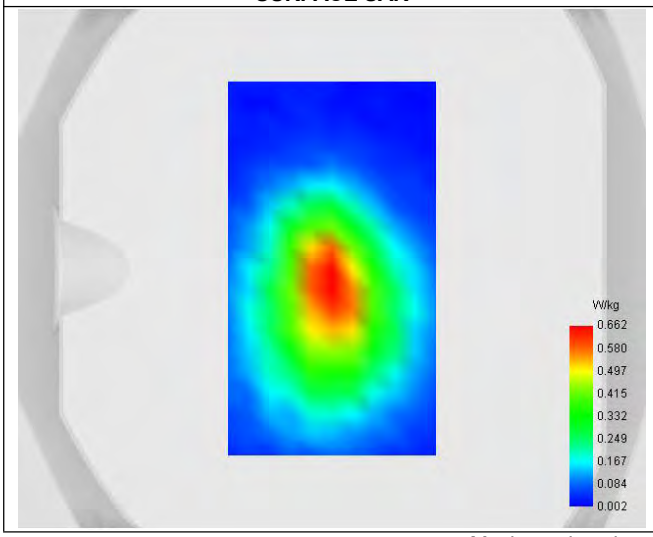
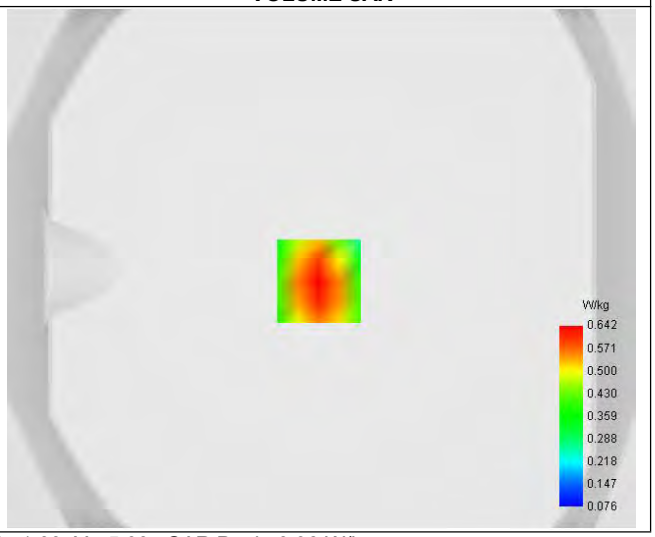
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 5
Channels	Lower (20450)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	824.590
Relative permitivity (real part)	41.426
Relative permitivity (imaginary part)	19.474
Conductivity (S/m)	0.865

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-5.00 ; SAR Peak: 0.96 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.377
SAR 1g (W/Kg)	0.609
Variation (%)	3.250
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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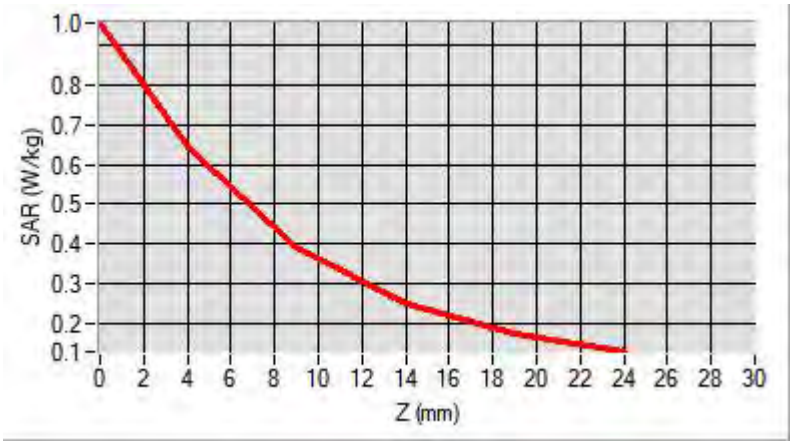
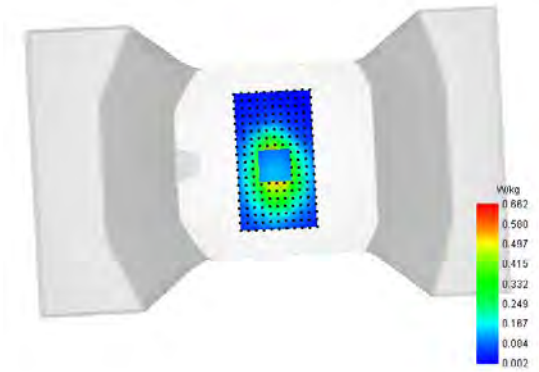
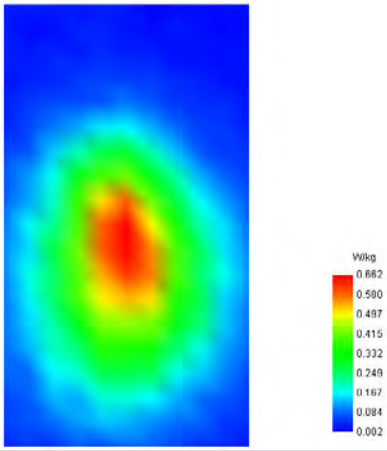
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.956	0.642	0.391	0.250	0.175



F. 3D Image

3D screen shot	Hot spot position
	

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4-Body with bottom position in dist. 0mm on Channel 20850 in LTE band 7

SAR Measurement at LTE band 7 (Body, Validation Plane)

Date of measurement: 12/6/2023

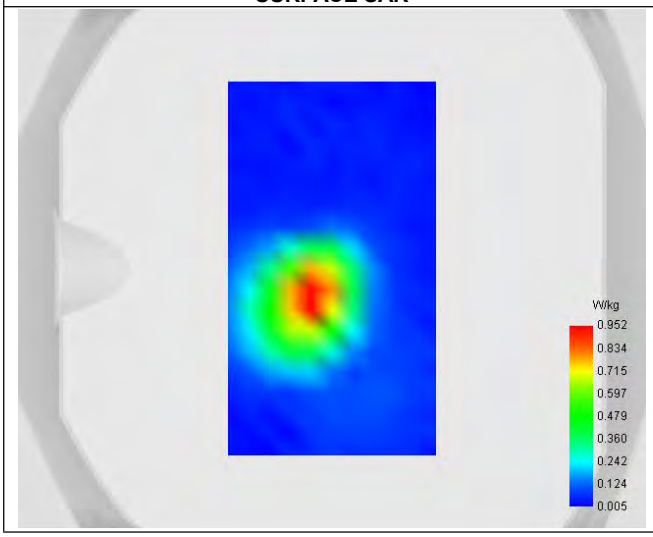
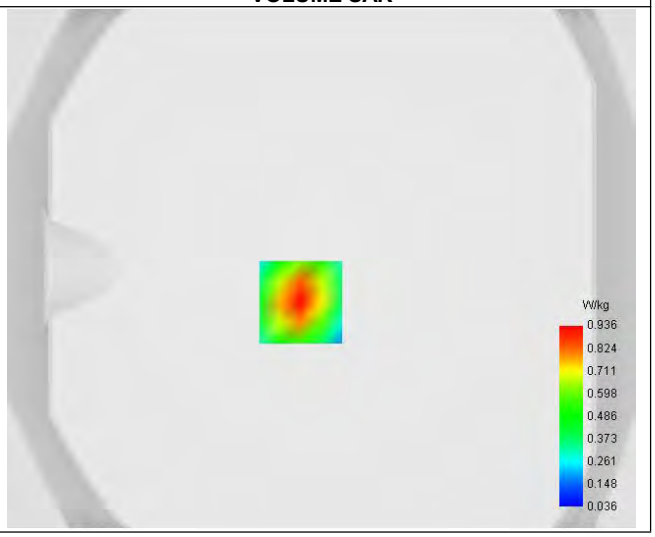
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 7
Channels	Lower (20850)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	2510.000
Relative permitivity (real part)	39.000
Relative permitivity (imaginary part)	13.080
Conductivity (S/m)	1.874

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=-13.00 ; SAR Peak: 1.55 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.428
SAR 1g (W/Kg)	0.850
Variation (%)	2.005
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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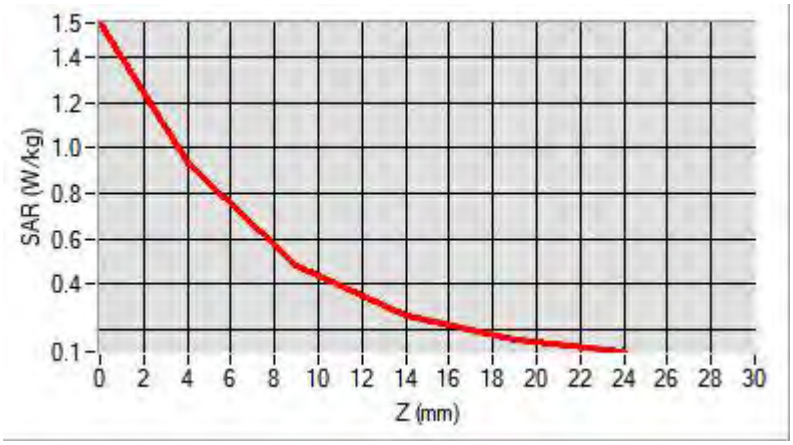
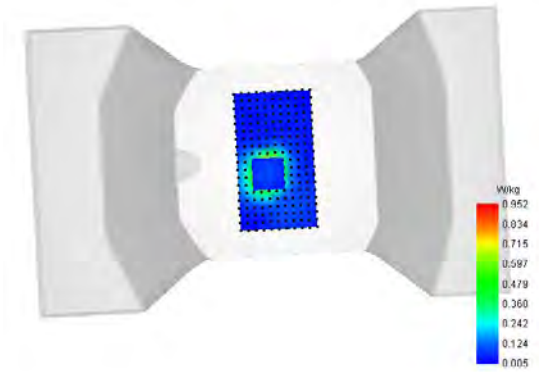
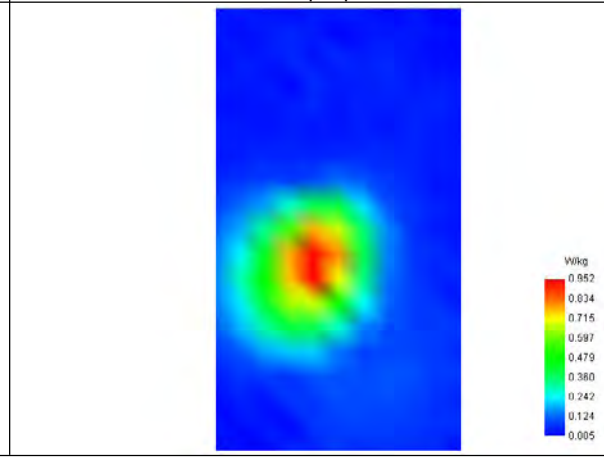
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.548	0.936	0.486	0.262	0.160



F. 3D Image

3D screen shot	Hot spot position
	

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5-Body with bottom position in dist. 0mm on Channel 23095 in LTE band 12

SAR Measurement at LTE band 12 (Body, Validation Plane)

Date of measurement: 8/6/2023

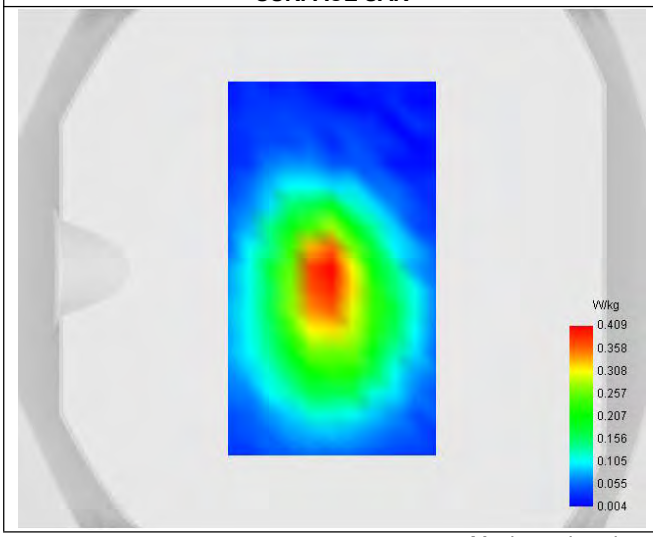
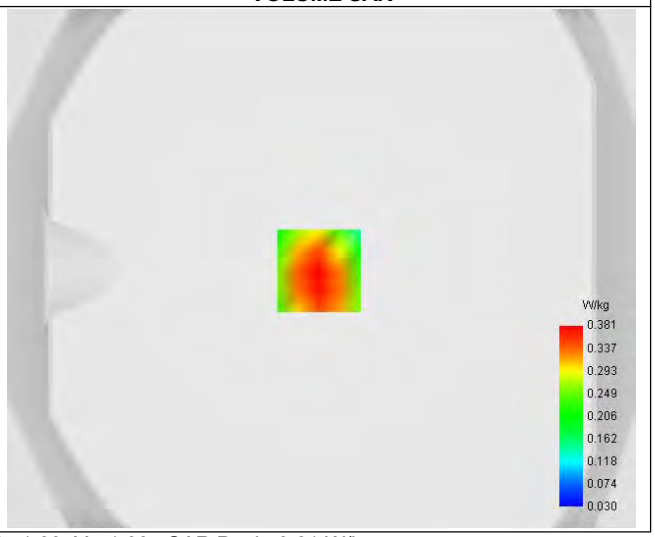
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 12
Channels	Middle (23095)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	711.910
Relative permitivity (real part)	41.601
Relative permitivity (imaginary part)	19.299
Conductivity (S/m)	0.806

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-1.00 ; SAR Peak: 0.61 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.232
SAR 1g (W/Kg)	0.378
Variation (%)	-3.060
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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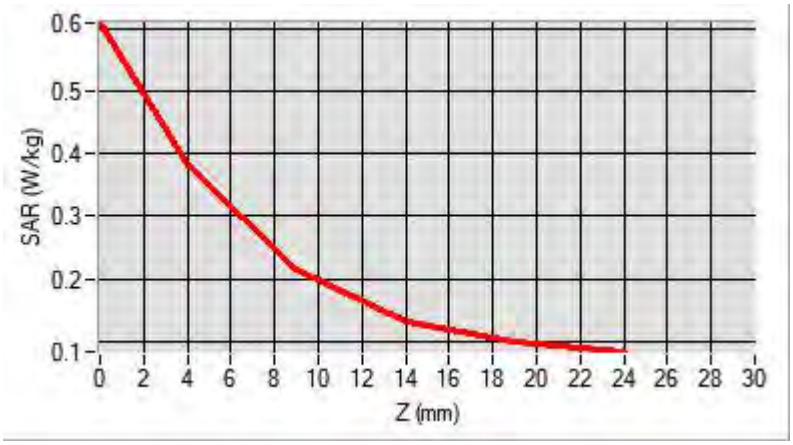
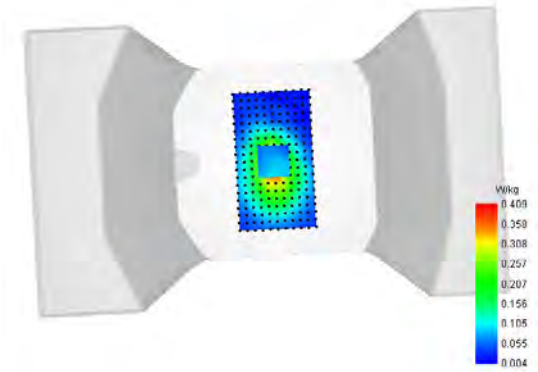
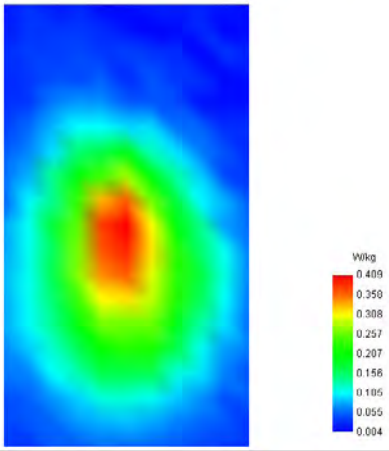
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.608	0.381	0.215	0.134	0.100



F. 3D Image

3D screen shot	Hot spot position
	

6-Body with bottom position in dist. 0mm on Channel 23230 in LTE band 13

SAR Measurement at LTE band 13 (Body, Validation Plane)

Date of measurement: 8/6/2023

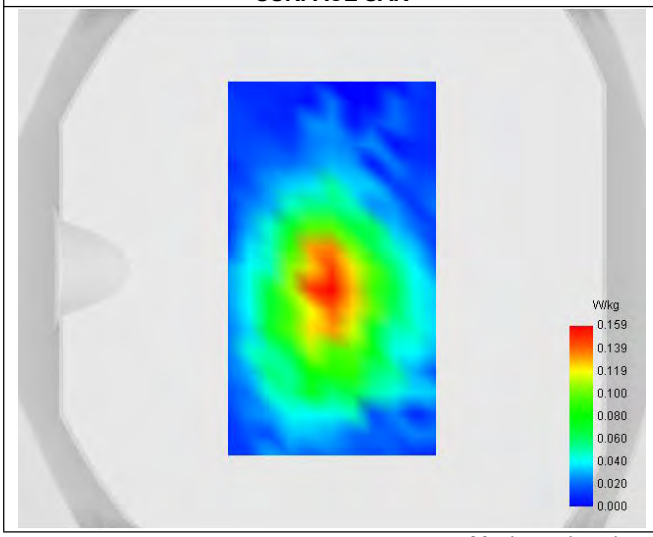
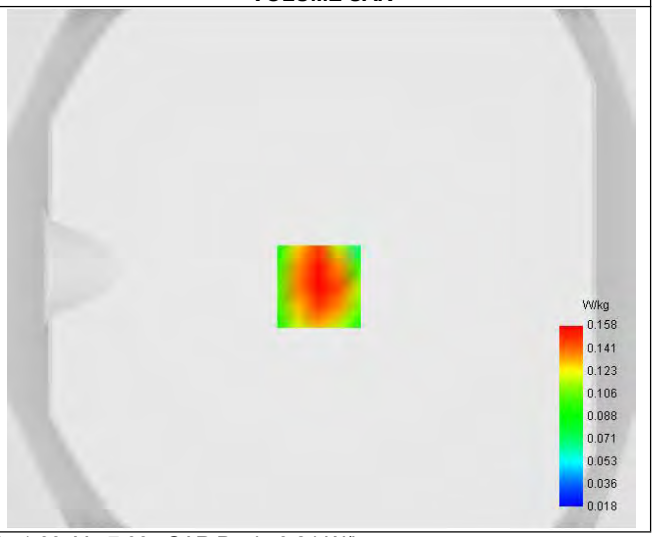
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 13
Channels	Middle (23230)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	777.590
Relative permitivity (real part)	41.499
Relative permitivity (imaginary part)	19.401
Conductivity (S/m)	0.840

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-7.00 ; SAR Peak: 0.24 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.097
SAR 1g (W/Kg)	0.152
Variation (%)	2.200
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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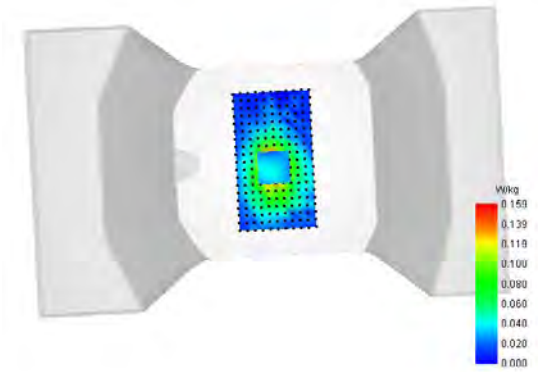
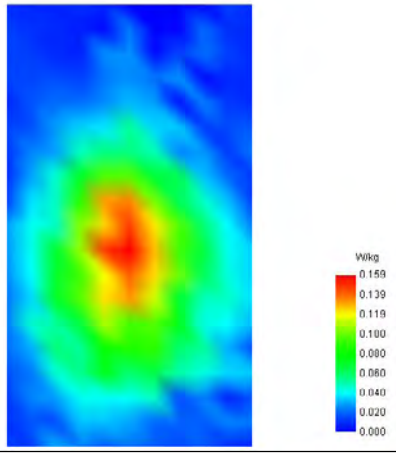
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.238	0.158	0.097	0.065	0.050

F. 3D Image

3D screen shot	Hot spot position
	

7-Body with bottom position in dist. 0mm on Channel 23330 in LTE band 14

SAR Measurement at LTE band 14 (Body, Validation Plane)

Date of measurement: 8/6/2023

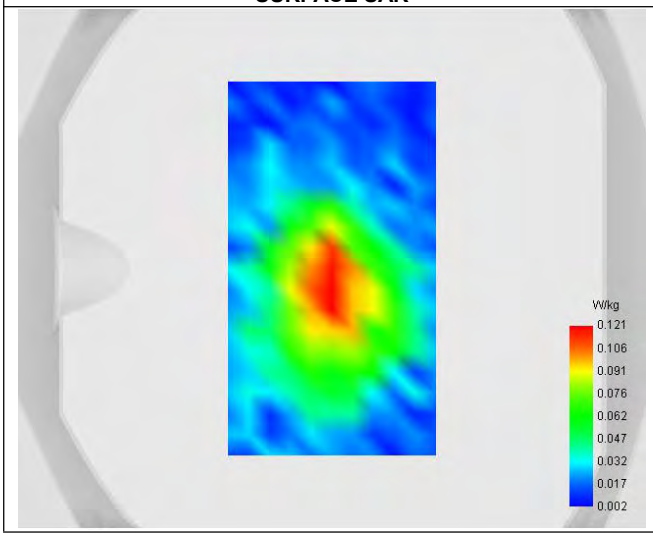
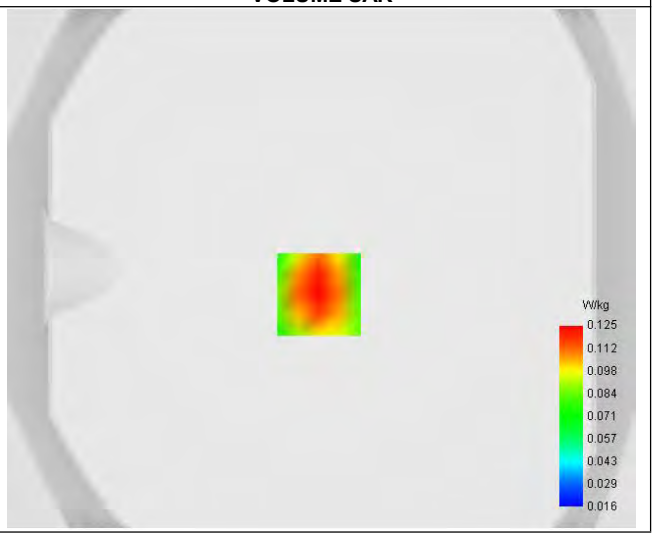
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 14
Channels	Middle (23330)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	788.590
Relative permitivity (real part)	41.482
Relative permitivity (imaginary part)	19.418
Conductivity (S/m)	0.846

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-10.00 ; SAR Peak: 0.19 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.078
SAR 1g (W/Kg)	0.120
Variation (%)	-3.440
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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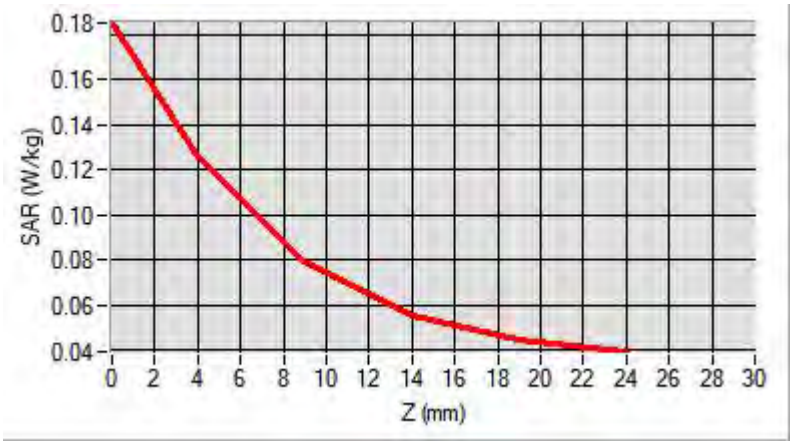
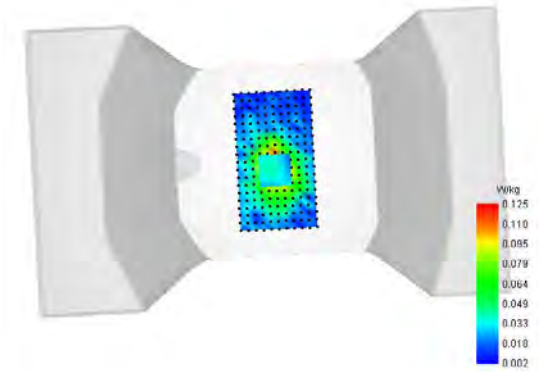
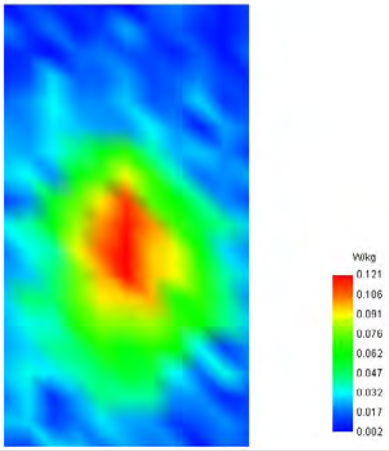
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.185	0.125	0.079	0.055	0.045



F. 3D Image

3D screen shot	Hot spot position
	

8-Body with bottom position in dist. 0mm on Channel 23790 in LTE band 17

SAR Measurement at LTE band 17 (Body, Validation Plane)

Date of measurement: 8/6/2023

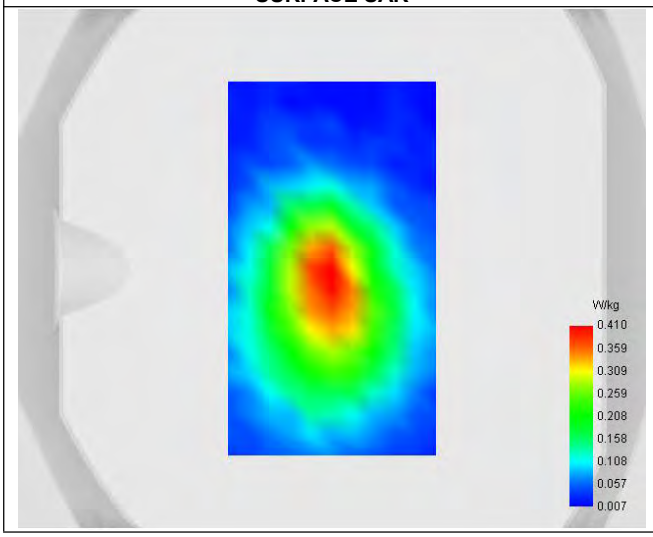
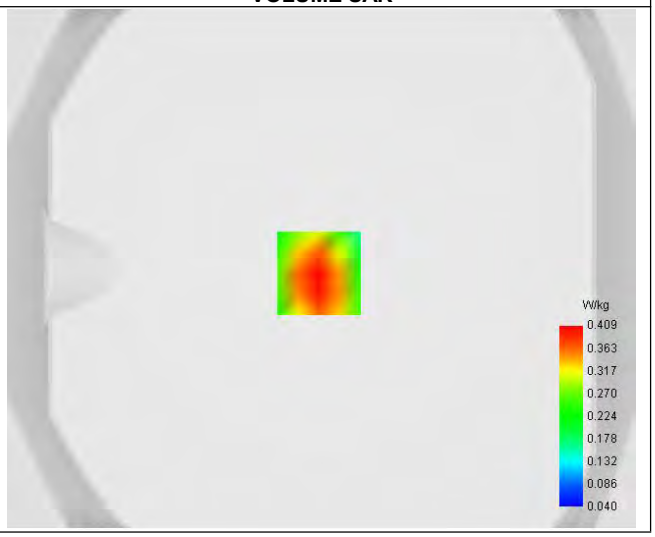
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 17
Channels	Middle (23790)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	714.410
Relative permitivity (real part)	41.597
Relative permitivity (imaginary part)	19.303
Conductivity (S/m)	0.808

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-2.00 ; SAR Peak: 0.61 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.245
SAR 1g (W/Kg)	0.398
Variation (%)	-3.210
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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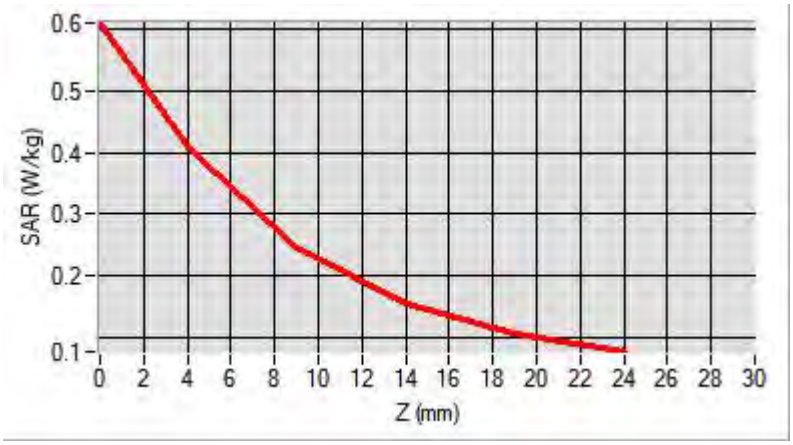
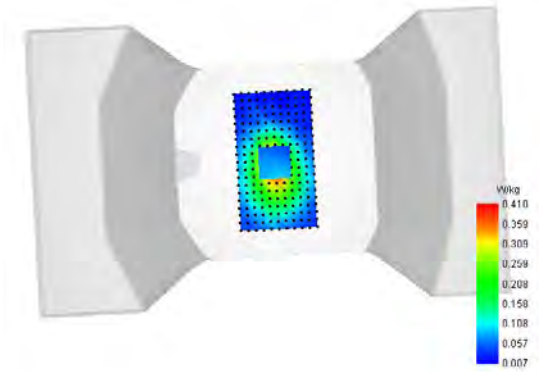
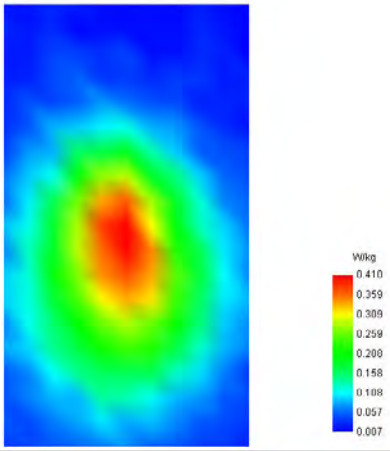
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.611	0.409	0.247	0.156	0.107



F. 3D Image

3D screen shot	Hot spot position
	

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9-Body with bottom position in dist. 0mm on Channel 26590 in LTE band 25

SAR Measurement at LTE band 25 (Body, Validation Plane)

Date of measurement: 9/6/2023

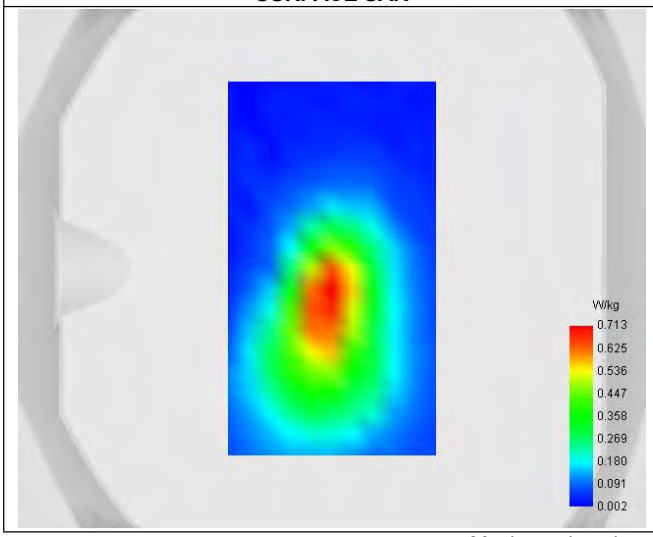
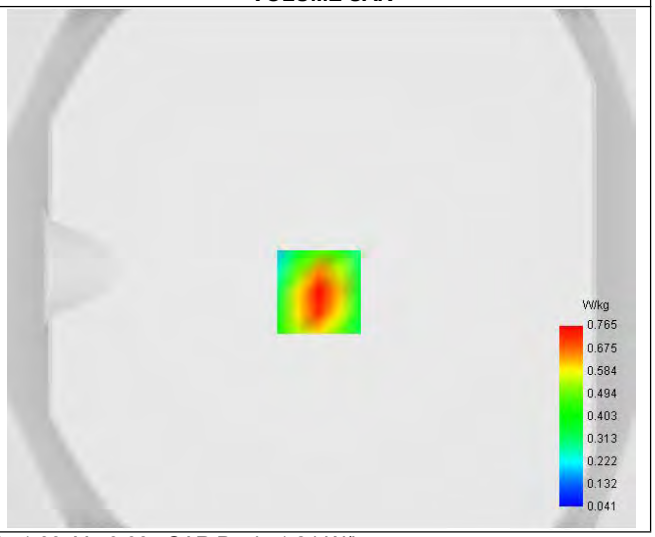
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 25
Channels	Higher (26590)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	50
RB size	1

B. Permitivity

Frequency (MHz)	1905.090
Relative permitivity (real part)	39.873
Relative permitivity (imaginary part)	13.387
Conductivity (S/m)	1.414

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-9.00 ; SAR Peak: 1.24 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.390
SAR 1g (W/Kg)	0.718
Variation (%)	1.320
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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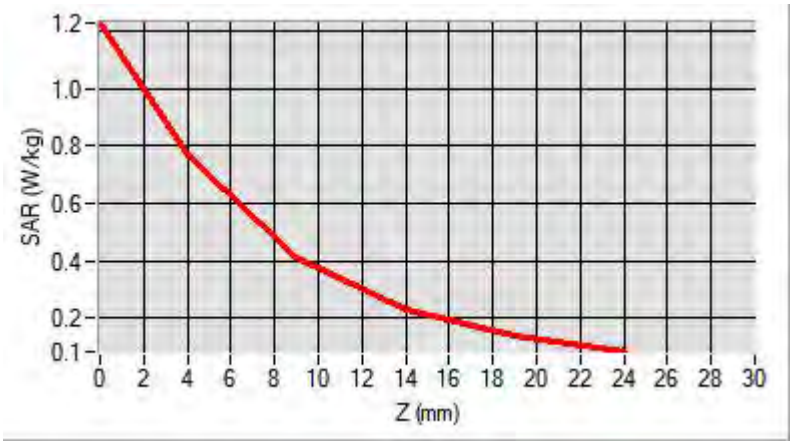
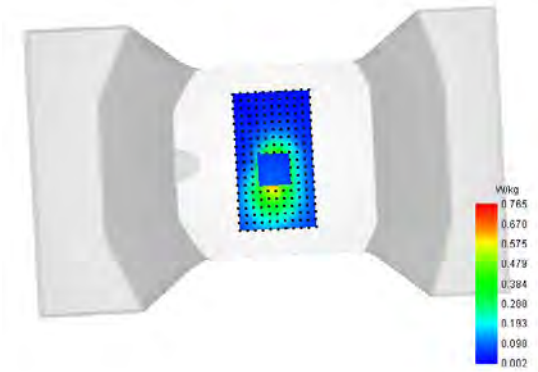
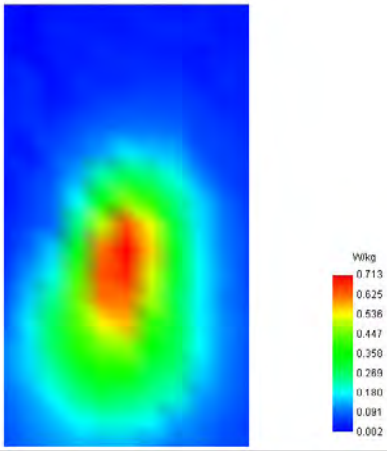
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.228	0.765	0.413	0.228	0.137



F. 3D Image

3D screen shot	Hot spot position
	

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10-Body with bottom position in dist. 0mm on Channel 26965 in LTE band 26

SAR Measurement at LTE band 26 (Body, Validation Plane)

Date of measurement: 8/6/2023

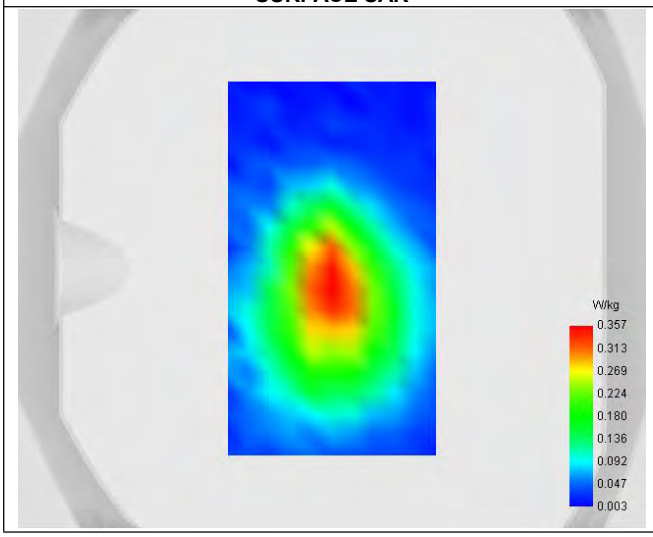
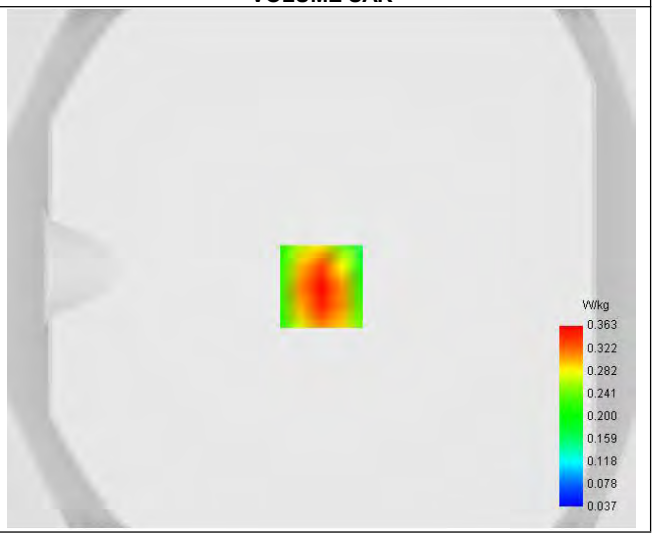
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 26
Channels	Higher (26965)
Signal	LTE FDD
Cell Bandwidth	15 Mhz
Modulation	SC-OFDM - QPSK
RB offset	74
RB size	1

B. Permitivity

Frequency (MHz)	848.160
Relative permitivity (real part)	41.390
Relative permitivity (imaginary part)	19.510
Conductivity (S/m)	0.877

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-7.00 ; SAR Peak: 0.56 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.216
SAR 1g (W/Kg)	0.346
Variation (%)	-1.640
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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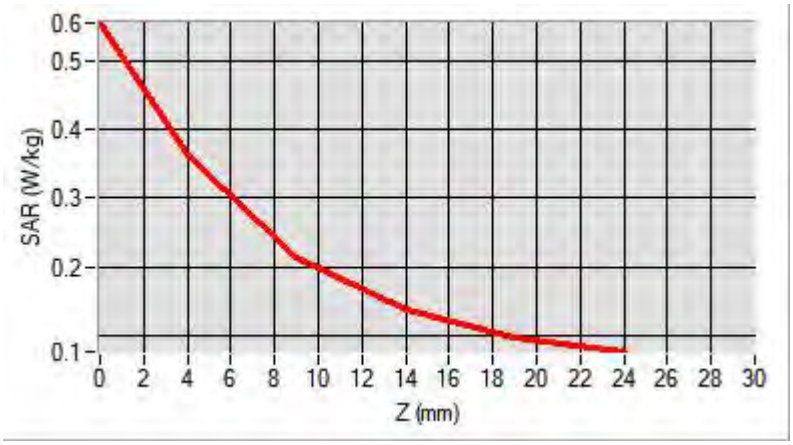
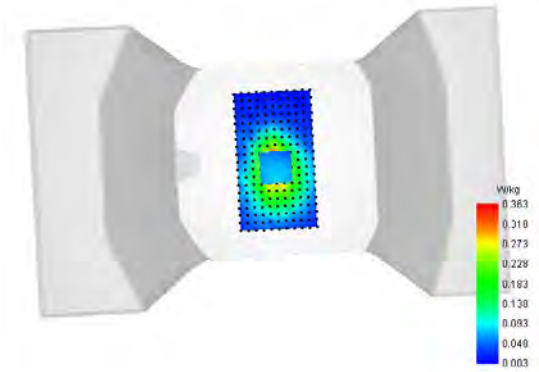
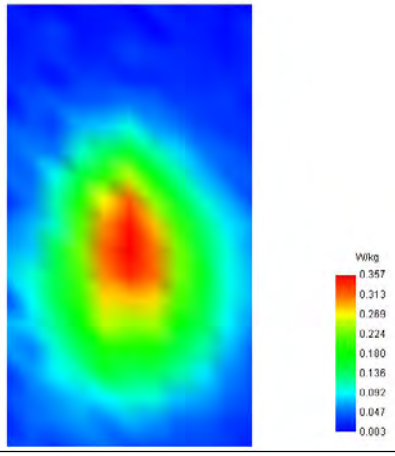
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.556	0.363	0.214	0.136	0.097



F. 3D Image

3D screen shot	Hot spot position
	

11-Body with bottom position in dist. 0mm on Channel 40620 in LTE band 41

SAR Measurement at LTE band 41 (Body, Validation Plane)

Date of measurement: 12/6/2023

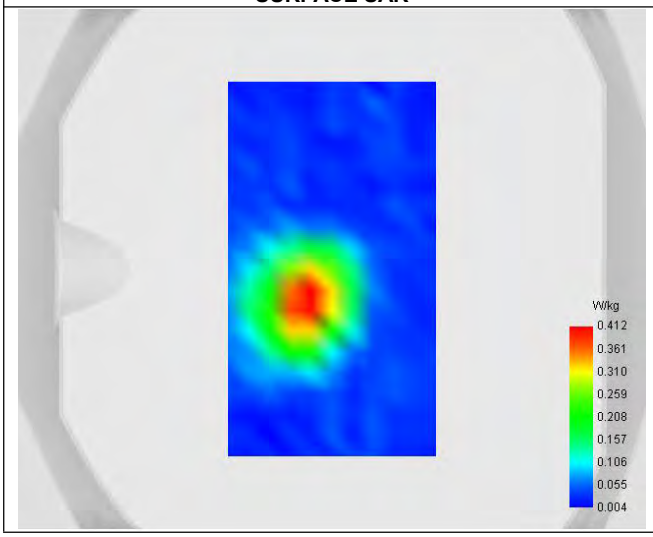
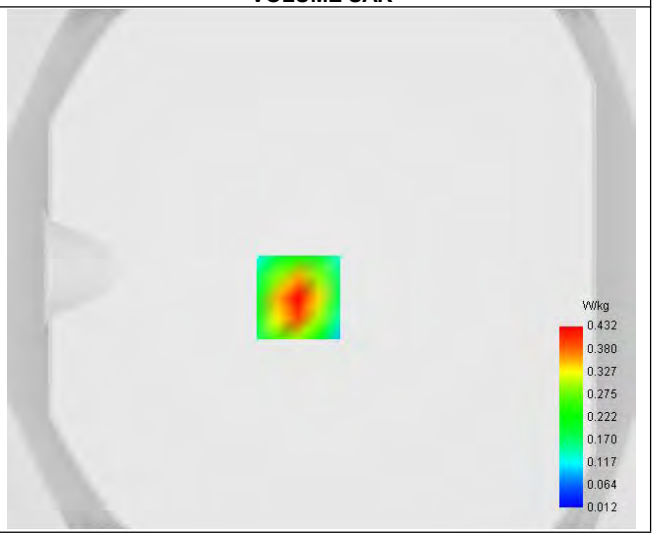
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 41
Channels	Middle (40620)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	50
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2593.090
Relative permitivity (real part)	38.889
Relative permitivity (imaginary part)	12.720
Conductivity (S/m)	1.963

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-9.00, Y=-11.00 ; SAR Peak: 0.72 W/kg

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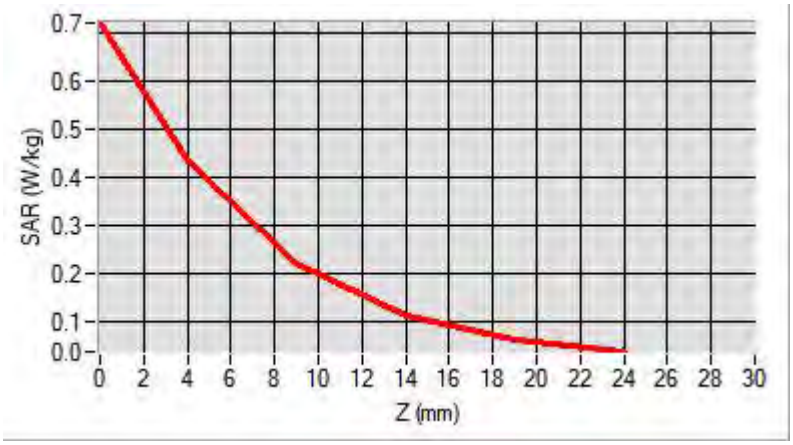
D. SAR 1g & 10g

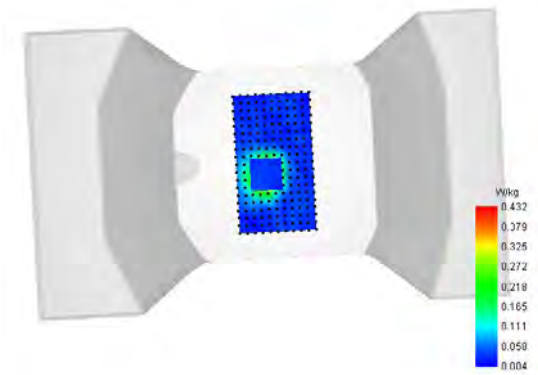
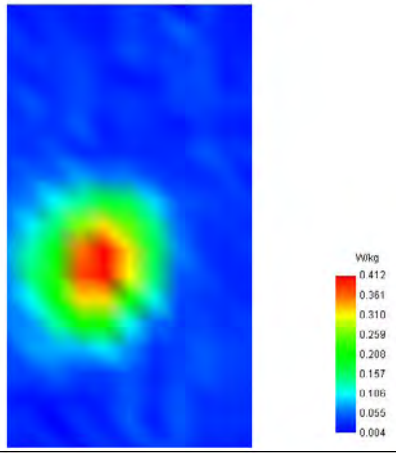
SAR 10g (W/Kg)	0.206
SAR 1g (W/Kg)	0.404
Variation (%)	0.680
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.721	0.432	0.220	0.113	0.064



F. 3D Image

3D screen shot	Hot spot position
	

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12-Body with bottom position in dist. 0mm on Channel 132072 in LTE band 66

SAR Measurement at LTE band 66 (Body, Validation Plane)

Date of measurement: 9/6/2023

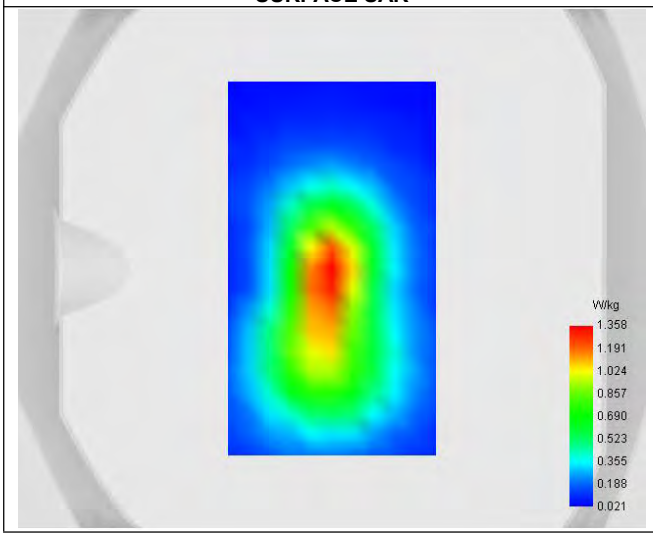
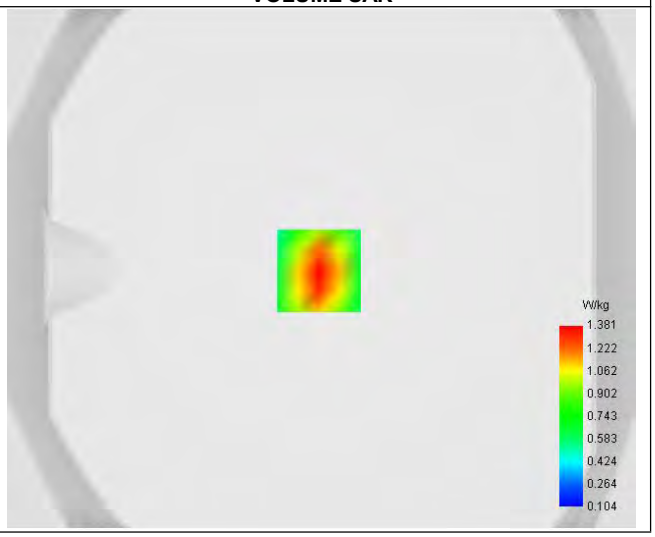
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 66
Channels	Lower (132072)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1728.910
Relative permitivity (real part)	40.021
Relative permitivity (imaginary part)	13.979
Conductivity (S/m)	1.333

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-1.00 ; SAR Peak: 2.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.706
SAR 1g (W/Kg)	1.188
Variation (%)	0.200
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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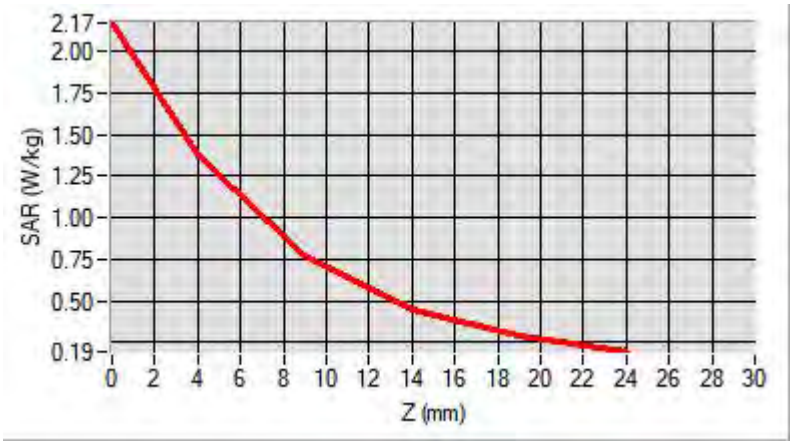
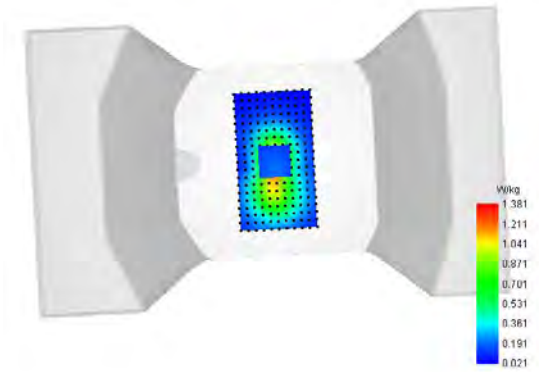
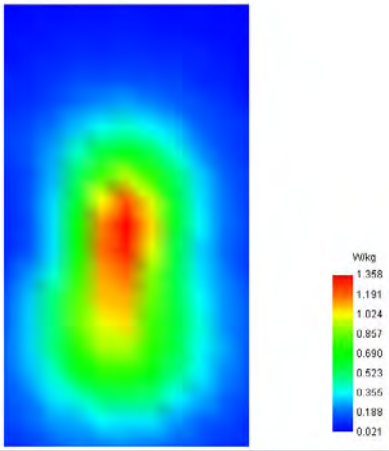
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	2.173	1.381	0.774	0.450	0.289



F. 3D Image

3D screen shot	Hot spot position
	

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13-Body with bottom position in dist. 0mm on Channel 133222 in LTE band 71

SAR Measurement at LTE band 71 (Body, Validation Plane)

Date of measurement: 8/6/2023

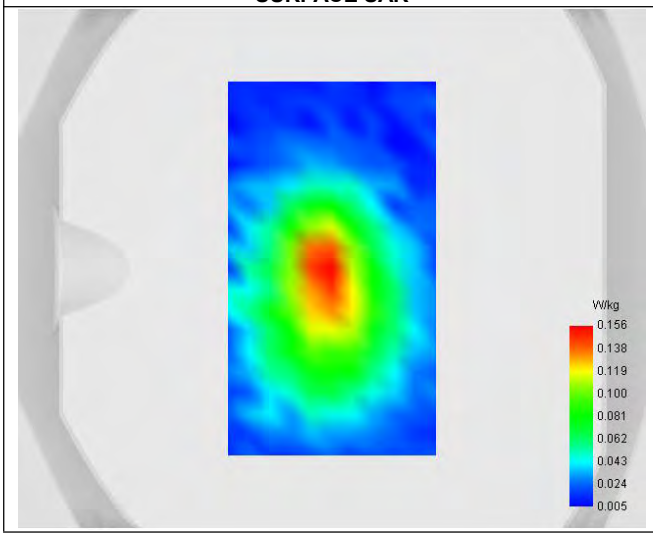
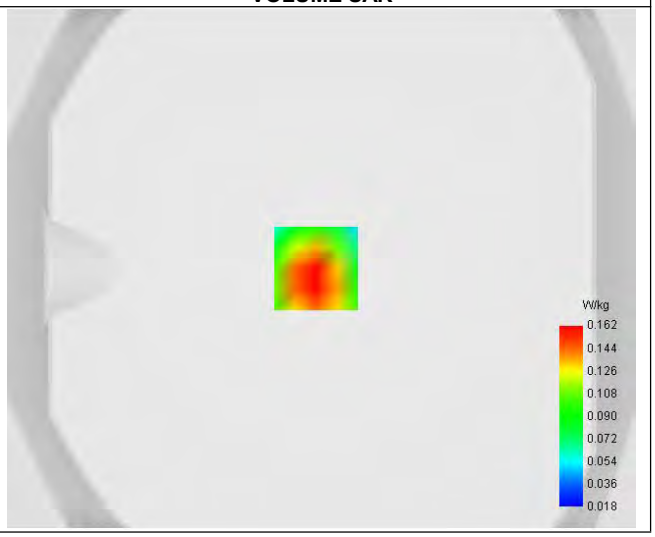
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 71
Channels	Lower (133222)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	50
RB size	1

B. Permitivity

Frequency (MHz)	673.090
Relative permitivity (real part)	41.662
Relative permitivity (imaginary part)	19.238
Conductivity (S/m)	0.786

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-2.00, Y=0.00 ; SAR Peak: 0.28 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.092
SAR 1g (W/Kg)	0.163
Variation (%)	-2.160
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

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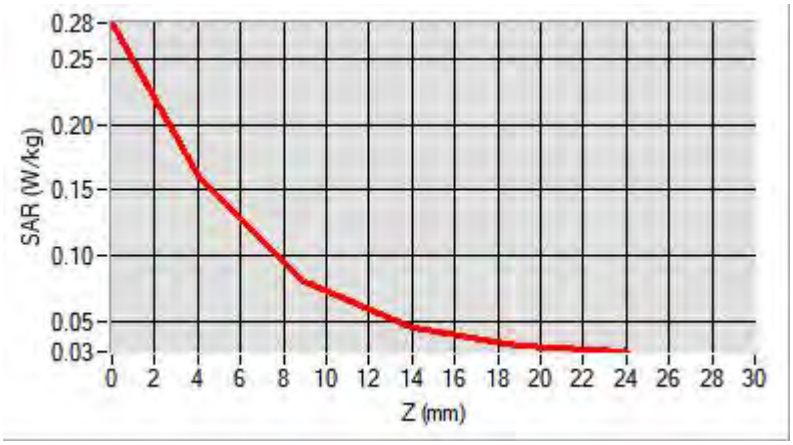
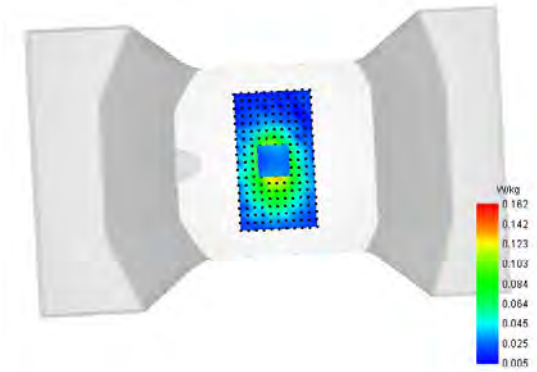
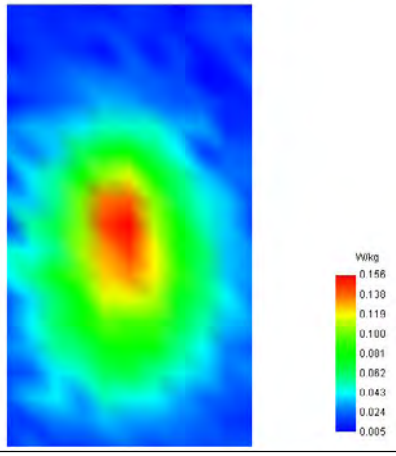
E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.278	0.162	0.081	0.045	0.031



F. 3D Image

3D screen shot	Hot spot position
	

14-Body with front position in dist. 0mm on Channel 11 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Body, Validation Plane)

Date of measurement: 12/6/2023

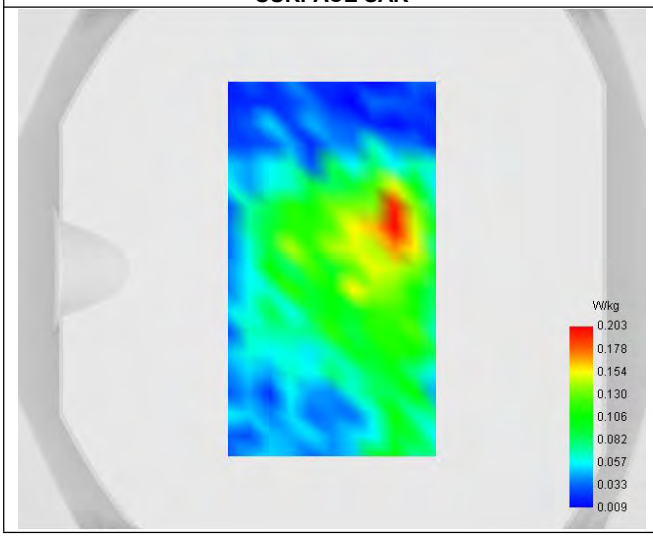
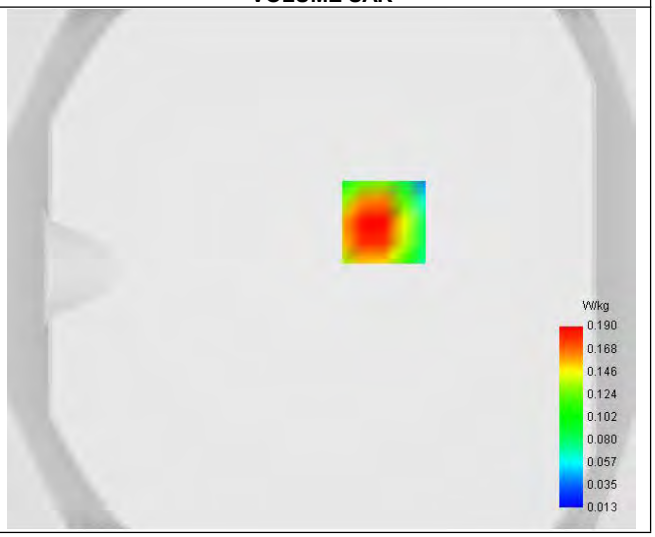
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11b ISM
Channels	Higher (11)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2462.000
Relative permitivity (real part)	39.064
Relative permitivity (imaginary part)	13.288
Conductivity (S/m)	1.823

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=24.00, Y=18.00 ; SAR Peak: 0.32 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.110
SAR 1g (W/Kg)	0.189
Variation (%)	1.700
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.310	0.190	0.102	0.058	0.038

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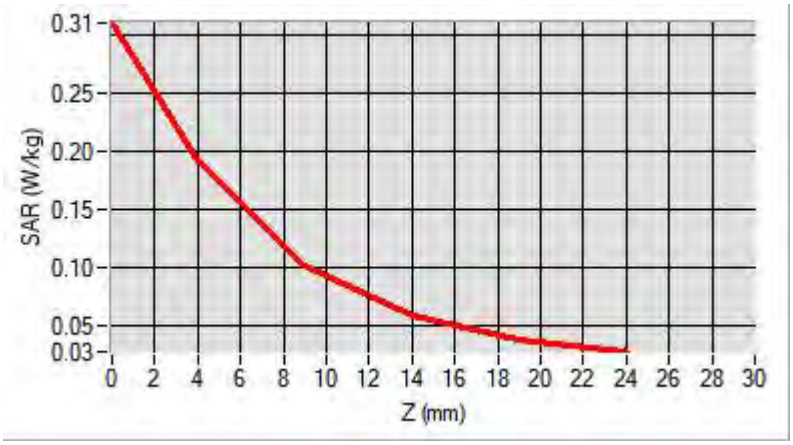
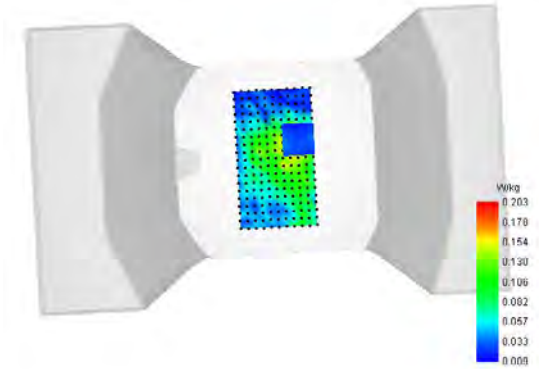
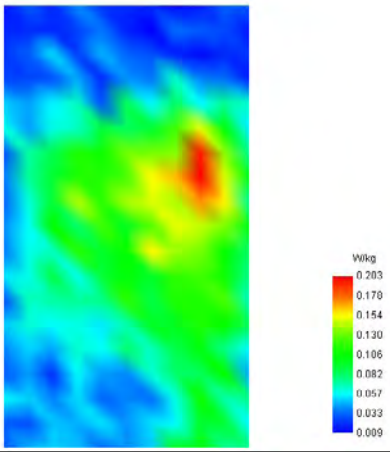


F. 3D Image

3D screen shot	Hot spot position
	

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15-Body with front position in dist. 0mm on Channel 38 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Body, Validation Plane)

Date of measurement: 12/6/2023

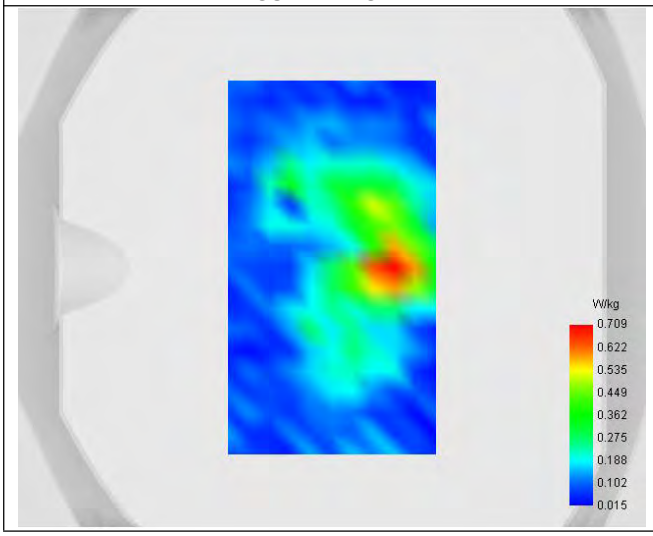
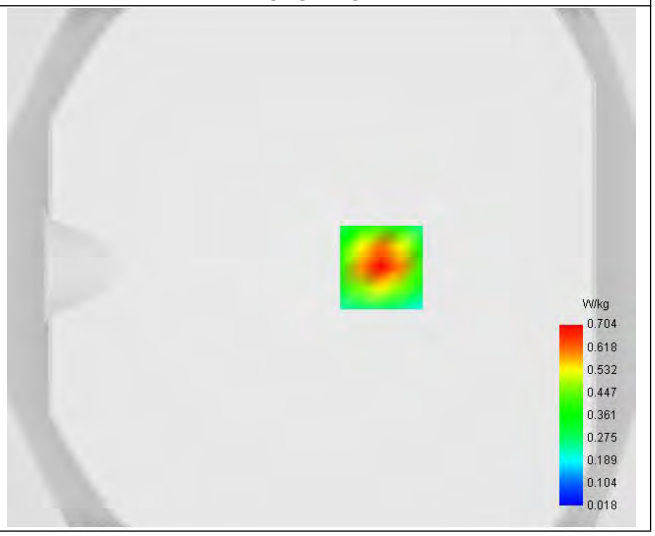
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11n U-NII
Channels	Lower (38)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5190.000
Relative permitivity (real part)	35.890
Relative permitivity (imaginary part)	16.240
Conductivity (S/m)	4.690

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=23.00, Y=0.00 ; SAR Peak: 1.04 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.216
SAR 1g (W/Kg)	0.461
Variation (%)	-2.240
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	7.00	12.00	17.00
SAR (W/Kg)	1.012	0.704	0.257	0.090	0.040

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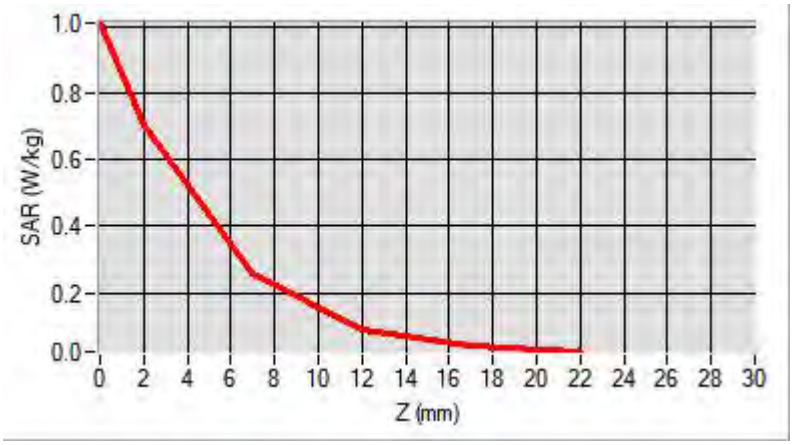
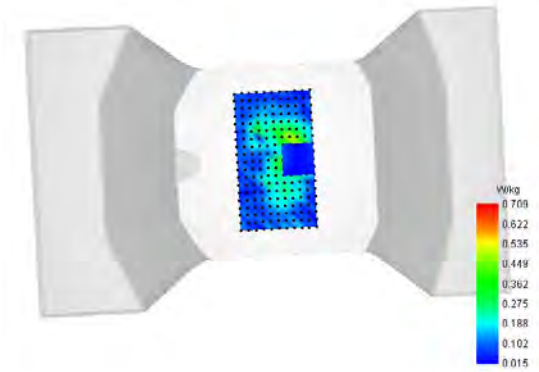
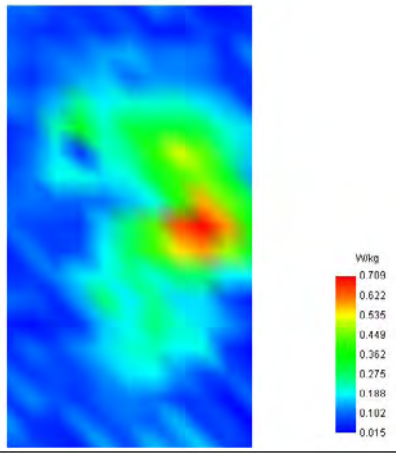


F. 3D Image

3D screen shot	Hot spot position
	

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16-Body with front position in dist. 0mm on Channel 54 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Body, Validation Plane)

Date of measurement: 12/6/2023

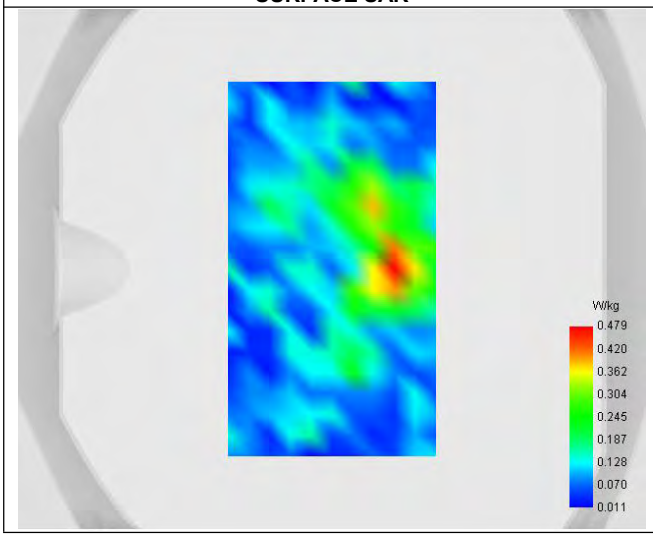
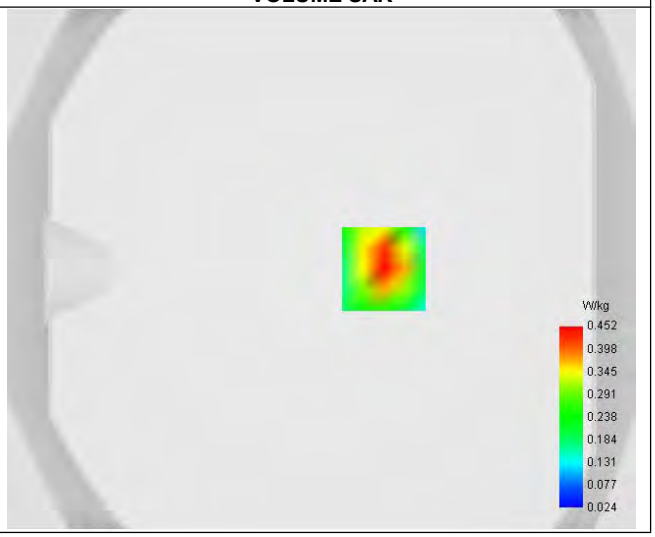
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11n U-NII
Channels	Lower (54)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5270.000
Relative permitivity (real part)	35.810
Relative permitivity (imaginary part)	16.320
Conductivity (S/m)	4.770

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=24.00, Y=0.00 ; SAR Peak: 0.70 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.141
SAR 1g (W/Kg)	0.289
Variation (%)	1.680
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	7.00	12.00	17.00
SAR (W/Kg)	0.679	0.452	0.145	0.051	0.034

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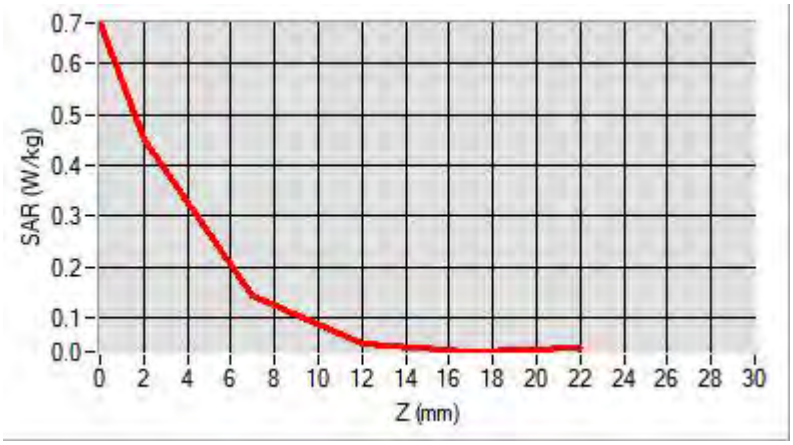
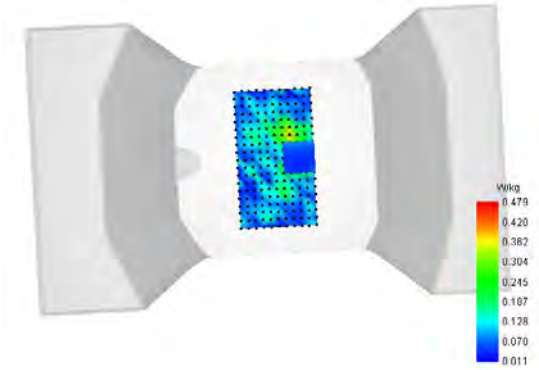
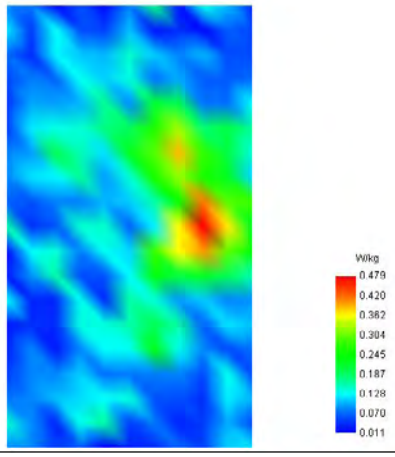


F. 3D Image

3D screen shot	Hot spot position
	

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17-Body with front position in dist. 0mm on Channel 102 in IEEE 802.11ac U-NII

SAR Measurement at IEEE 802.11ac U-NII (Body, Validation Plane)

Date of measurement: 12/6/2023

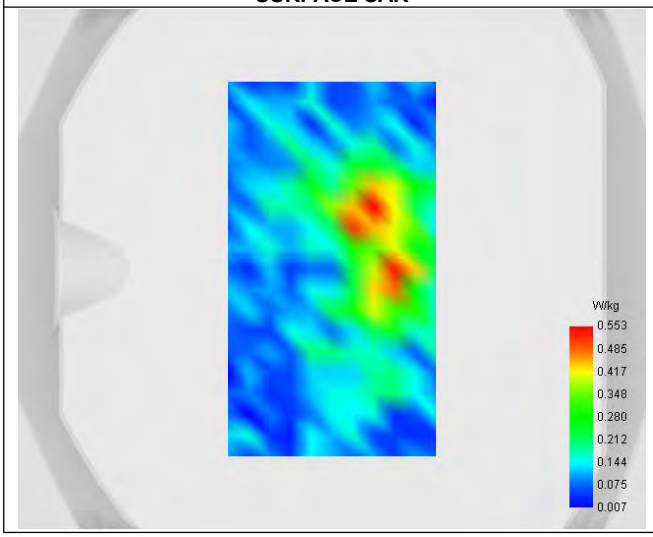
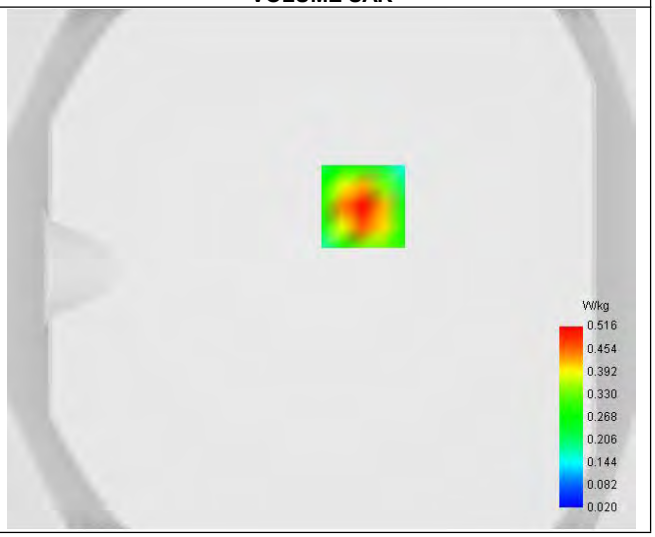
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.18
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11ac U-NII
Channels	Middle (102)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5510.000
Relative permitivity (real part)	35.515
Relative permitivity (imaginary part)	16.485
Conductivity (S/m)	5.016

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=16.00, Y=24.00 ; SAR Peak: 0.84 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.158
SAR 1g (W/Kg)	0.330
Variation (%)	-0.350
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	7.00	12.00	17.00
SAR (W/Kg)	0.818	0.516	0.134	0.036	0.027

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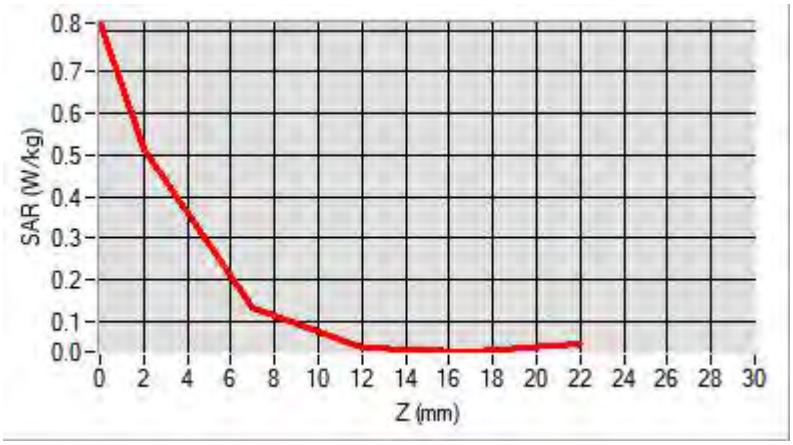
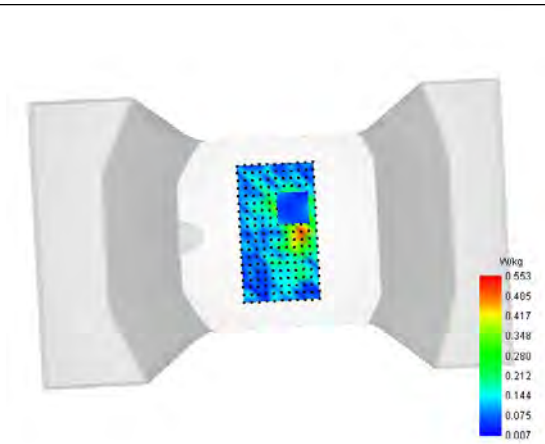
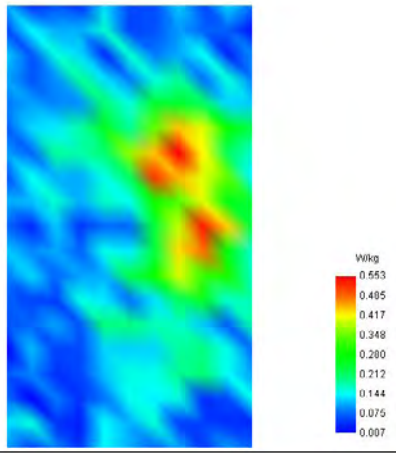


F. 3D Image

3D screen shot	Hot spot position
	

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18-Body with front position in dist. 0mm on Channel 159 in IEEE 802.11ac U-NII

SAR Measurement at IEEE 802.11ac U-NII (Body, Validation Plane)

Date of measurement: 12/6/2023

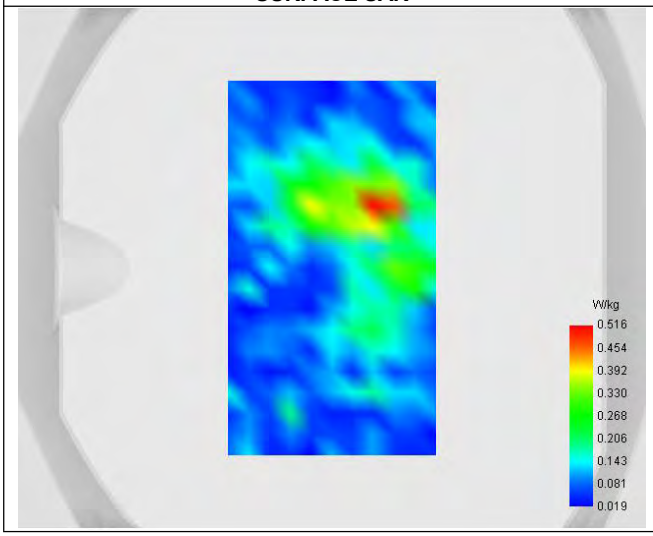
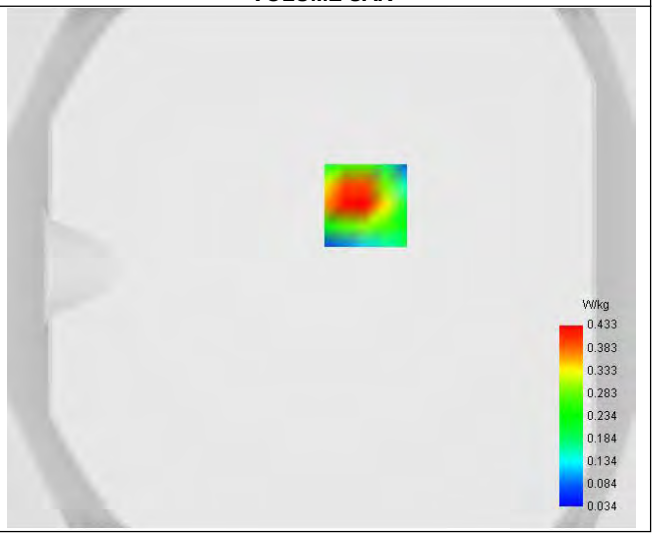
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	surf_sam_plan.txt
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11ac U-NII
Channels	Higher (159)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5795.000
Relative permitivity (real part)	35.185
Relative permitivity (imaginary part)	16.615
Conductivity (S/m)	5.305

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=17.00, Y=24.00 ; SAR Peak: 0.68 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.152
SAR 1g (W/Kg)	0.297
Variation (%)	-1.000
Horizontal validation criteria: minimum distance (mm)	0.000000
Vertical validation criteria: SAR ratio M2/M1 (%)	0.000000

E. Z Axis Scan

Z (mm)	0.00	2.00	7.00	12.00	17.00
SAR (W/Kg)	0.631	0.433	0.156	0.063	0.044

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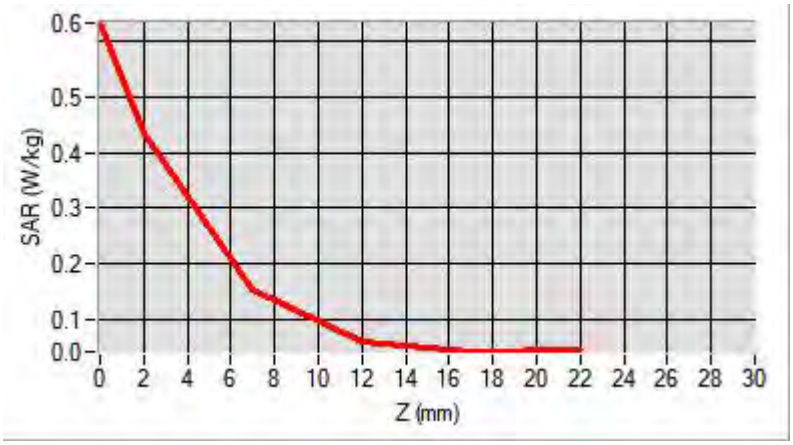
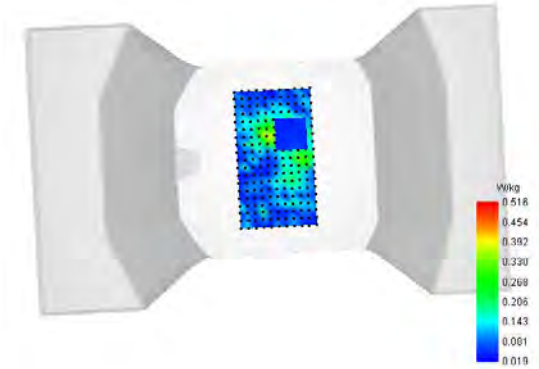
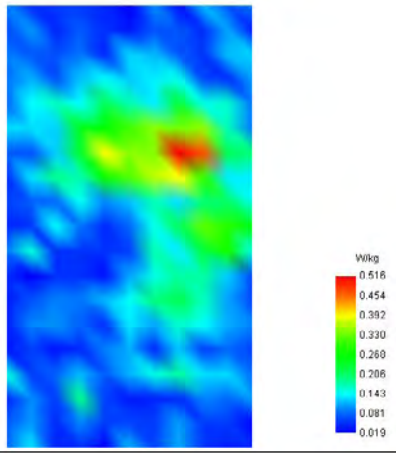


F. 3D Image

3D screen shot	Hot spot position
	

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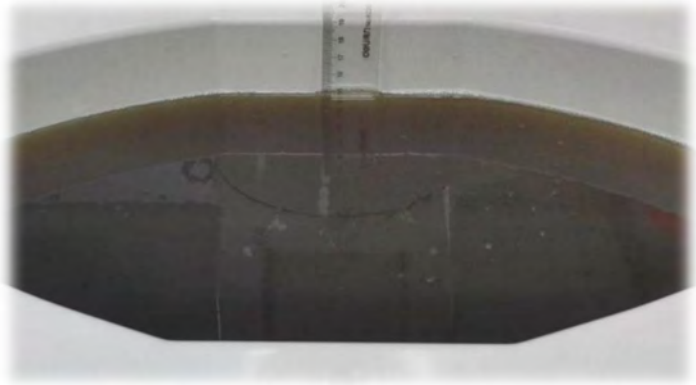
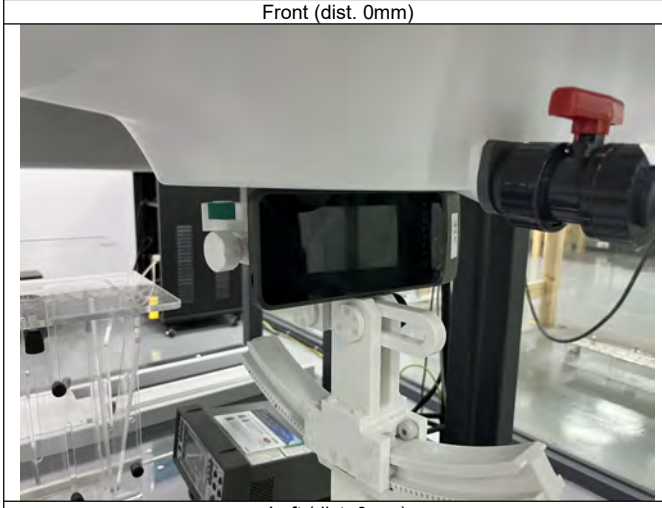
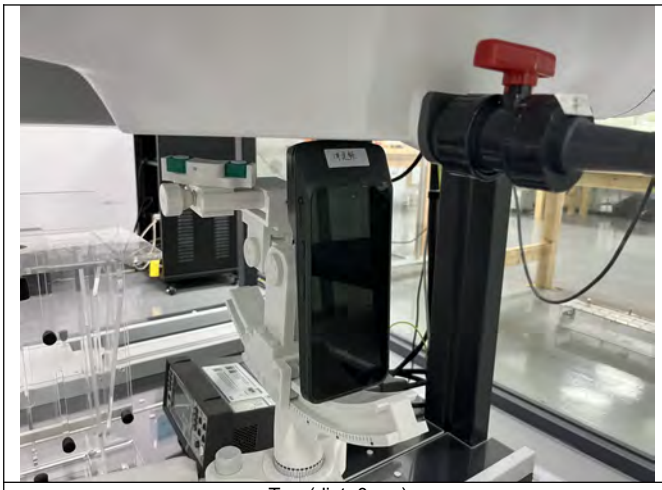
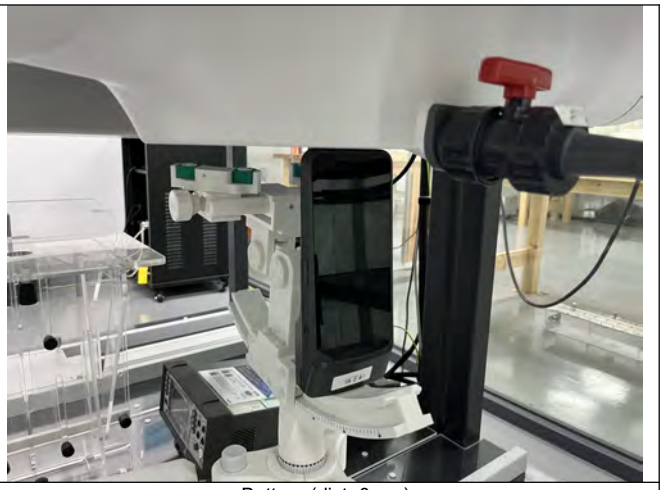
ANNEX D SAR Test Setup Photos

Reference Photo: simulation liquid depth 15cm


Reference Photos	
	
Front (dist. 0mm)	Back (dist. 0mm)
	
Left (dist. 0mm)	Right (dist. 0mm)

	
Top (dist. 0mm)	Bottom (dist. 0mm)

ANNEX E EUT External and Internal Photos

Please refer to RF Report.

ANNEX F Calibration Information

Please refer to the document “Calibration.pdf”.

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--END OF REPORT--